

Design guide for low-noise transistors in WLAN front ends

RF bipolar transistors

About this document

Scope and purpose

This application note provides application circuit design examples of Infineon's low-noise silicon germanium: carbon (SiGe:C) transistors for wireless local area network (WLAN) low noise amplifiers (LNAs) and a medium-power transistor for WLAN power amplifier. In this document, the transistor-based LNA and power amplifier (PA) schematics, printed circuit board (PCB) layouts and measurement results are shown. This document is relevant to the following low-noise transistors and medium-power transistor:

- [BFP740](#) Low-noise transistor for 2.4 GHz WLAN
- [BFP740ESD](#) Low-noise transistor for 2.4 GHz WLAN
- [BFP740F](#) Low-noise transistor for 2.4 GHz WLAN
- [BFP740FESD](#) Low-noise transistor for 2.4 GHz WLAN
- [BFP760](#) Low-noise transistor for 2.4 GHz WLAN
- [BFP842ESD](#) Low-noise transistor for 2.4 GHz WLAN
- [BGB707L7ESD](#) Low-noise transistor for 2.4 GHz WLAN
- [BFP840ESD](#) Low-noise transistor for 5 to 6 GHz WLAN
- [BFP840FESD](#) Low-noise transistor for 5 to 6 GHz WLAN
- [BFR840L3RHESD](#) Low-noise transistor for 2.4 GHz and 5 to 6 GHz WLAN
- [BFQ790](#) High-linearity medium-power transistor.

Intended audience

This document is intended for engineers who need to design LNAs and PAs for WLAN applications.

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1 Introduction

1.1 WLAN radio front ends

The WLAN function is one of the most important connectivity functions between WLAN access points and smartphones, tablets, and laptops. WLAN standards according to IEEE 802.11b/g/n at 2.4 GHz have been widely implemented over the years. Due to the overcrowded WLAN at 2.4 GHz, the applications in the 5 to 6 GHz band according to IEEE 802.11a/ac/n are becoming popular for fast data throughput. Today, wireless high-quality multimedia data transmission requires even higher data throughput. Hence, the next generation standard 802.11ax will increase the data rate to 9.6 Gbps through the high-order modulation scheme (1024QAM) and 8×8 multi-user multiple-input and multiple-output (MU-MIMO).

Key performance metrics for WLAN application are the speed of data transfer and coverage, which are greatly influenced by transmitted power, receiver sensitivity, noise, and interference. High data throughput related to the high-order modulation scheme asks for better received signal quality, while the necessary solution of WLAN router for MU-MIMO with multiple antennas will introduce trace loss in the signal path to transceiver IC, resulting in a deteriorated signal quality. A radio front end including filter, switch, LNA and PA close to the antenna is a popular method to improve the signal quality.

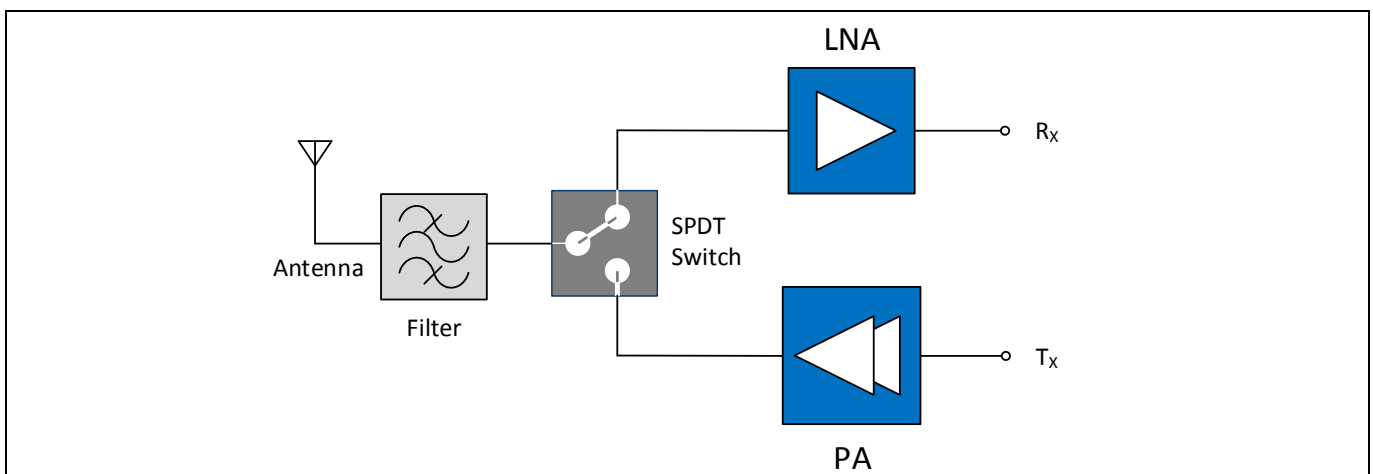


Figure 1 Block diagram example of a WLAN radio front end

1.2 Infineon RF transistor family

Infineon Technologies provides high-performance radio frequency (RF) transistors targeting WLAN LNA applications. Infineon's reliable high-volume RF transistors offer exceptionally low noise figure (NF), high gain and high linearity at low power consumption levels for RF applications. The sixth-, seventh-generation, and the latest high-performance eighth-generation transistors are based on robust ultra low-noise SiGe:C technologies. Their optimized inner transistor cell structure leads to best-in-class power gain and NF at high frequencies, including 2.4 GHz and 5 to 6 GHz WLAN bands. The transistors maximize the design flexibility for customer requirements.

In addition to low-noise transistors, Infineon offers [BFQ790](#), a high-linearity medium-power transistor. Its output power level reaches 27 dBm (0.5 W), which is adequate for 2.4 GHz indoor WLAN signal power amplification. The device is housed in the halogen-free industry-standard SOT89 package. The high thermal conductivity of the silicon substrate and the low thermal resistance of the package add up to a thermal resistance of only 35 K/W, which leads to moderate junction temperatures even at high dissipated power values.

2 2.4 GHz band WLAN LNA application circuits

2.1 2.4 GHz band WLAN LNAs with SOT343 packaged low-noise transistors

2.1.1 Performance overview

The following table shows the performance of the 2.4 GHz band WLAN LNAs with SOT343 packaged low-noise transistors.

Table 1 Summary of measurement results for the 2.4 GHz band WLAN LNAs with SOT343 packaged transistors

| Parameter | Symbol | Value | | | | Unit | Notes |
|------------------------------------|-------------|------------------------|------------------------|---------------------------|---------------------------|------|--|
| | | BFP760 | BFP740 | BFP740ESD | BFP842ESD | | |
| Device | | BFP760 | BFP740 | BFP740ESD | BFP842ESD | | |
| Bias voltage | V_{CC} | 3.0 | 3.0 | 3.0 | 3.0 | V | |
| Bias current | I_{CC} | 16.6 | 13.5 | 13.5 | 8.6 | mA | |
| Frequency | f | 2.45 | 2.45 | 2.45 | 2.45 | GHz | |
| Gain | G | 16.0 | 18.9 | 18.8 | 18.5 | dB | |
| NF | NF | 0.82 | 0.81 | 0.76 | 0.76 | dB | PCB and SMA loss subtracted: 0.1 dB |
| Input return loss | RL_{in} | 10.8 | 10.1 | 10.6 | 14.3 | dB | |
| Output return loss | RL_{out} | 12.7 | 11.5 | 12.3 | 16.3 | dB | |
| Reverse isolation | ISO_{rev} | 24.0 | 25.2 | 25.7 | 23.2 | dB | |
| Output 1 dB compression point | OP_{1dB} | 6.6 | 5.2 | 5.0 | 8.9 | dBm | |
| Output third-order intercept point | OIP_3 | 17.5 | 12.6 | 12.9 | 22.3 | dBm | Input power: -25 dBm per tone Tone 1: 2450 MHz Tone 2: 2451 MHz |
| Stability | K | >1 | >1 | >1 | >1 | | Measured from 15 MHz to 13 GHz |

2.1.2 Schematic

The following figure shows the schematic of the 2.4 GHz band WLAN LNAs with SOT343 packaged transistors. Emitter degeneration provides negative feedback to achieve the transistor impedance matching and low-noise matching at the same time (see Figure 3 and Figure 4). In the LNA circuit, resistors R1 and R2 stand for transistor voltage and current bias, meanwhile, they form a negative DC feedback mechanism to stabilize the transistor bias points in various conditions. Capacitors C2 and C3 serve as the RF bypass. Transistor input matching is achieved by the inductors L1, L3, and the capacitor C1. The output matching network is formed by C4, C5, L2, L4, R3 and R4. Resistors R3 and R4 also have the function of improving circuit stability.

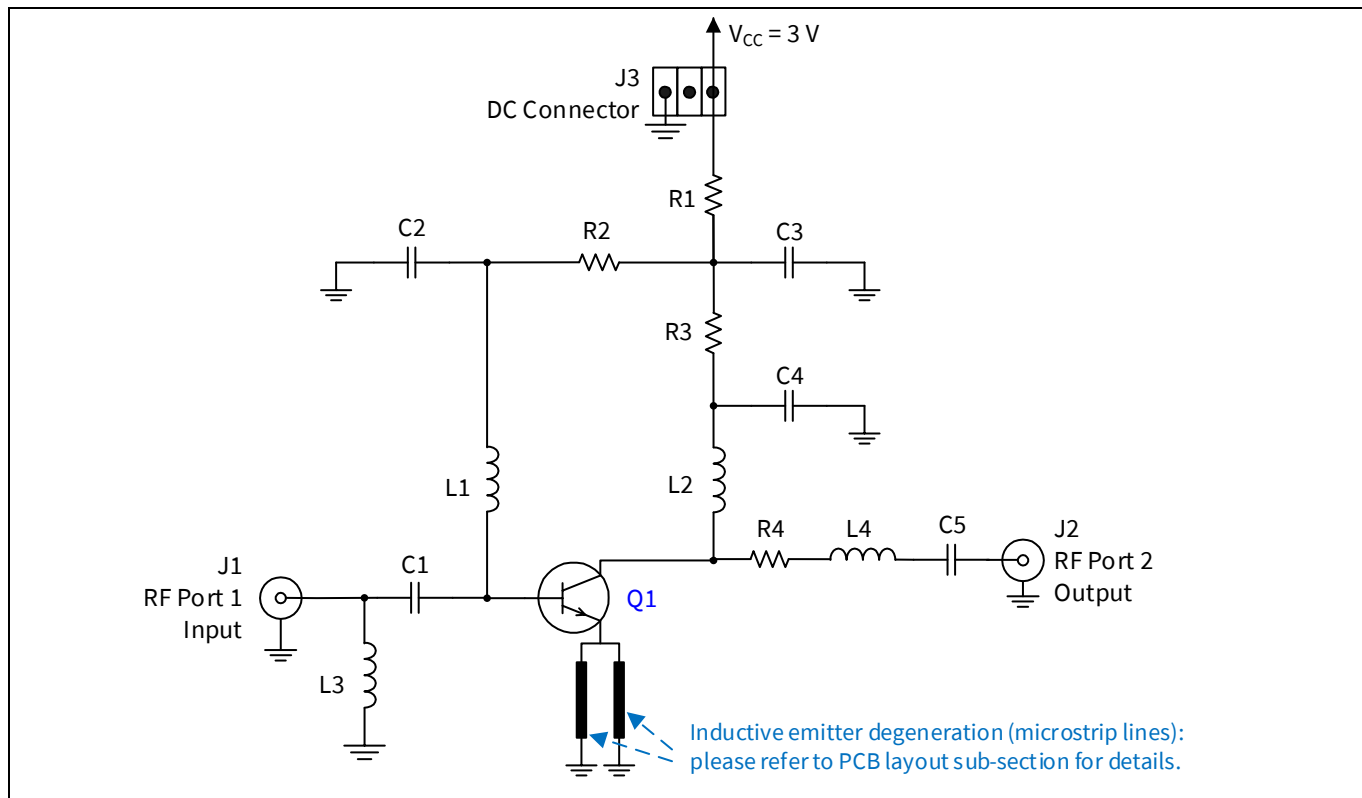


Figure 2 Schematic of the 2.4 GHz band WLAN LNAs with SOT343 packaged transistors

2.1.3 Bill of materials (BOM)

Table 2 BOM of the 2.4 GHz band WLAN LNAs with SOT343 packaged transistors

| Symbol | Value | | | | Unit | Size | Manufacturer | Notes |
|--------|------------------------|------------------------|---------------------------|---------------------------|------------|------|--------------|--|
| Q1 | BFP760 | BFP740 | BFP740ESD | BFP842ESD | - | - | Infineon | SiGe: C low-noise transistor |
| C1 | 1.8 | 8.2 | 8.2 | 10 | pF | 0402 | Various | Input matching and DC blocking |
| C2 | 39 | 39 | 39 | 10 | pF | 0402 | Various | RF decoupling |
| C3 | n.c. | 39 | 39 | 330 | pF | 0402 | Various | RF decoupling |
| C4 | n.c. | n.c. | n.c. | 6.8 | pF | 0402 | Various | Output matching and stability improvement |
| C5 | 1.8 | 22 | 22 | 1.5 | pF | 0402 | Various | Output matching and DC blocking |
| R1 | 30 | 120 | 120 | 33 | Ω | 0402 | Various | DC biasing |
| R2 | 33 | 22 | 22 | 39 | k Ω | 0402 | Various | DC biasing |
| R3 | 82 | 24 | 24 | 22 | Ω | 0402 | Various | Low-frequency stability improvement |
| R4 | 2.2 | n.c. | n.c. | n.c. | Ω | 0402 | Various | Output matching and high-frequency stability improvement |

| | | | | | | | | |
|----|------|------|------|------|----|------|------------|------------------------------|
| L1 | n.c. | 2.2 | 2.2 | 3.3 | nH | 0402 | Murata LQG | RF choke and input matching |
| L2 | n.c. | 2.2 | 2.2 | 1.8 | nH | 0402 | Murata LQG | RF choke and output matching |
| L3 | 2 | n.c. | n.c. | n.c. | nH | 0402 | Murata LQG | Input matching |
| L4 | 2.2 | n.c. | n.c. | n.c. | nH | 0402 | Murata LQG | Output matching |

Note: 1) Not connected (n.c.).

2.1.4 Evaluation boards and PCB layout information

The evaluation boards for the 2.4 GHz band WLAN LNAs with SOT343 packaged transistors:

- PCB material: FR4
- PCB marking:
 - [BFP740](#) M130125
 - [BFP740ESD](#) M130125
 - [BFP760](#) M130125
 - [BFP842ESD](#) M130225

The photo of the evaluation boards for the 2.4 GHz band WLAN LNAs with SOT343 packaged transistors and the detailed description of the PCB stack are shown in the following figures.

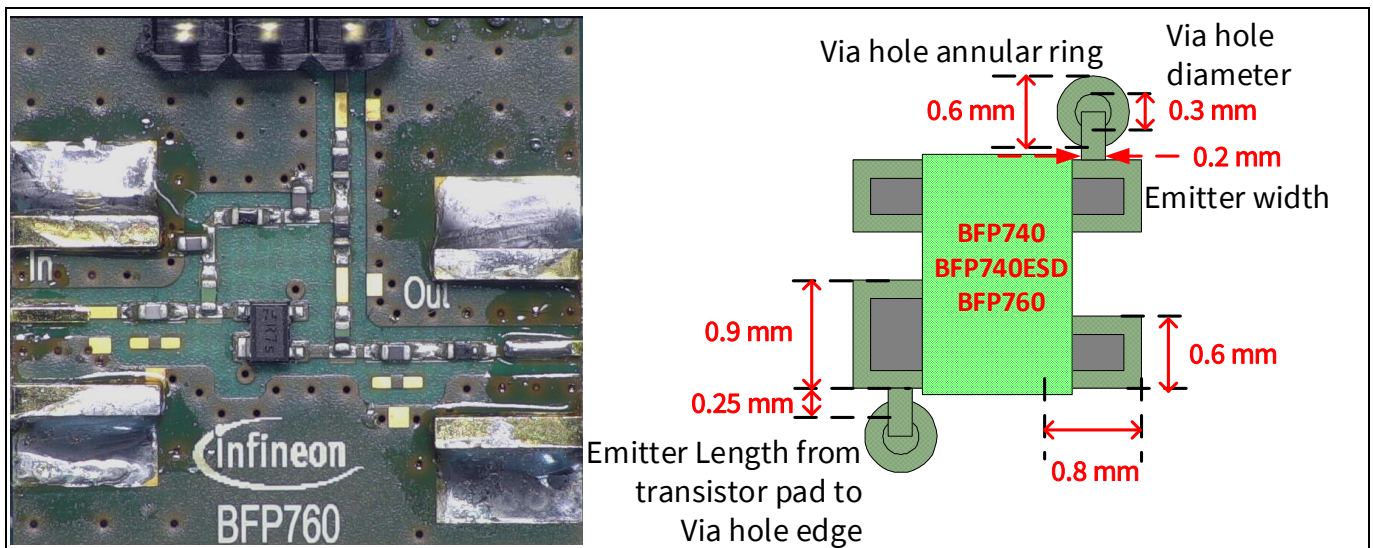


Figure 3 Photo of the evaluation board with PCB marking M130125 (left) and emitter degeneration details (right)

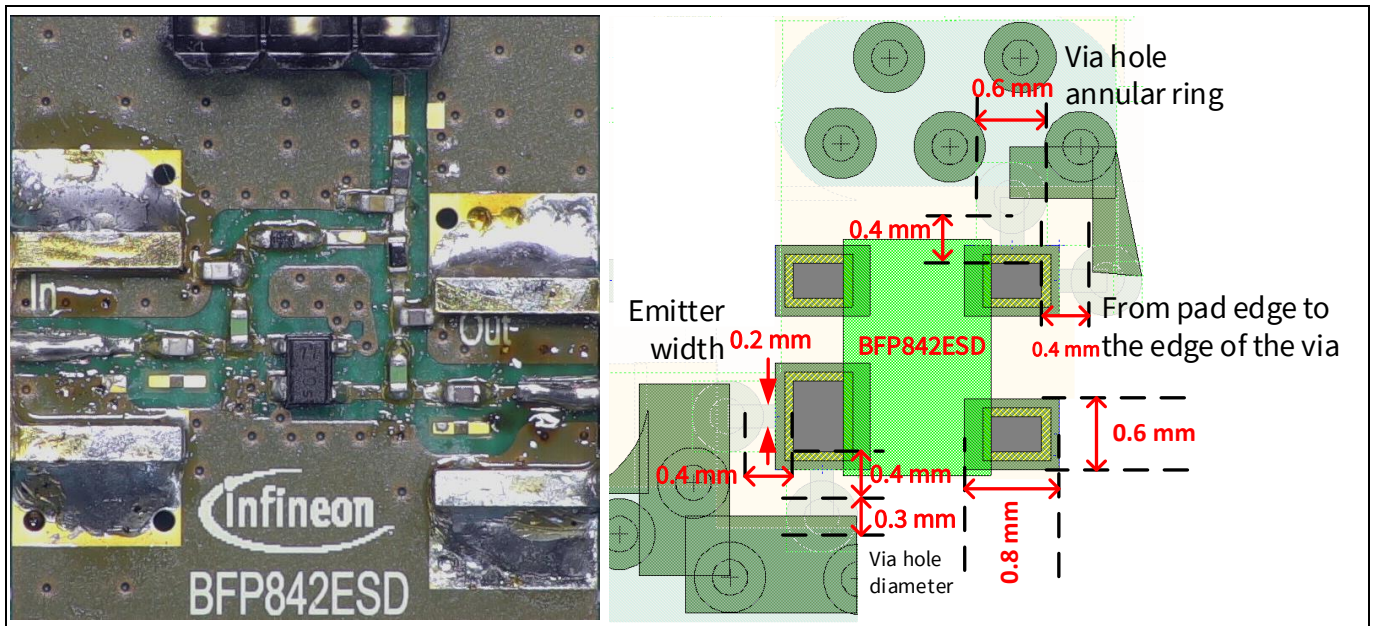


Figure 4 Photo of the evaluation board with PCB marking M130225 (left) and emitter degeneration details (right)

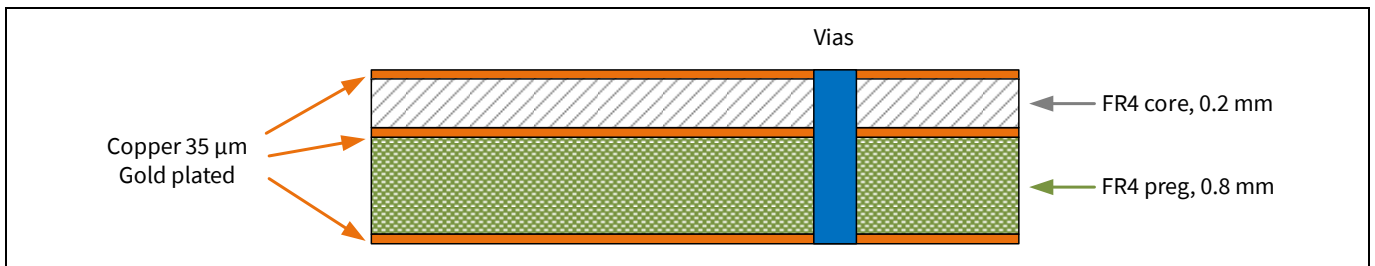


Figure 5 PCB stack information for the evaluation boards with PCB marking M130125 and M130225

2.1.5 Measurement results of 2.4 GHz band WLAN LNAs with SOT343 packaged low-noise transistors

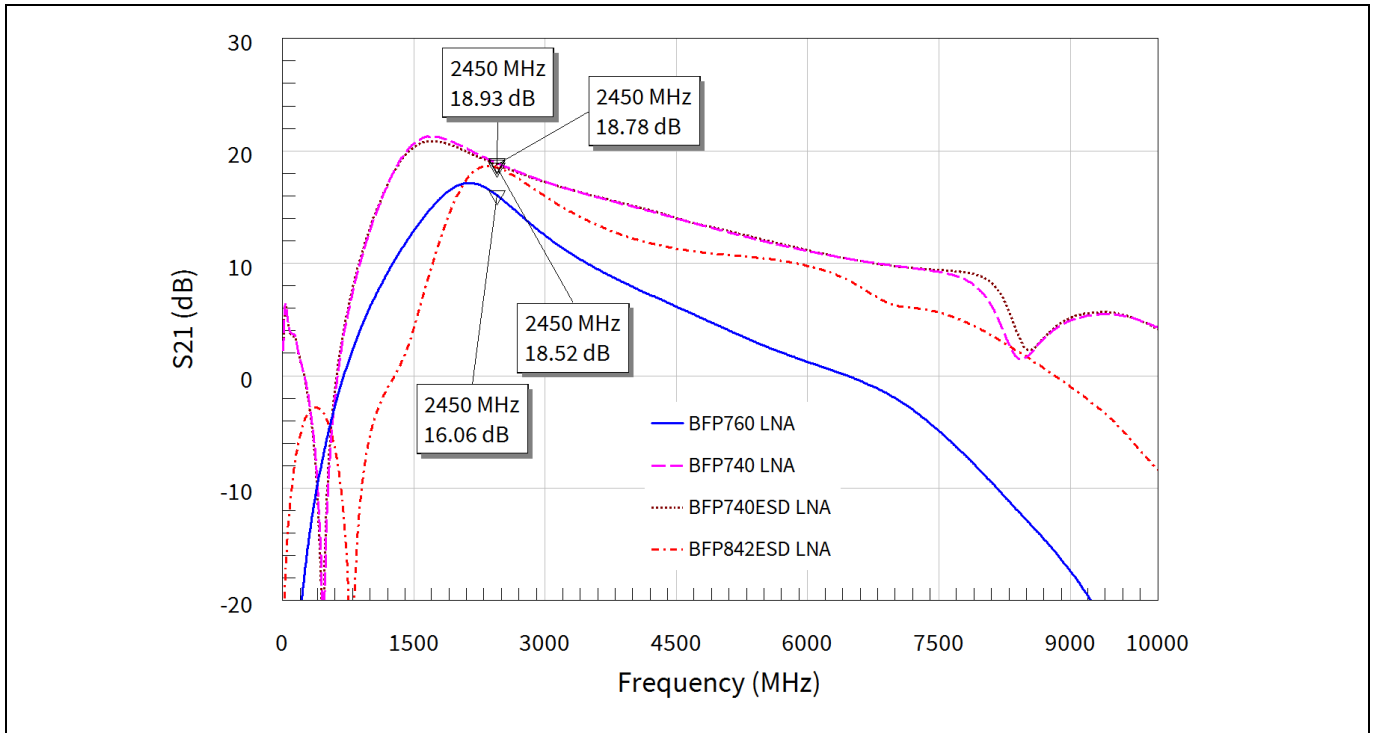


Figure 6 Small signal gain of the 2.4 GHz band WLAN LNAs with SOT343 packaged transistors

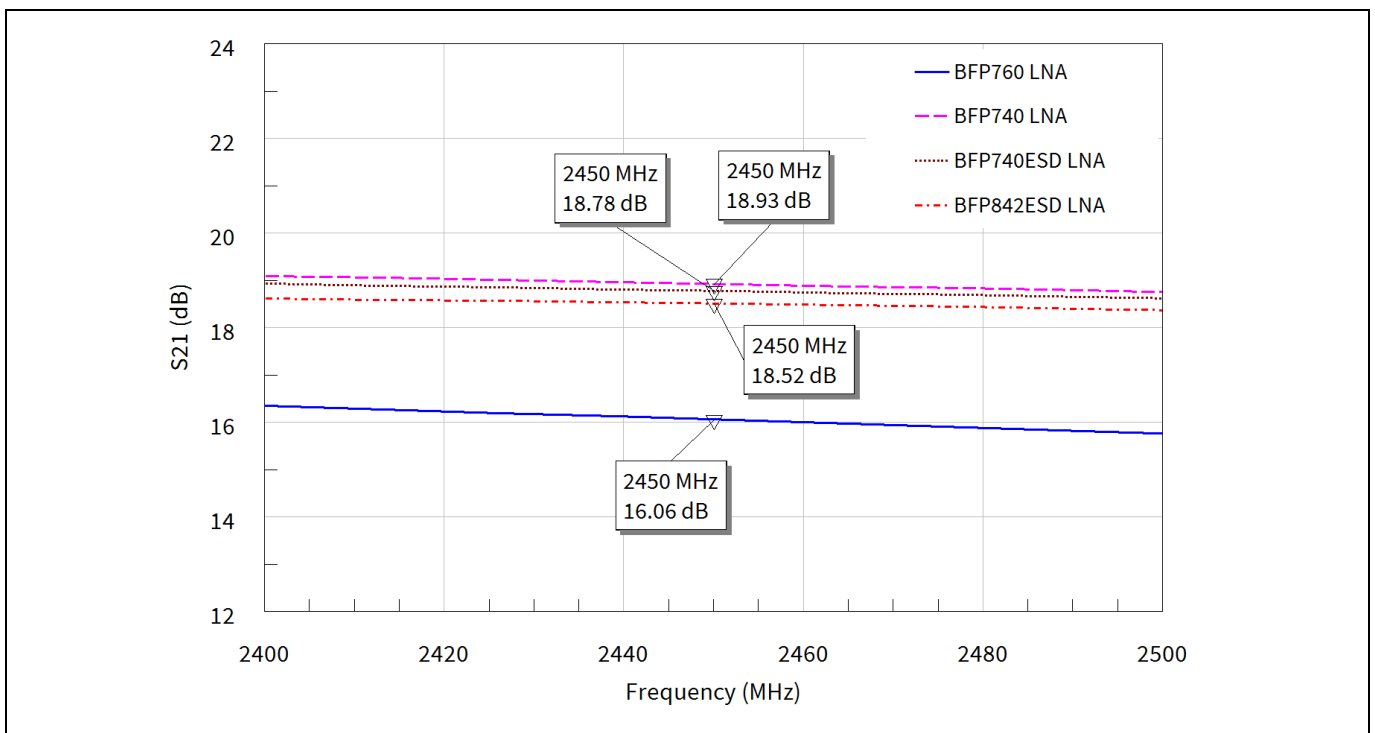


Figure 7 Small signal gain of the 2.4 GHz band WLAN LNAs with SOT343 packaged transistors (detail view)

Note: The graphs are generated with the AWR electronic design automation (EDA) software Microwave Office®.

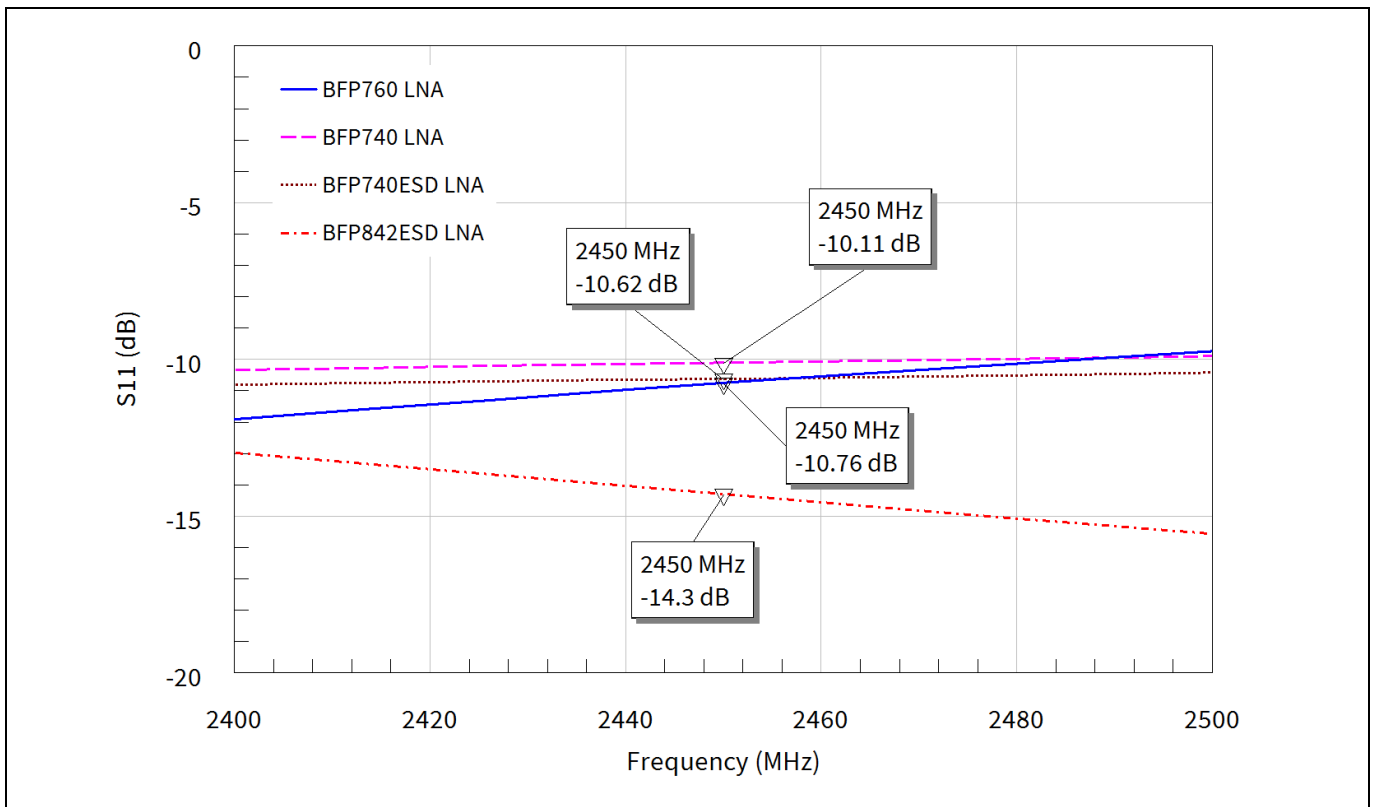


Figure 8 Input return loss measurement of the 2.4 GHz band WLAN LNAs with SOT343 packaged transistors

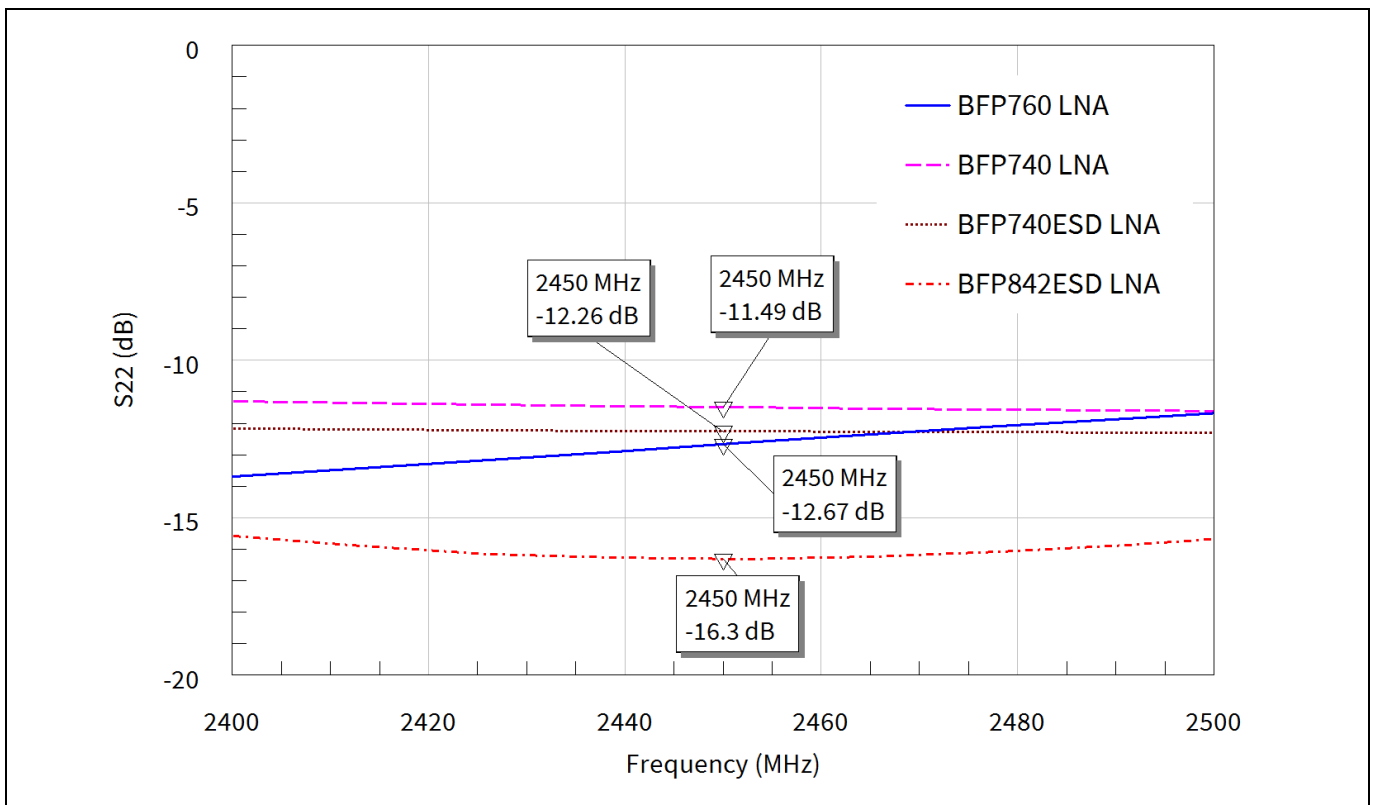


Figure 9 Output return loss measurement of the 2.4 GHz band WLAN LNAs with SOT343 packaged transistors

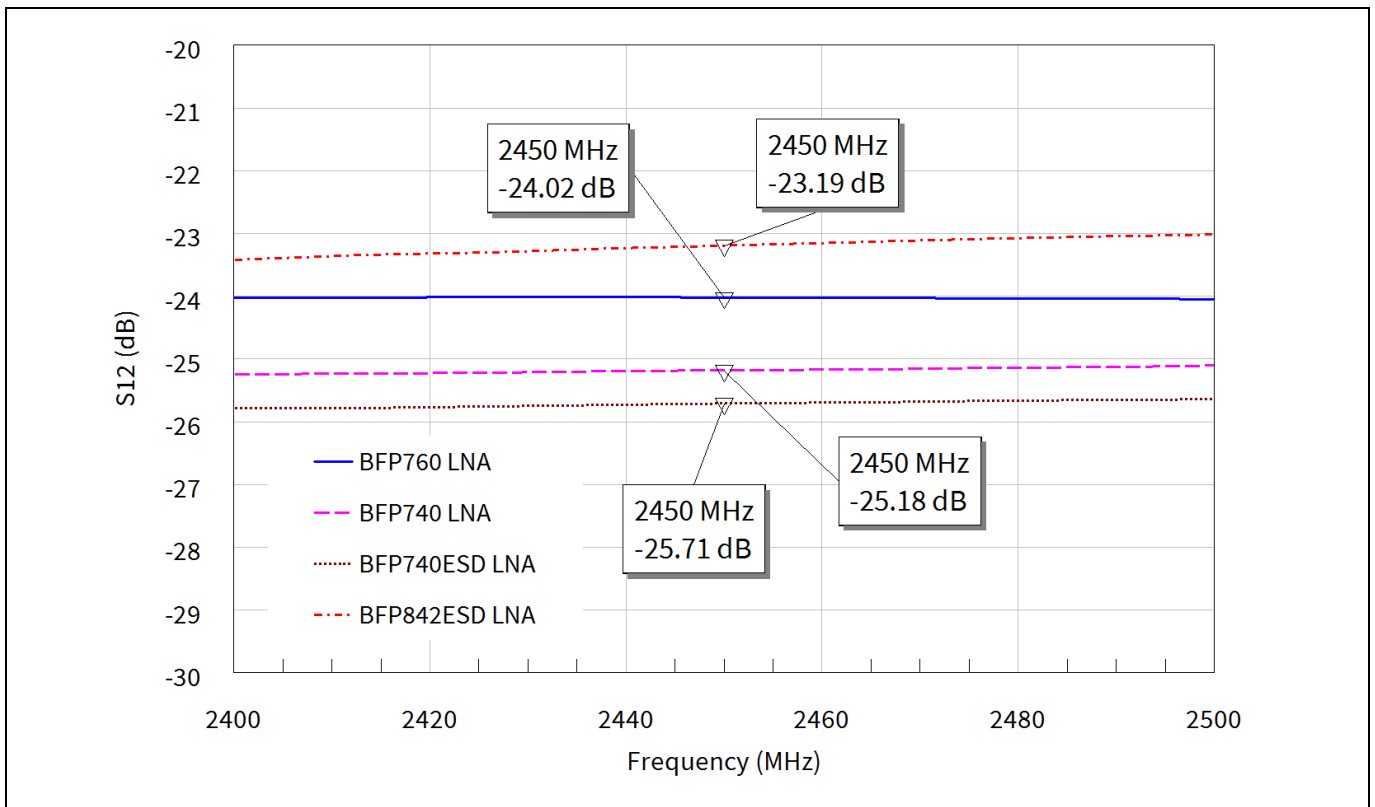


Figure 10 Reverse isolation measurement of the 2.4 GHz band WLAN LNAs with SOT343 packaged transistors

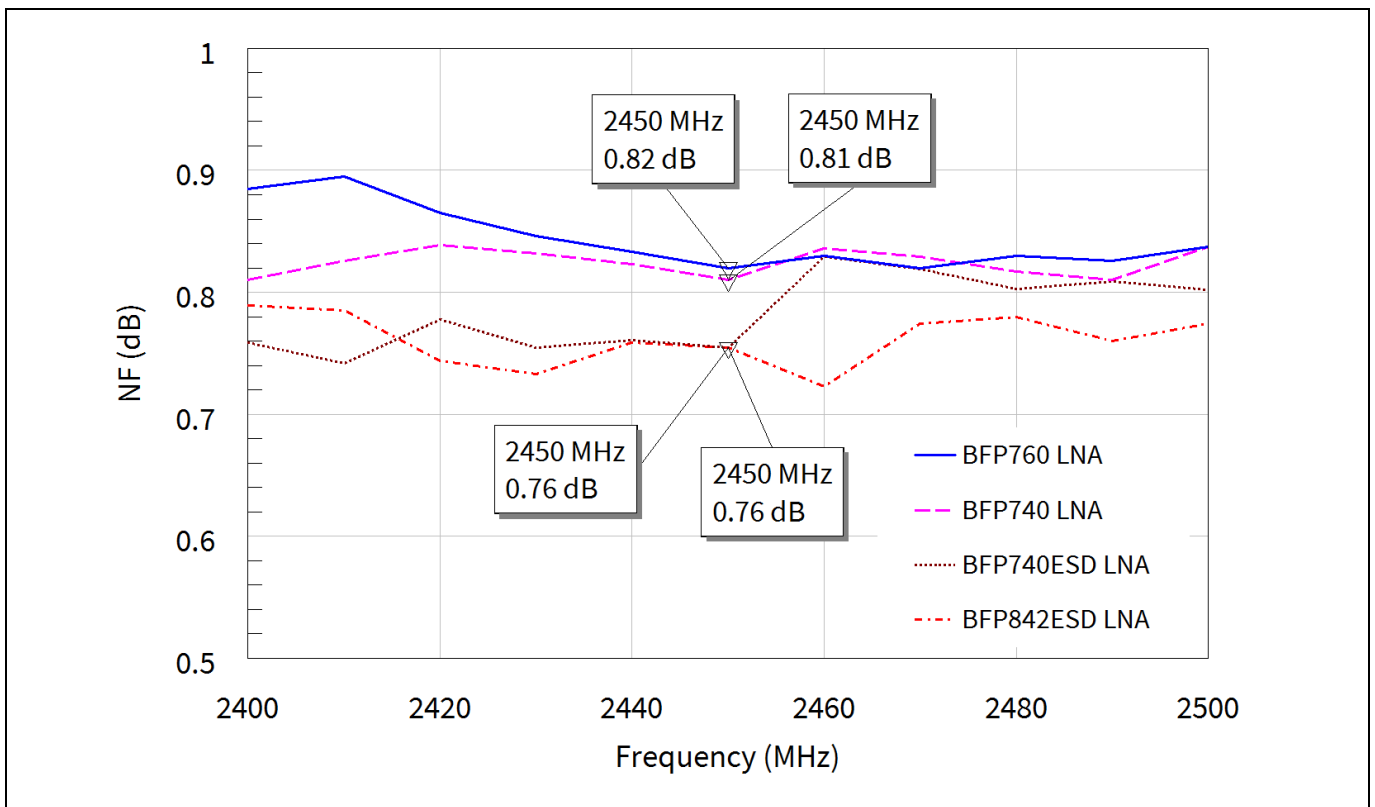


Figure 11 NF measurement of the 2.4 GHz band WLAN LNAs with SOT343 packaged transistors

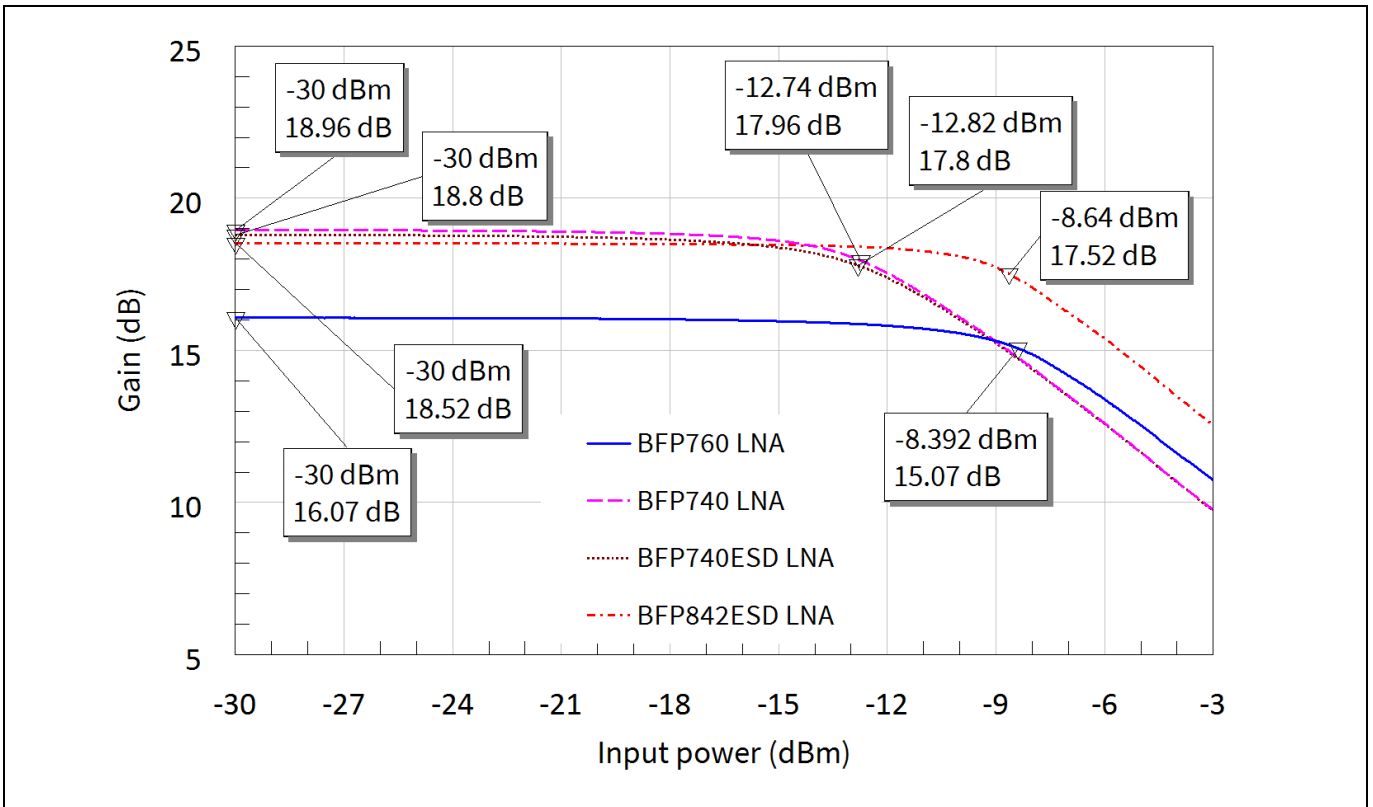


Figure 12 Input 1 dB compression point measurement of the 2.4 GHz band WLAN LNAs with SOT343 packaged transistors

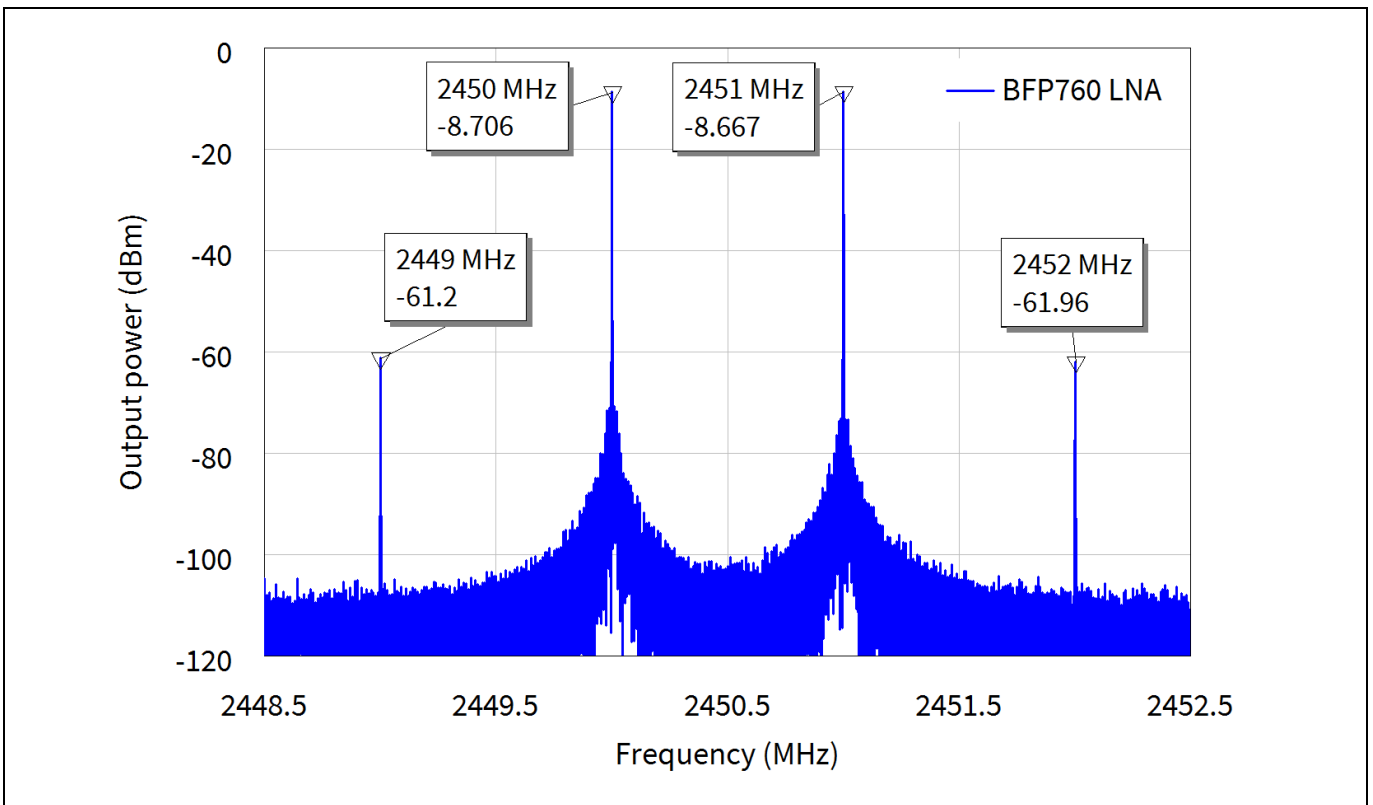


Figure 13 Output third-order intermodulation distortion (IMD₃) measurement of the 2.4 GHz band WLAN LNA with [BFP760](#)

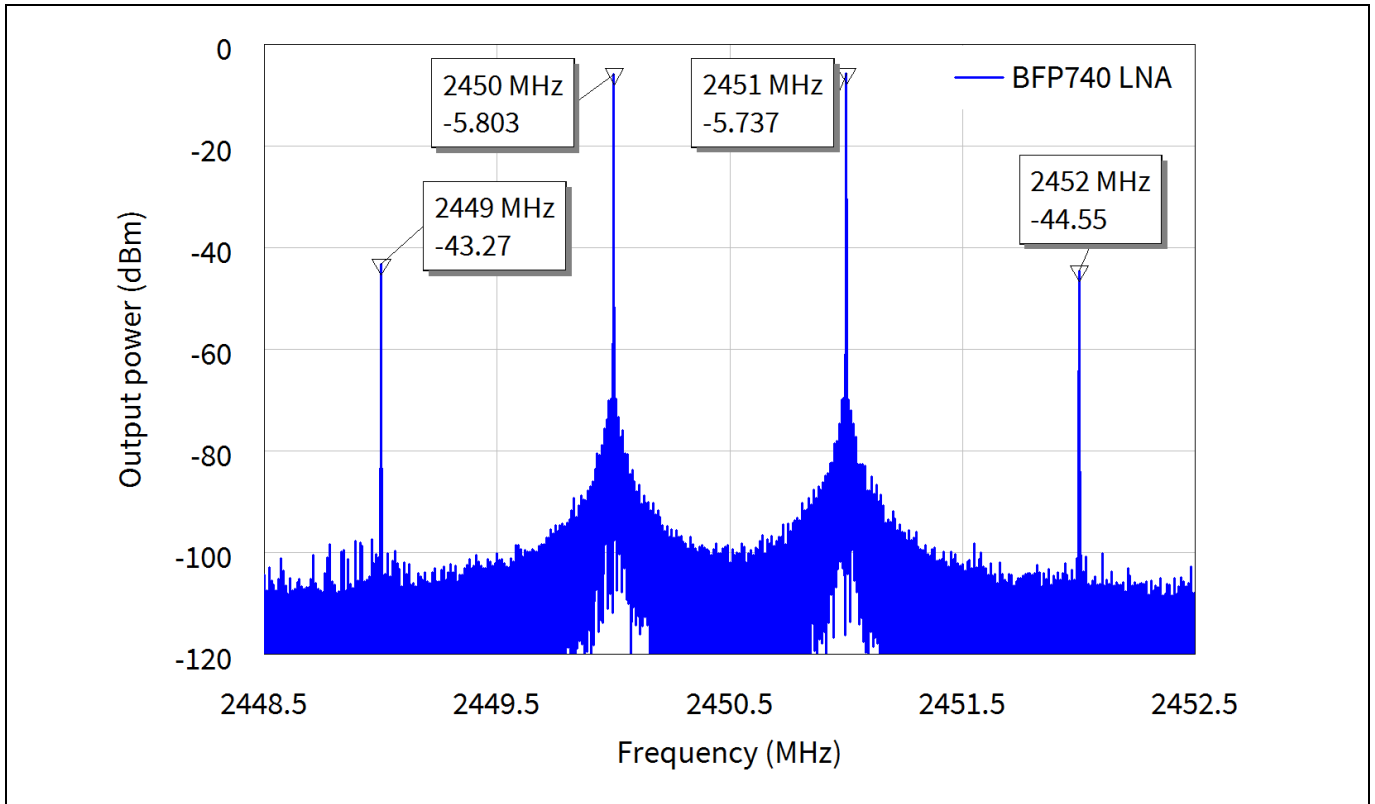


Figure 14 Output IMD_3 measurement of the 2.4 GHz band WLAN LNA with [BFP740](#)

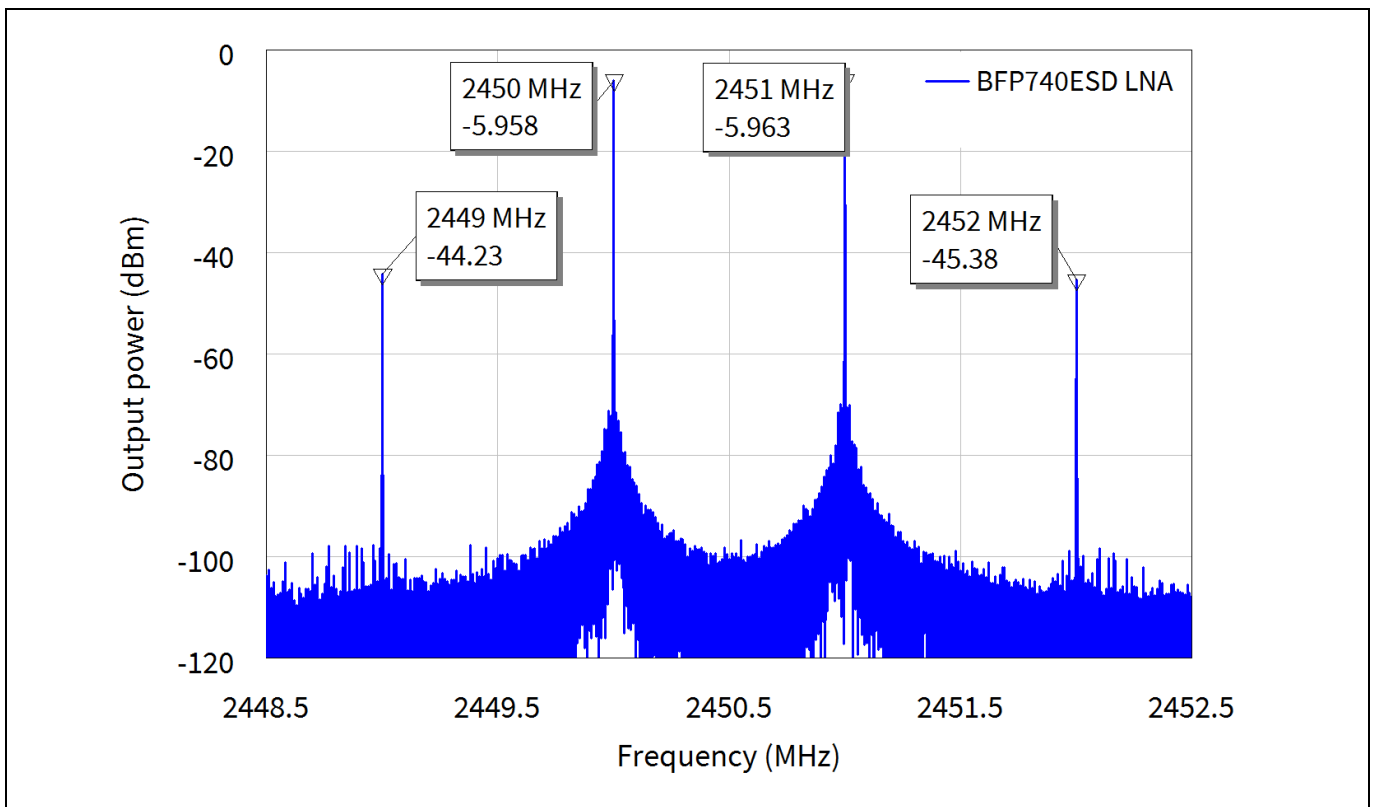


Figure 15 Output IMD_3 measurement of the 2.4 GHz band WLAN LNA with [BFP740ESD](#)

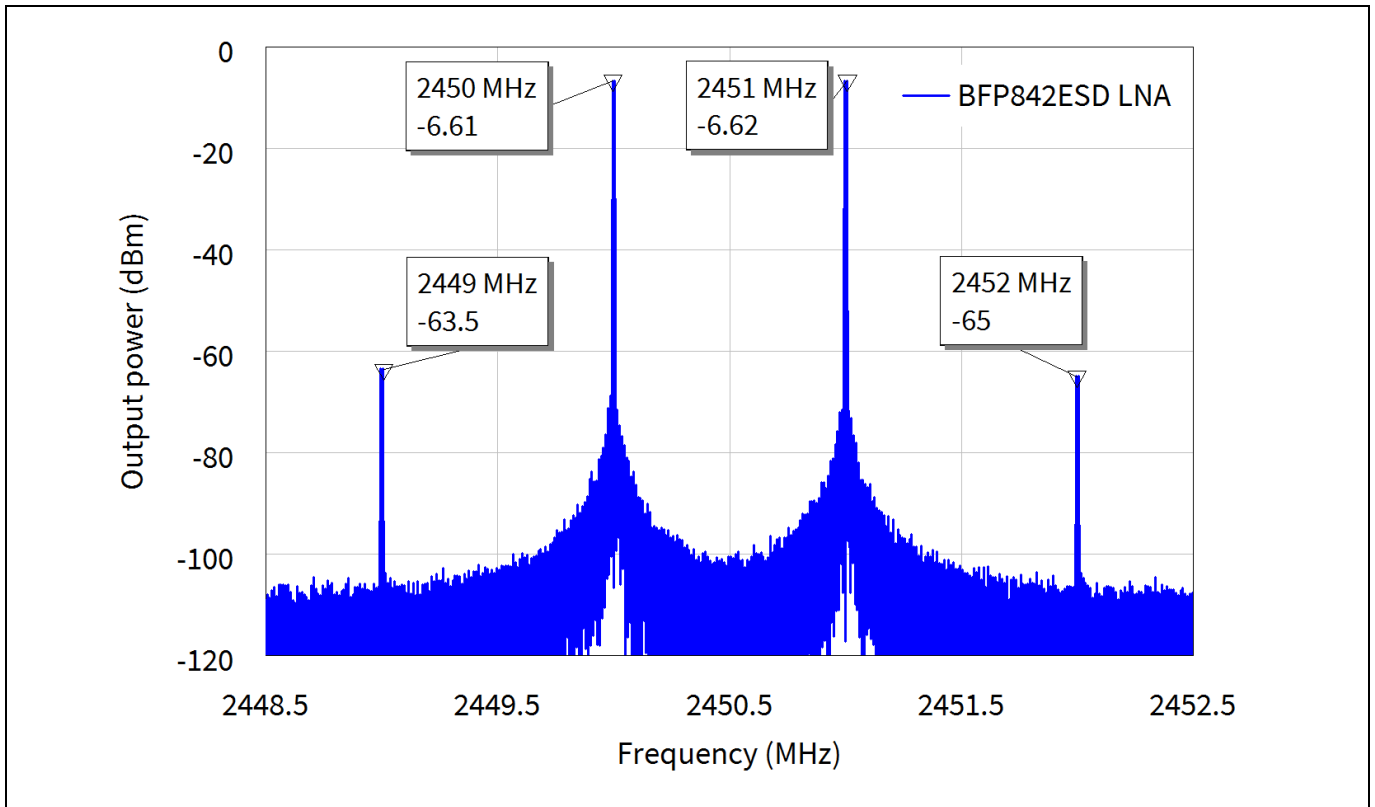


Figure 16 Output IMD_3 measurement of the 2.4 GHz band WLAN LNA with [BFP842ESD](#)

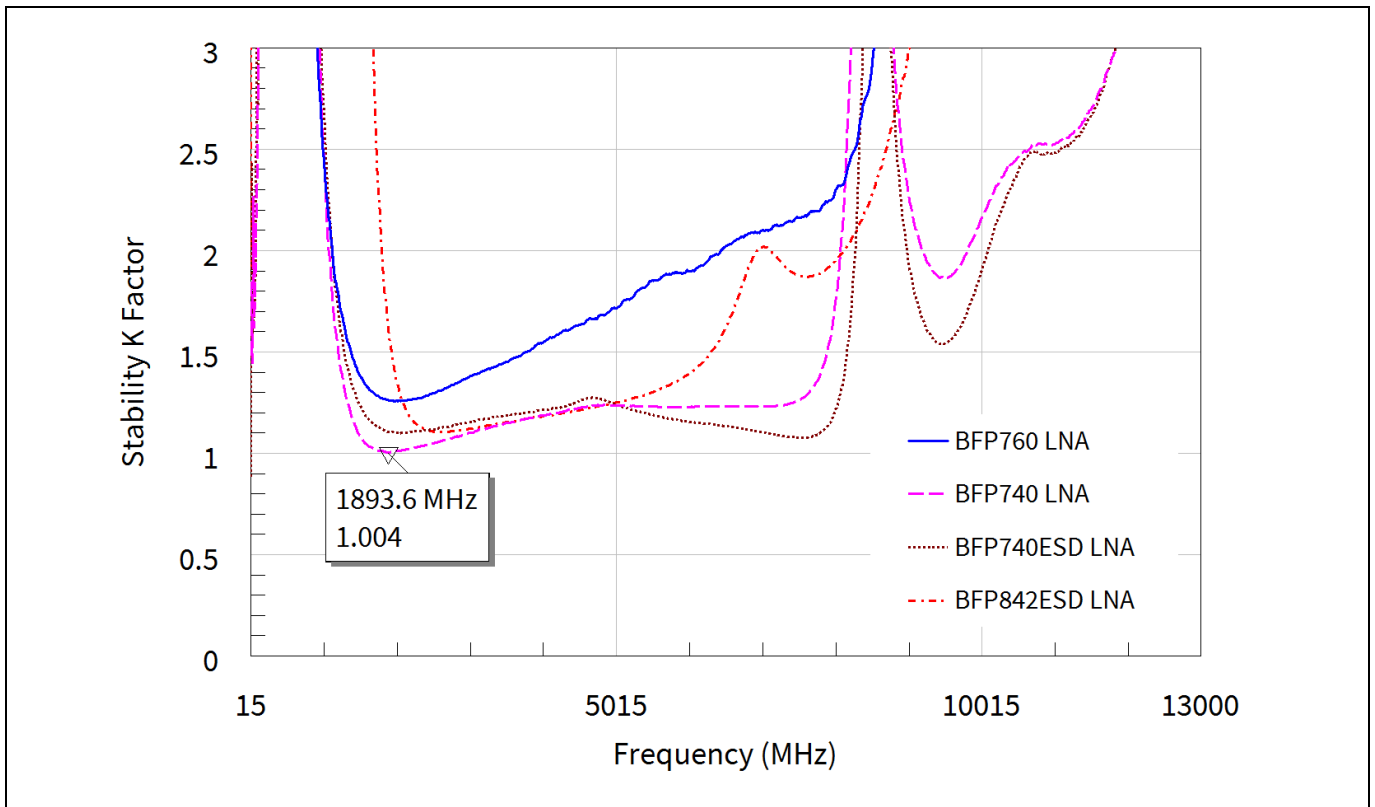


Figure 17 Stability K-factor plots of the 2.4 GHz band WLAN LNAs with SOT343 packaged transistors

2.2 2.4 GHz band WLAN LNAs with small and flat leaded TSFP packaged low-noise transistors

2.2.1 Performance overview

The following table shows the performance of the 2.4 GHz band WLAN LNAs with small and flat leaded TSFP packaged low-noise transistors.

Table 3 Summary of measurement results for the 2.4 GHz band WLAN LNAs with small and flat leaded TSFP packaged low-noise transistors

| Parameter | Symbol | Value | | Unit | Notes |
|------------------------------------|-------------|-------------------------|----------------------------|------|---|
| | | BFP740F | BFP740FESD | | |
| Device | | BFP740F | BFP740FESD | | |
| Bias voltage | V_{CC} | 3 | 3 | V | |
| Bias current | I_{CC} | 11.6 | 11 | mA | |
| Frequency | f | 2.45 | 2.45 | GHz | |
| Gain | G | 17.1 | 16.6 | dB | |
| NF | NF | 0.71 | 0.76 | dB | PCB and SMA loss subtracted: 0.1 dB |
| Input return loss | RL_{in} | 10 | 10 | dB | |
| Output return loss | RL_{out} | 11 | 9.8 | dB | |
| Reverse isolation | ISO_{rev} | 28.8 | 29.2 | dB | |
| Output 1 dB compression point | OP_{1dB} | 2.1 | 1.5 | dBm | |
| Output third-order intercept point | OIP_3 | 11.1 | 10.7 | dBm | Input power: -25 dBm per tone Tone 1: 2450 MHz Tone 2: 2451 MHz |
| Stability | K | >1 | >1 | | Measured from 10 MHz to 13 GHz |

2.2.2 Schematic

The following figure shows the schematic of the 2.4 GHz band WLAN LNAs with small and flat leaded TSFP packaged low-noise transistors. Like the previous LNA circuits, emitter degeneration has been adopted to achieve the transistor impedance matching and low-noise matching at the same time. Please refer to the detailed setting in [Figure 19](#). In the LNA circuit, resistors R1 and R2 form the negative DC feedback mechanism to stabilize the transistor bias points in various conditions. Capacitors C2 and C3 serve as the RF bypass. Transistors' input matching is achieved by the capacitor C1 and the inductor L1. The output matching network is formed by C4, C5, L2, R3 and R4. Resistors R3 and R4 also have the function of improving circuit stability.

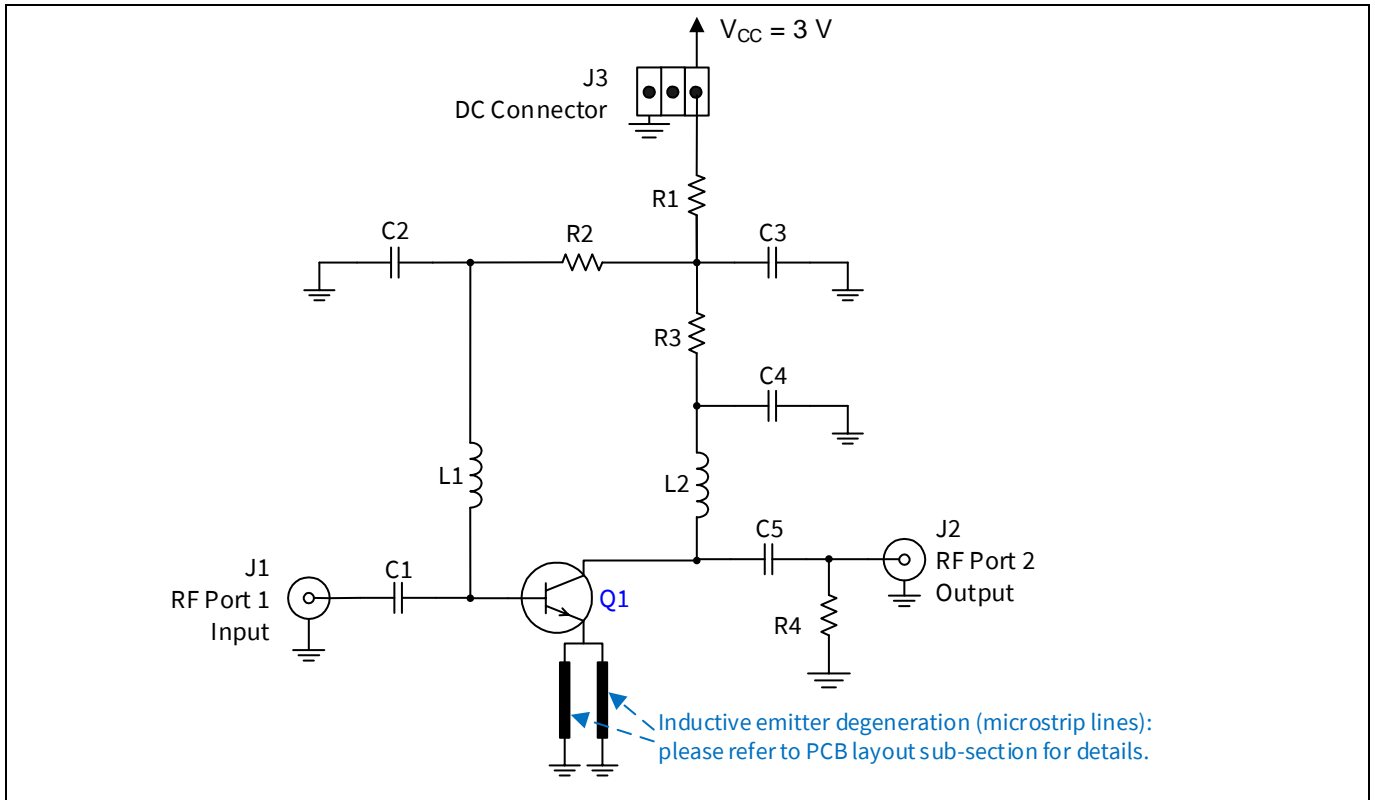


Figure 18 Schematic of the 2.4 GHz band WLAN LNAs with small and flat leaded TSFP packaged transistors

2.2.3 BOM

Table 4 BOM of the 2.4 GHz band WLAN LNAs with small and flat leaded TSFP packaged transistors

| Symbol | Value | | Unit | Size | Manufacturer | Comment |
|--------|-------------------------|----------------------------|------|------|--------------|---|
| Q1 | BFP740F | BFP740FESD | - | - | Infineon | SiGe:C low-noise transistor |
| C1 | 22 | 22 | pF | 0402 | Various | Input matching and DC blocking |
| C2 | 39 | 39 | pF | 0402 | Various | RF decoupling |
| C3 | 39 | 39 | pF | 0402 | Various | RF decoupling |
| C4 | 3.3 | 3.3 | pF | 0402 | Various | Output matching and stability improvement |
| C5 | 1.8 | 1.8 | pF | 0402 | Various | Output matching and DC blocking |
| R1 | 30 | 30 | Ω | 0402 | Various | DC biasing |
| R2 | 51 | 43 | kΩ | 0402 | Various | Base DC biasing |
| R3 | 30 | 30 | Ω | 0402 | Various | Low-frequency stability improvement |
| R4 | 100 | 100 | Ω | 0402 | Various | Output matching and stability improvement |
| L1 | 10 | 10 | nH | 0402 | Murata LQG | RF choke and input matching |
| L2 | 5.1 | 5.6 | nH | 0402 | Murata LQG | RF choke and output matching |

2.2.4 Evaluation board and PCB layout information

The evaluation board for the 2.4 GHz band WLAN LNAs with small and flat leaded TSFP packaged transistors:

- PCB material: FR4
- PCB marking: M11118

The photo of the evaluation board for the 2.4 GHz band WLAN LNAs with small and flat leaded TSFP packaged transistors and the detailed description of the PCB stack are shown in the following figures.

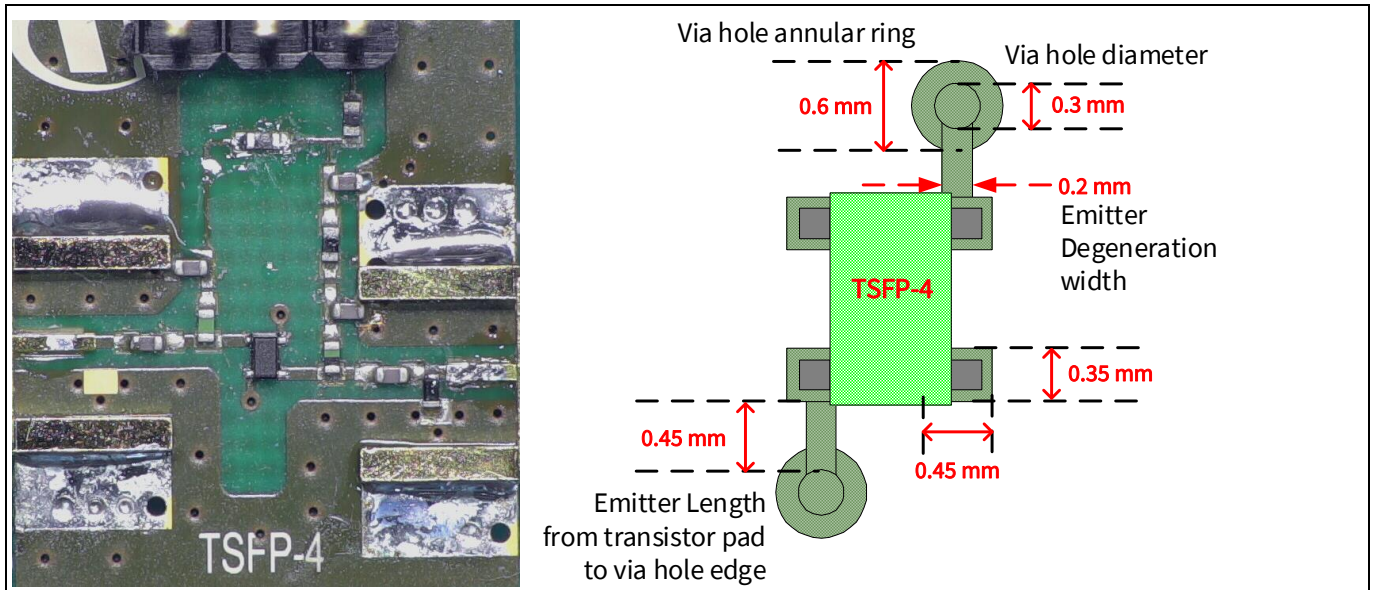


Figure 19 Photo of the evaluation board with PCB marking M11118 (left) and emitter degeneration details (right)

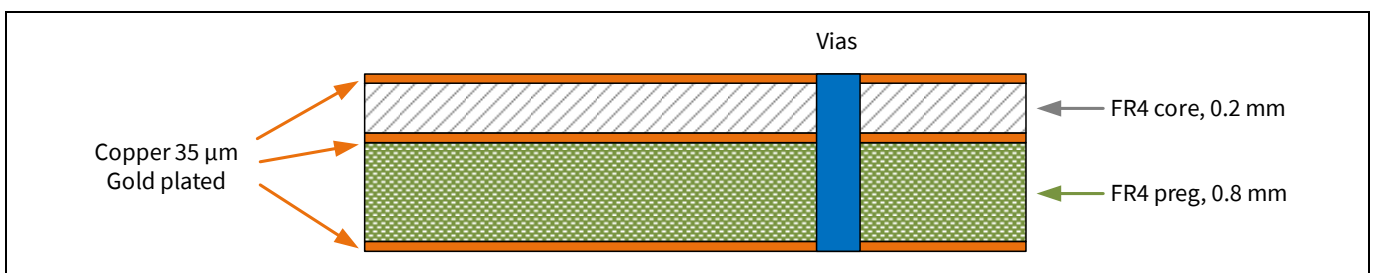


Figure 20 PCB stack information for the evaluation board with PCB marking M11118

2.2.5 Measurement results of 2.4 GHz band WLAN LNAs with small and flat leaded TSFP packaged low-noise transistors

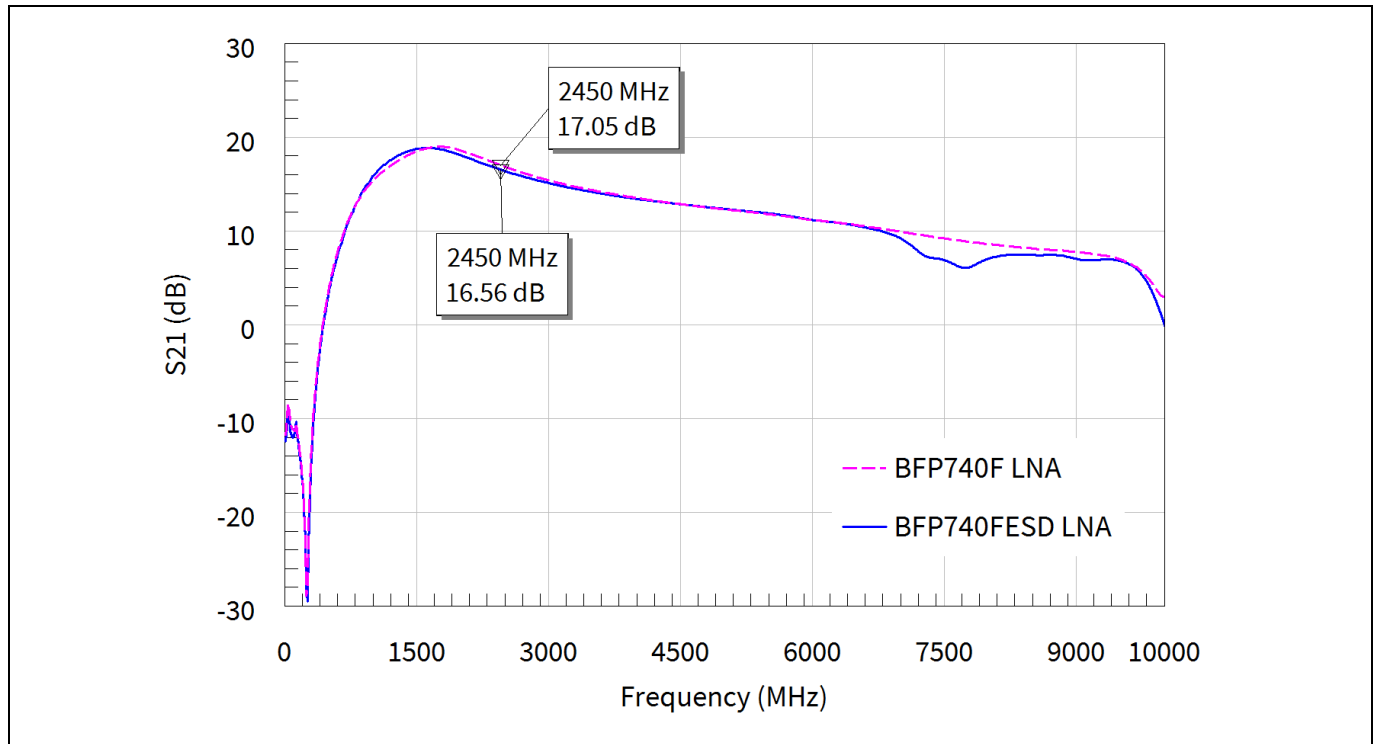


Figure 21 Small signal gain of the 2.4 GHz band WLAN LNAs with TSFP packaged transistors

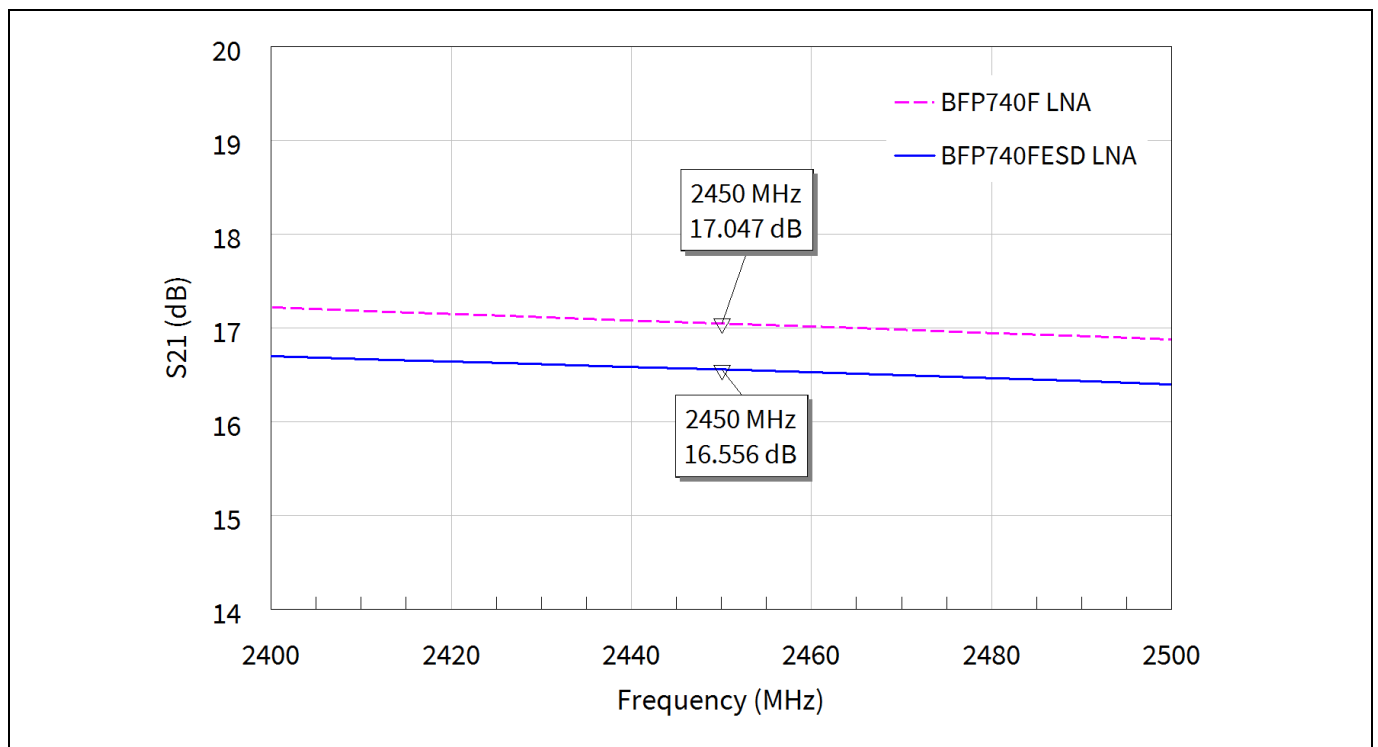


Figure 22 Small signal gain of the 2.4 GHz band WLAN LNAs with TSFP packaged transistors (detail view)

Note: The graphs are generated with the AWR EDA software Microwave Office®.

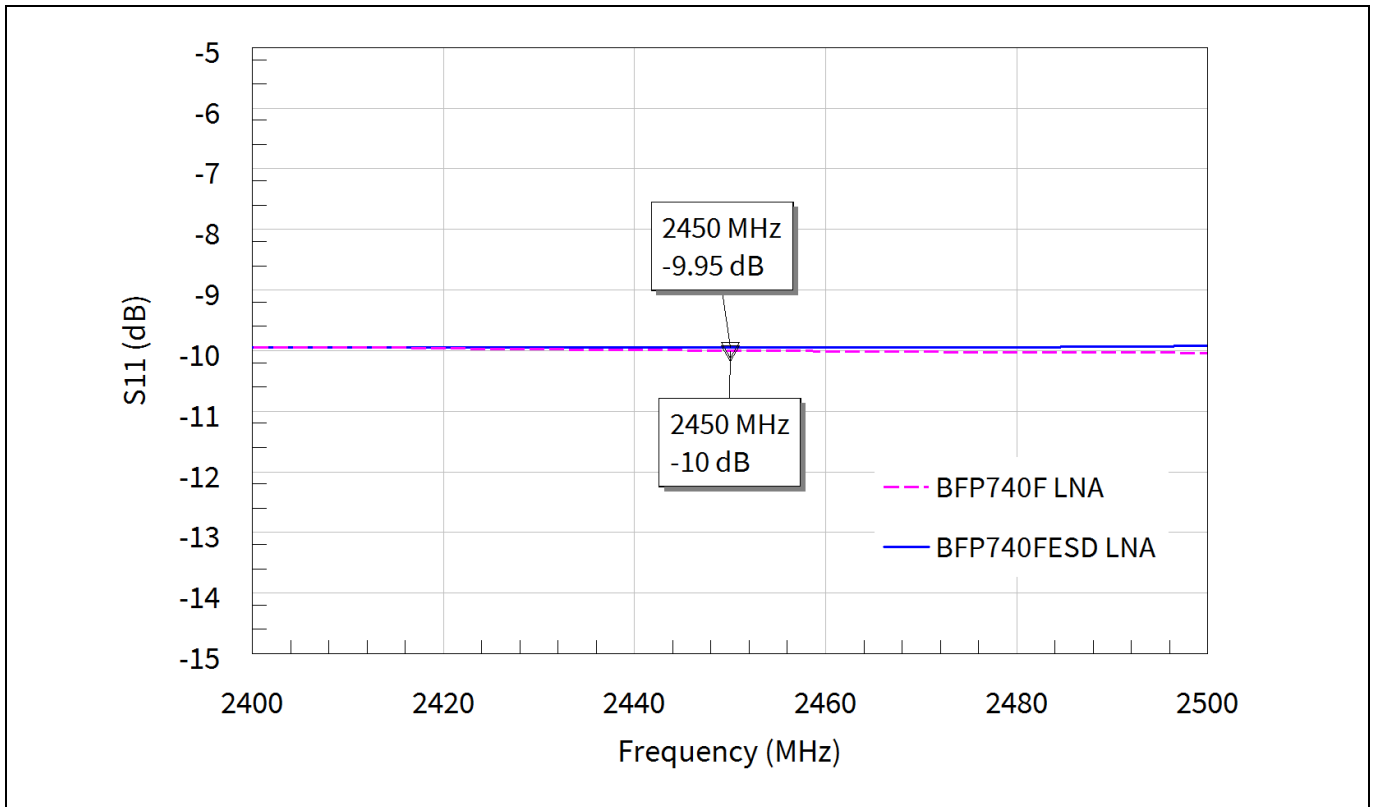


Figure 23 Input return loss measurement of the 2.4 GHz band WLAN LNAs with TSFP packaged transistors

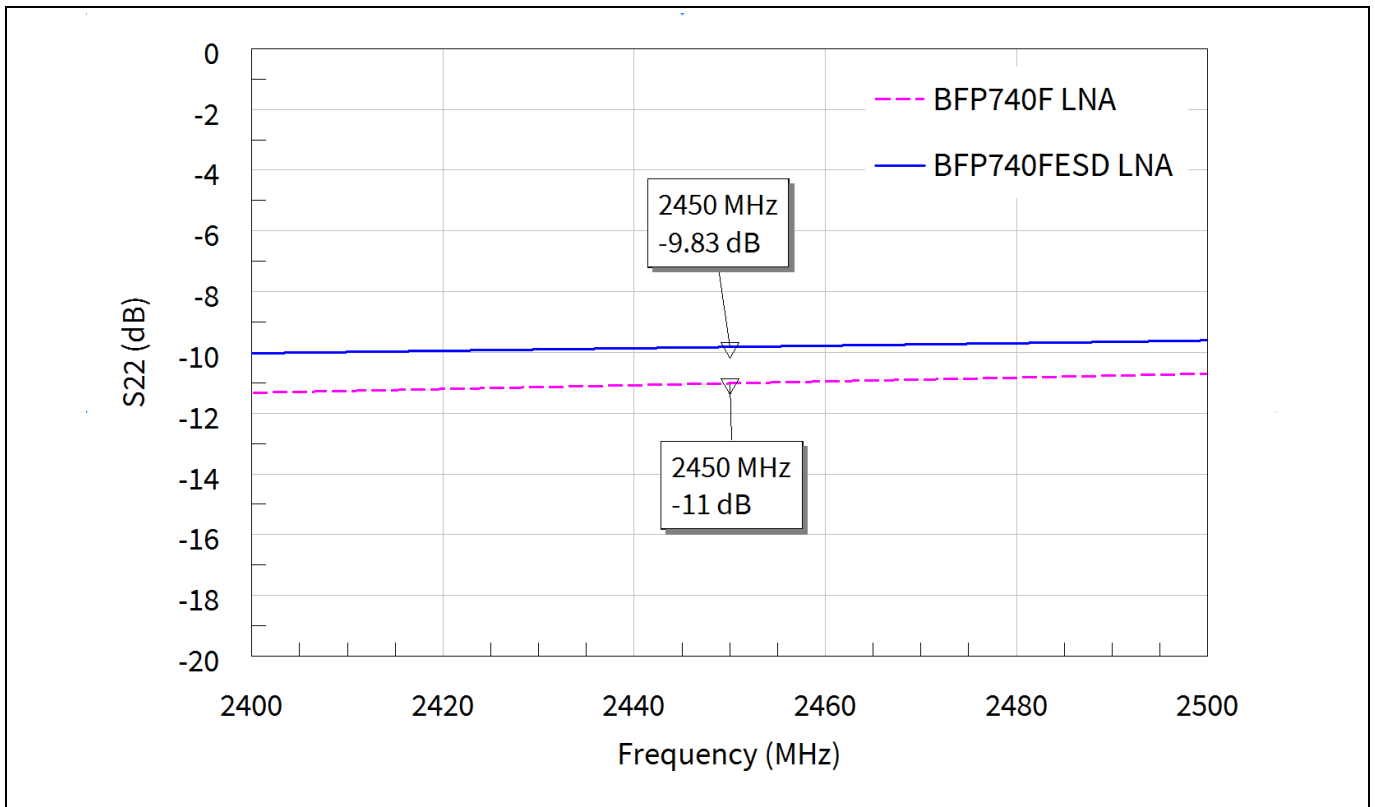


Figure 24 Output return loss measurement of the 2.4 GHz band WLAN LNAs with TSFP packaged transistors

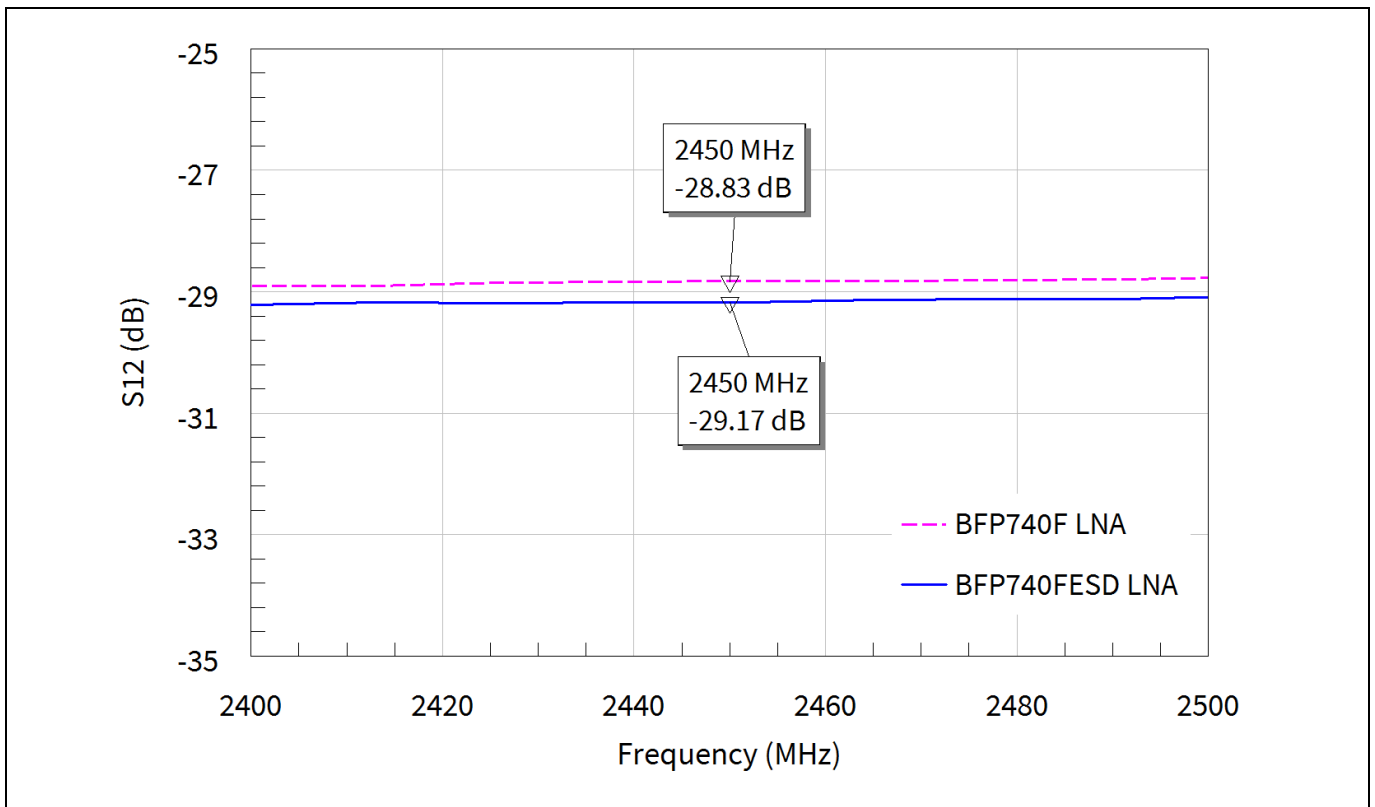


Figure 25 Reverse isolation measurement of the 2.4 GHz band WLAN LNAs with TSFP packaged transistors

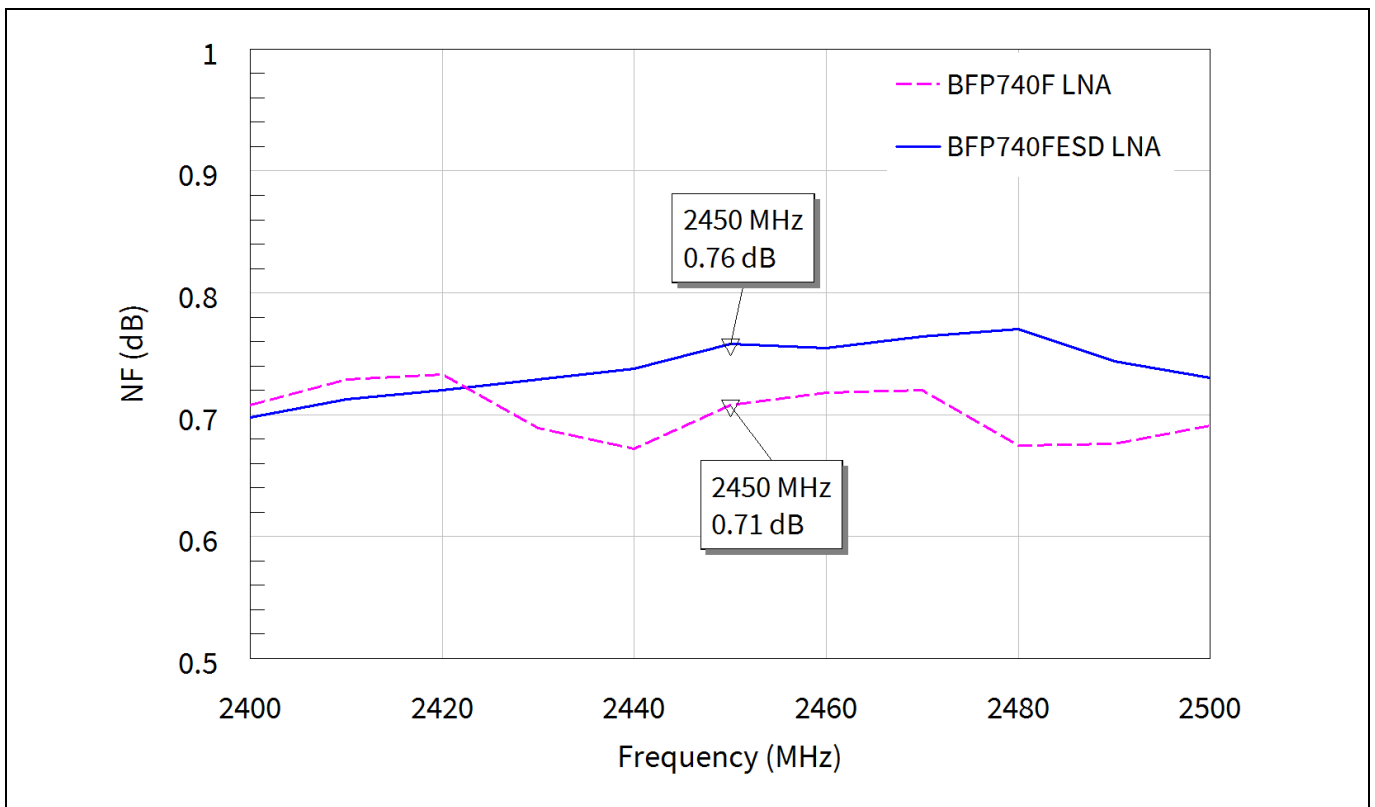


Figure 26 NF measurement of the 2.4 GHz band WLAN LNAs with TSFP packaged transistors

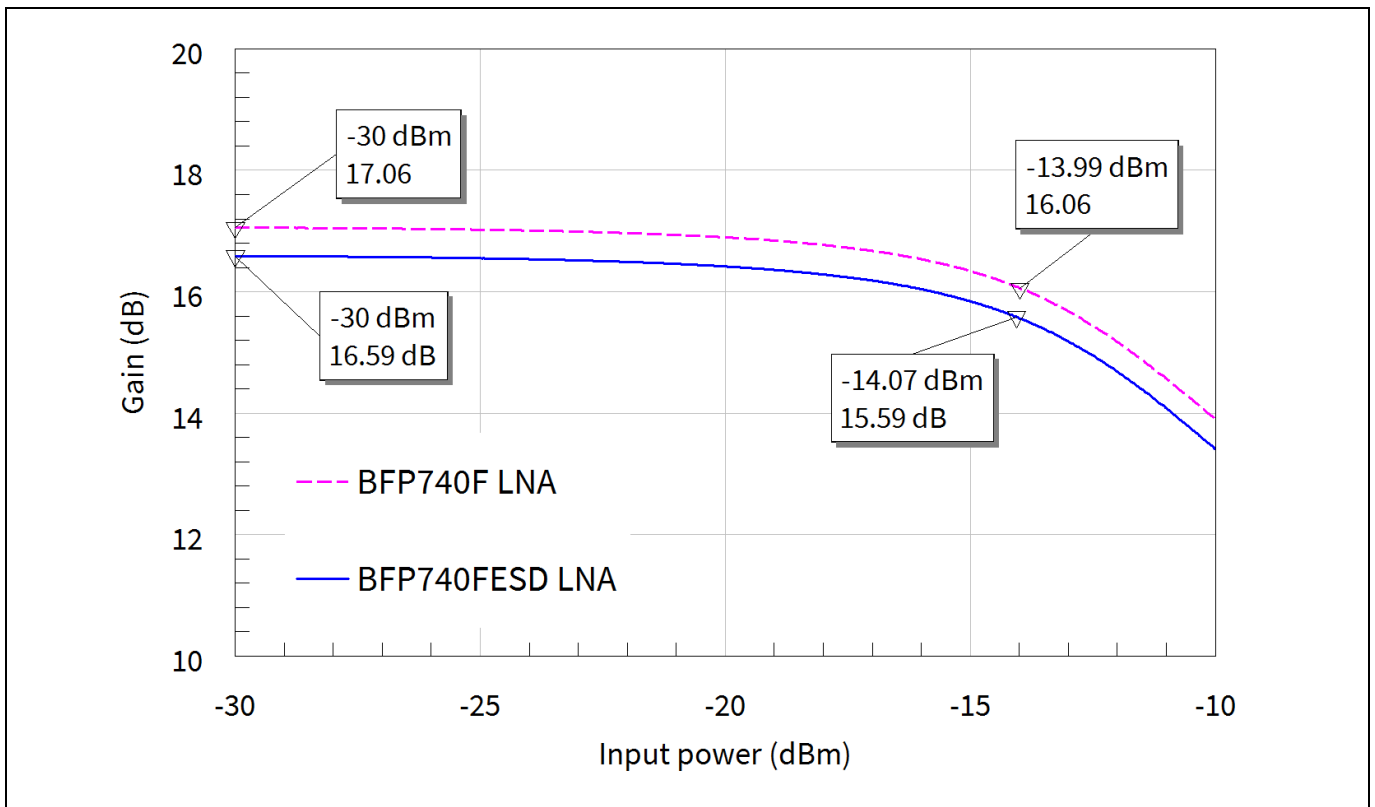


Figure 27 Input 1 dB compression point measurement of the 2.4 GHz band WLAN LNAs with TSFP packaged transistors

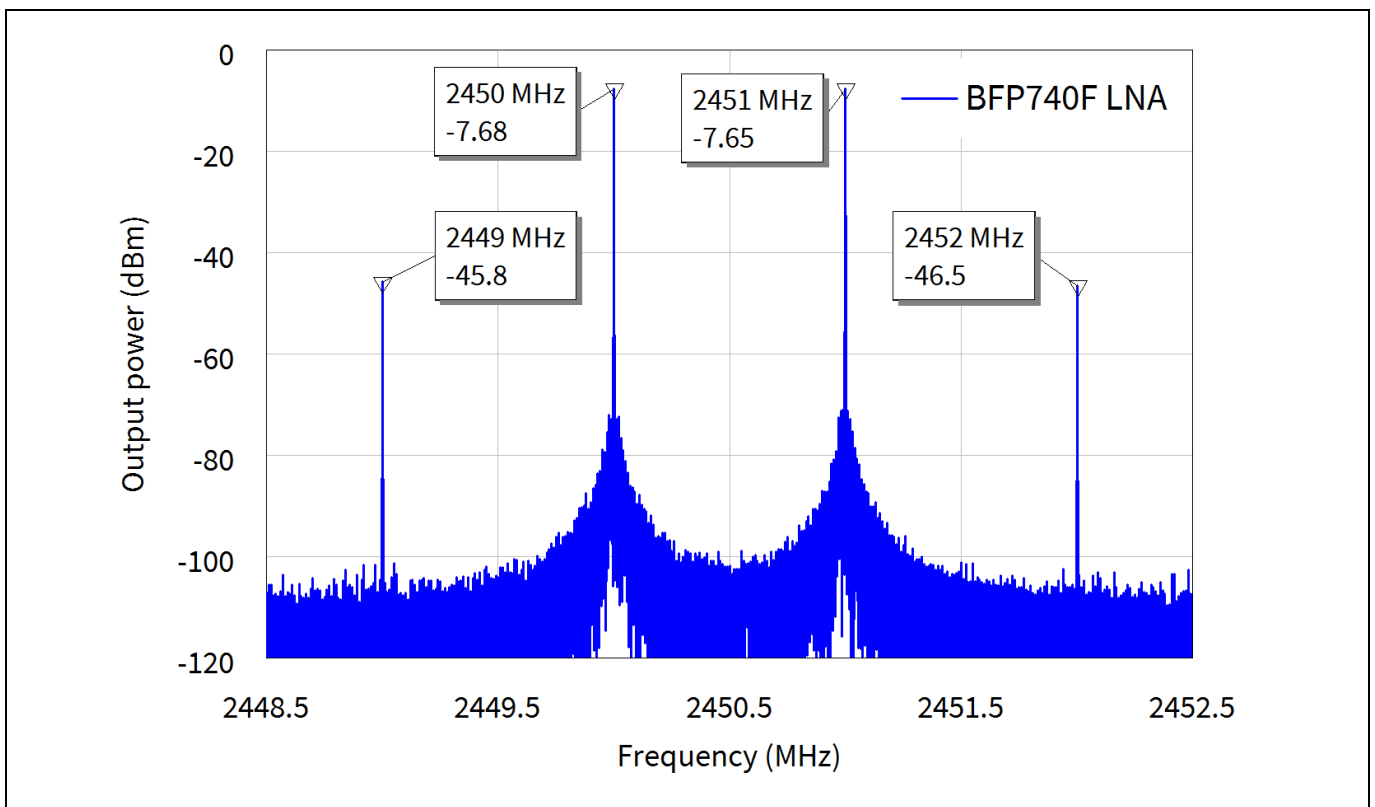


Figure 28 Output IMD_3 measurement of the 2.4 GHz band WLAN LNA with [BFP740F](#)

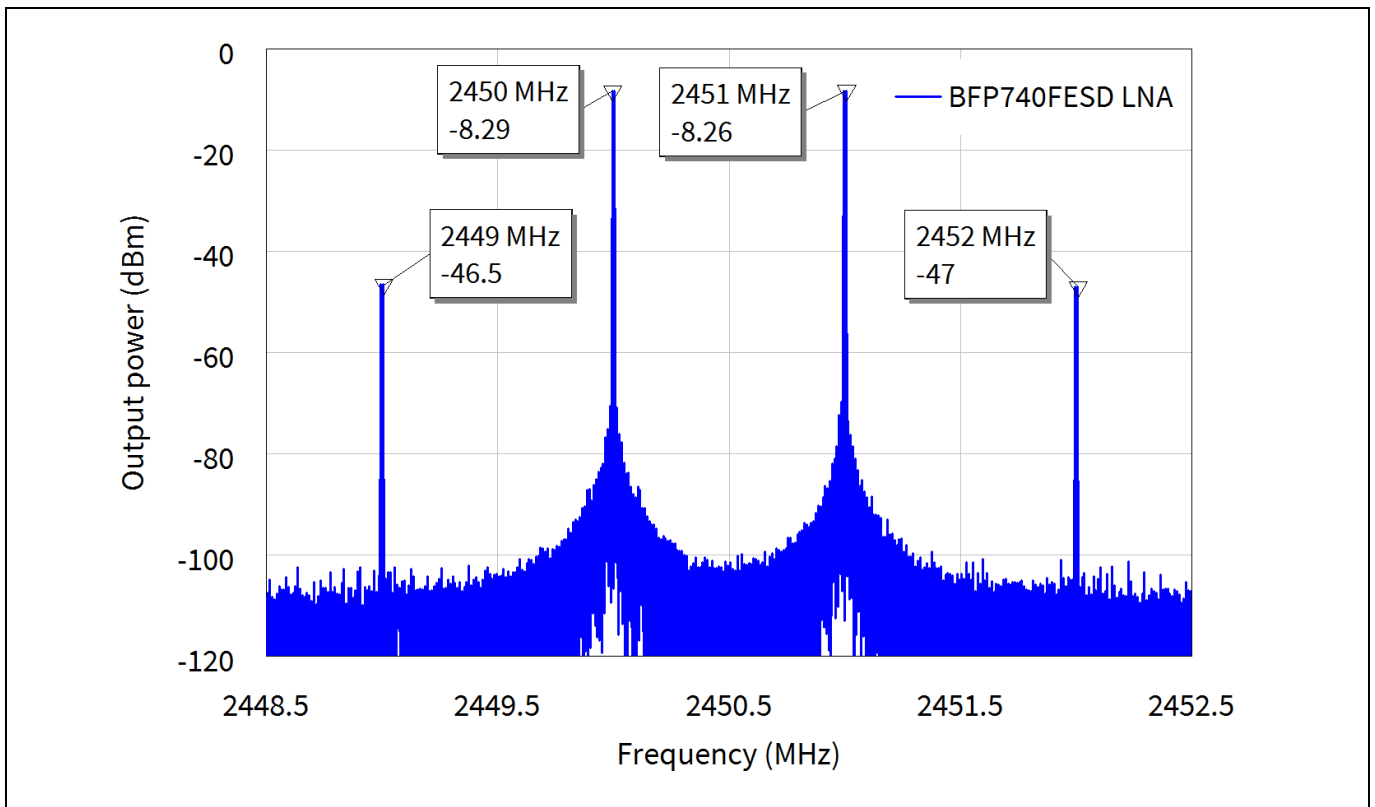


Figure 29 Output IMD₃ measurement of the 2.4 GHz band WLAN LNA with [BFP740FESD](#)

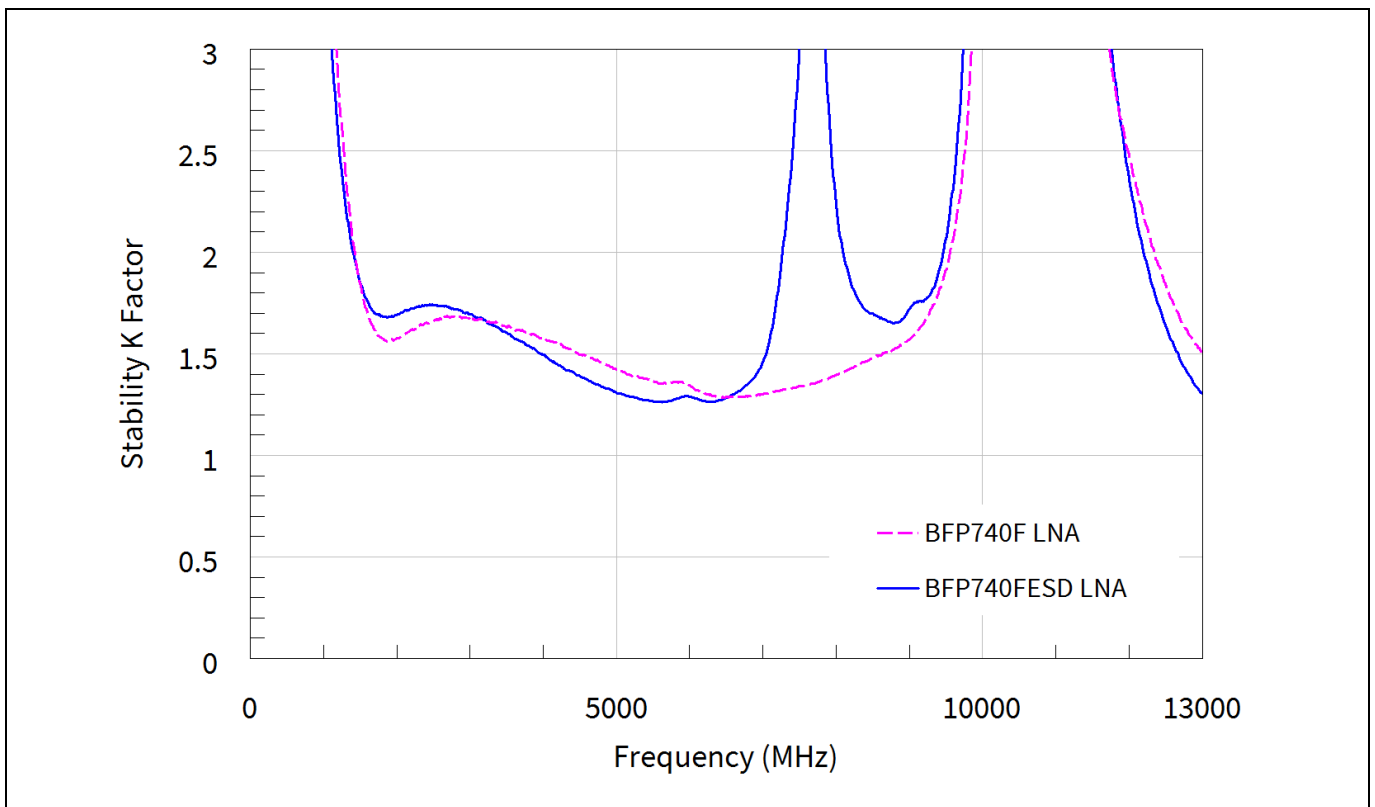


Figure 30 Stability K-factor plots of the 2.4 GHz band WLAN LNAs with TSFP packaged transistors

2.3 2.4 GHz band WLAN LNA with small leaded three-pin low-noise transistor [BFR840L3RHESD](#)

2.3.1 Performance overview

The following table shows the performance of the 2.4 GHz band WLAN LNA with small leaded three-pin TSLP packaged low-noise transistor [BFR840L3RHESD](#).

Table 5 Summary of measurement results for the 2.4 GHz band WLAN LNA with [BFR840L3RHESD](#)

| Parameter | Symbol | Value | Unit | Notes |
|------------------------------------|-------------|-------------------------------|------|---|
| Device | | BFR840L3RHESD | | |
| Bias voltage | V_{CC} | 3.0 | V | |
| Bias current | I_{CC} | 11.4 | mA | |
| Frequency | f | 2.45 | GHz | |
| Gain | G | 18.5 | dB | |
| NF | NF | 1.02 | dB | PCB and SMA connector losses subtracted: 0.1 dB |
| Input return loss | RL_{in} | 12.5 | dB | |
| Output return loss | RL_{out} | 23.9 | dB | |
| Reverse isolation | ISO_{rev} | 28.4 | dB | |
| Output 1 dB compression point | OP_{1dB} | 0.6 | dBm | |
| Output third-order intercept point | OIP_3 | 11.4 | dBm | Input power: -30 dBm per tone Tone 1: 2450 MHz Tone 2: 2451 MHz |
| Stability | K | >1 | | Stability measured from 100 MHz to 13 GHz |

2.3.2 Schematic

The following figure shows the schematic of the 2.4 GHz band WLAN LNA with the small leaded three-pin TSLP packaged transistor [BFR840L3RHESD](#). Emitter degeneration provides negative feedback to achieve the transistor impedance matching and low-noise matching at the same time (see [Figure 32](#)). In the LNA circuit, resistors R1 and R2 stand for transistor voltage and current bias; meanwhile, they form a negative DC feedback mechanism to stabilize the transistor bias points in various conditions. Capacitors C2 and C3 serve as the RF bypass. Transistor input matching is achieved by the capacitor C1 and the inductor L1. The output matching network is formed by C4, L2, R4 and R5. Resistors R4 and R5 also have the function of improving circuit stability.

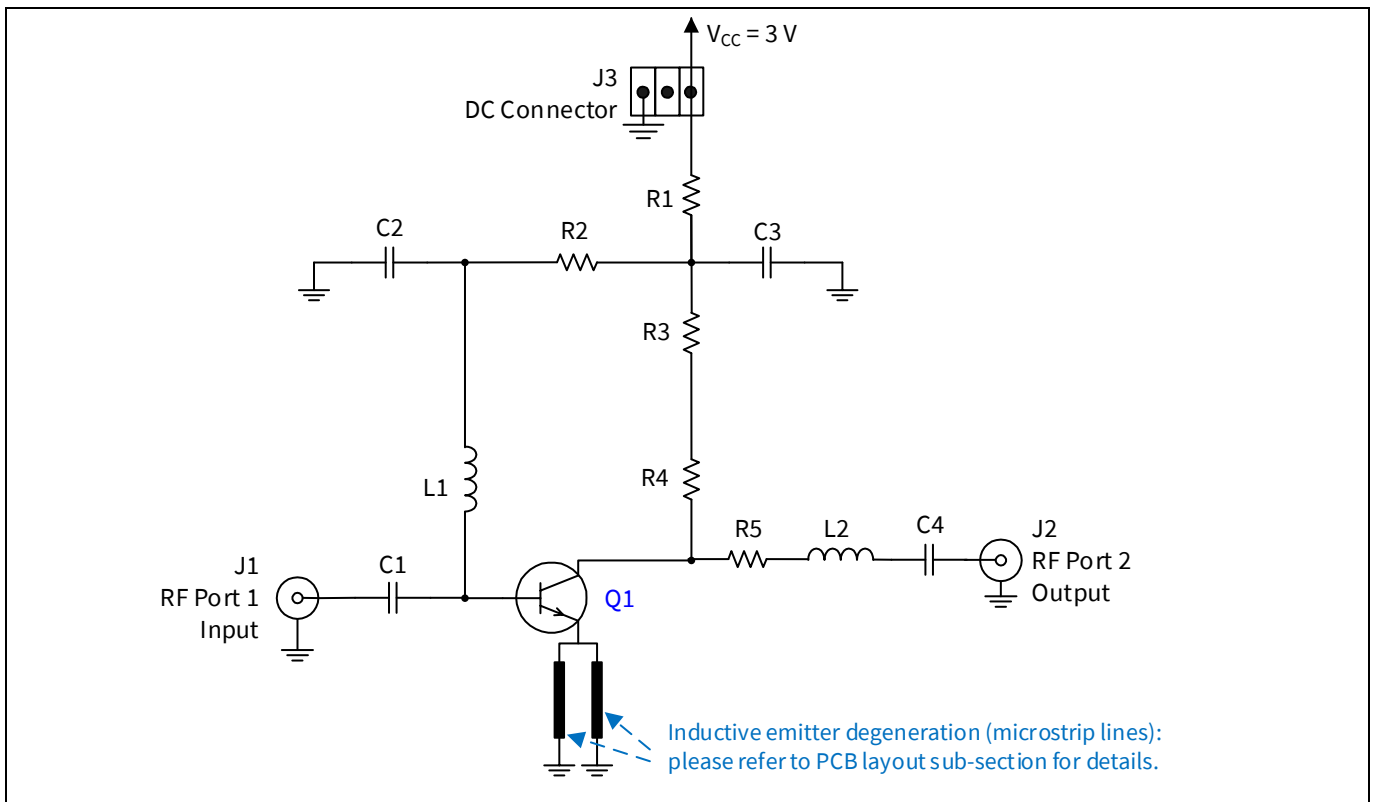


Figure 31 Schematic of the 2.4 GHz band WLAN LNA with [BFR840L3RHESD](#)

2.3.3 BOM

Table 6 BOM of the 2.4 GHz band WLAN LNA with [BFR840L3RHESD](#)

| Symbol | Value | Unit | Size | Manufacturer | Comment |
|--------|-------------------------------|------|------|-------------------|---|
| Q1 | BFR840L3RHESD | – | – | Infineon | SiGe bipolar transistor |
| C1 | 2.2 | pF | 0201 | Various | Input matching and DC blocking |
| C2 | 33 | pF | 0201 | Various | RF decoupling |
| C3 | 33 | pF | 0201 | Various | RF decoupling |
| C4 | 8.2 | pF | 0201 | Various | Output matching and DC blocking |
| R1 | 100 | Ω | 0201 | Various | DC biasing |
| R2 | 27 | kΩ | 0201 | Various | Base DC biasing |
| R3 | 0 | Ω | 0201 | Various | Jumper |
| R4 | 82 | Ω | 0201 | Various | Stability improvement and output matching |
| R5 | 10 | Ω | 0201 | Various | High-frequency stability improvement |
| L1 | 2.7 | nH | 0201 | Murata LQP series | RF choke and input matching |
| L2 | 2.4 | nH | 0201 | Murata LQP series | Output matching |

2.3.4 Evaluation board and PCB layout information

The evaluation board for the 2.4 GHz band WLAN LNA with small leaded three-pin TSLP packaged transistor [BFR840L3RHESD](#):

- PCB material: FR4
- PCB marking: M120131

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The photo of the evaluation board for the 2.4 GHz band WLAN LNA with [BFR840L3RHESD](#) and the detailed description of the PCB stack are shown in the following figures.

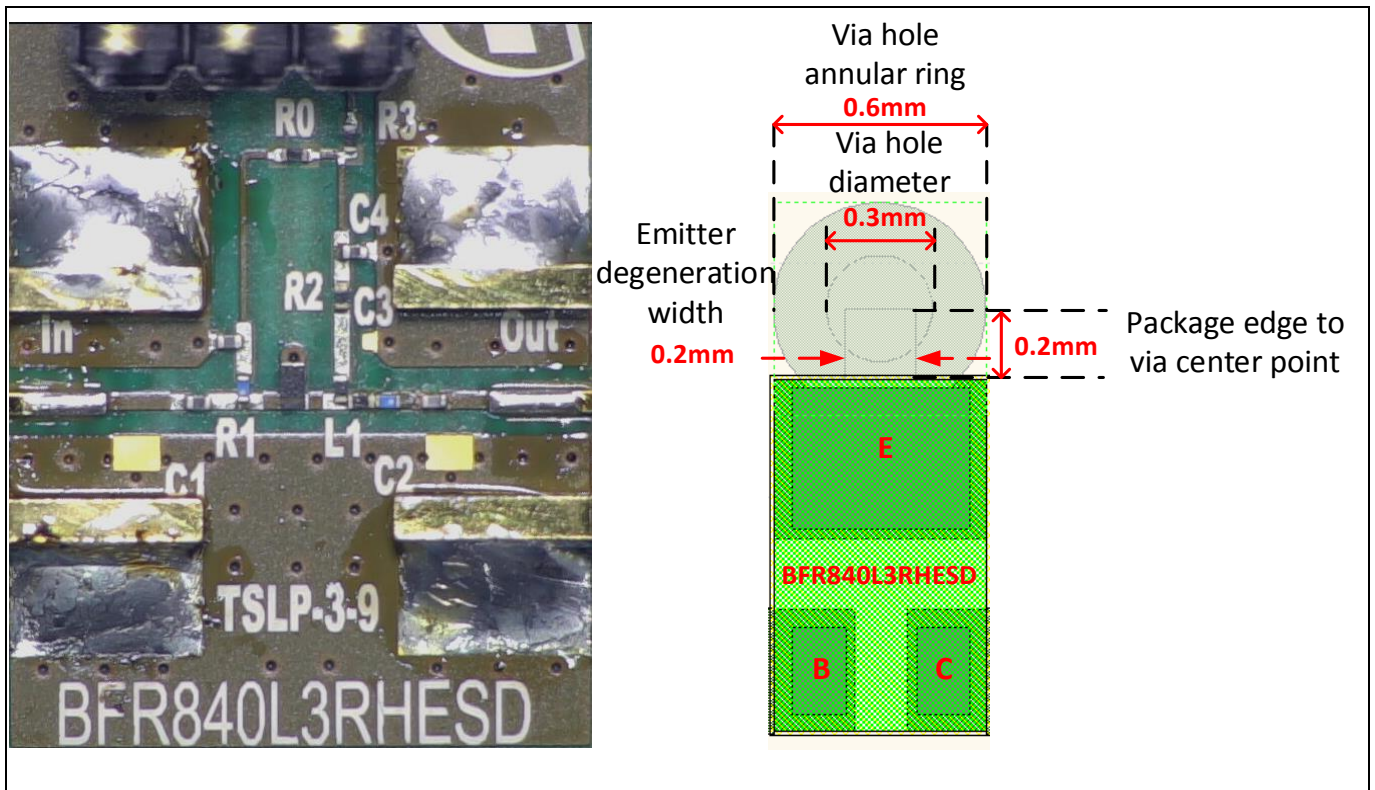


Figure 32 Photo of the evaluation board with the PCB marking M120131 (left) and emitter degeneration details (right)

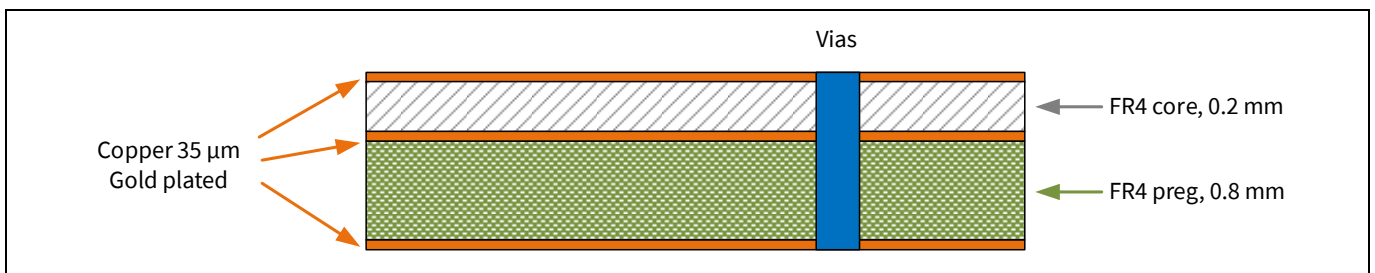


Figure 33 PCB stack information for the evaluation board with the PCB marking M120131

2.3.5 Measurement results of the 2.4 GHz band WLAN LNA with small leaded three-pin TSLP packaged low-noise transistor [BFR840L3RHESD](#)

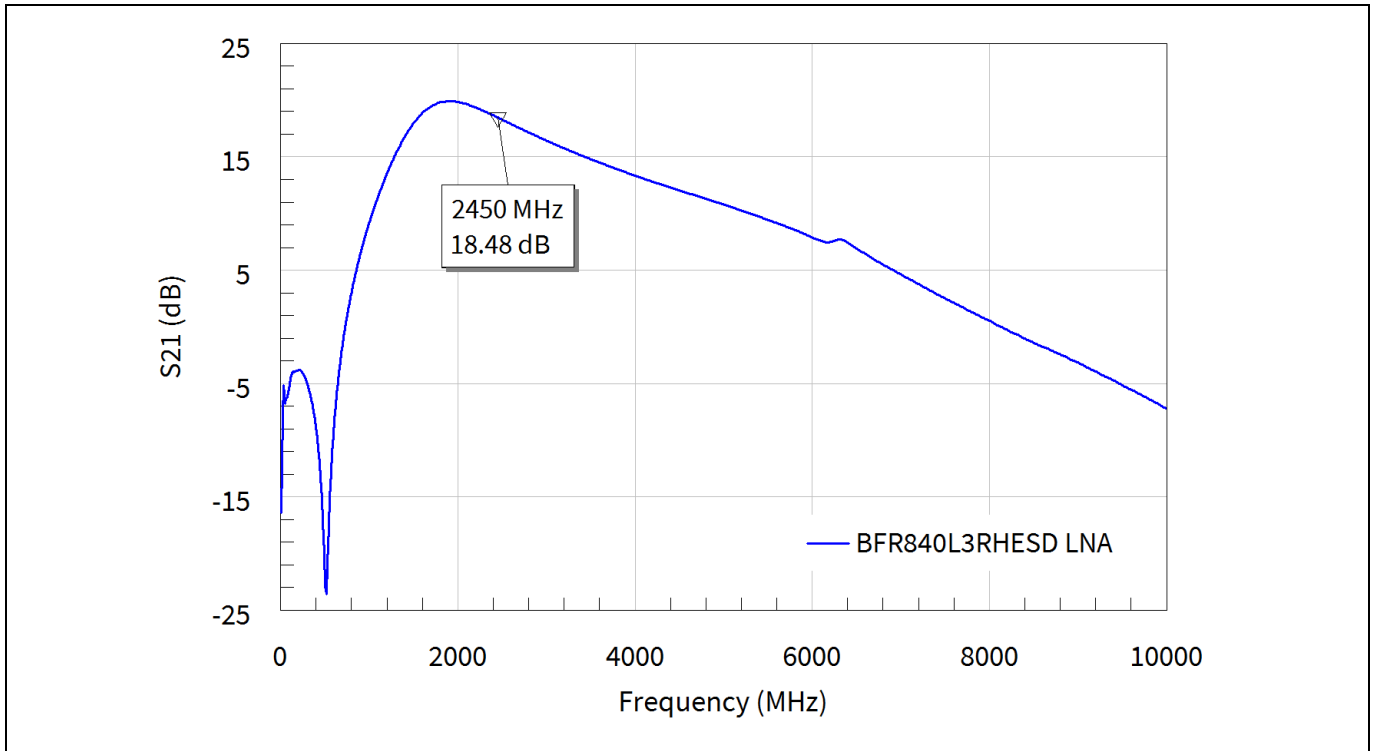


Figure 34 Small signal gain of the 2.4 GHz band WLAN LNA with [BFR840L3RHESD](#)

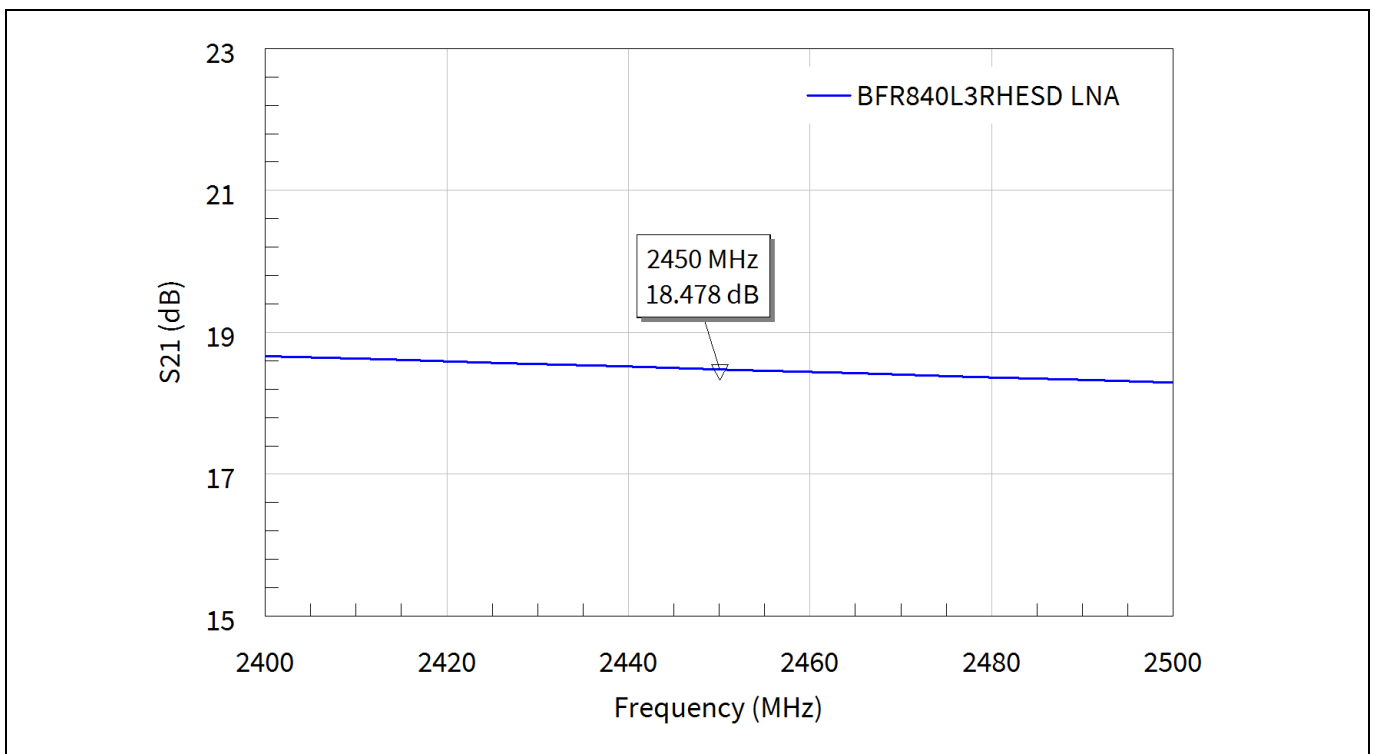


Figure 35 Small signal gain of the 2.4 GHz band WLAN LNA with [BFR840L3RHESD](#) (detail view)

Note: The graphs are generated with the AWR EDA software Microwave Office®.

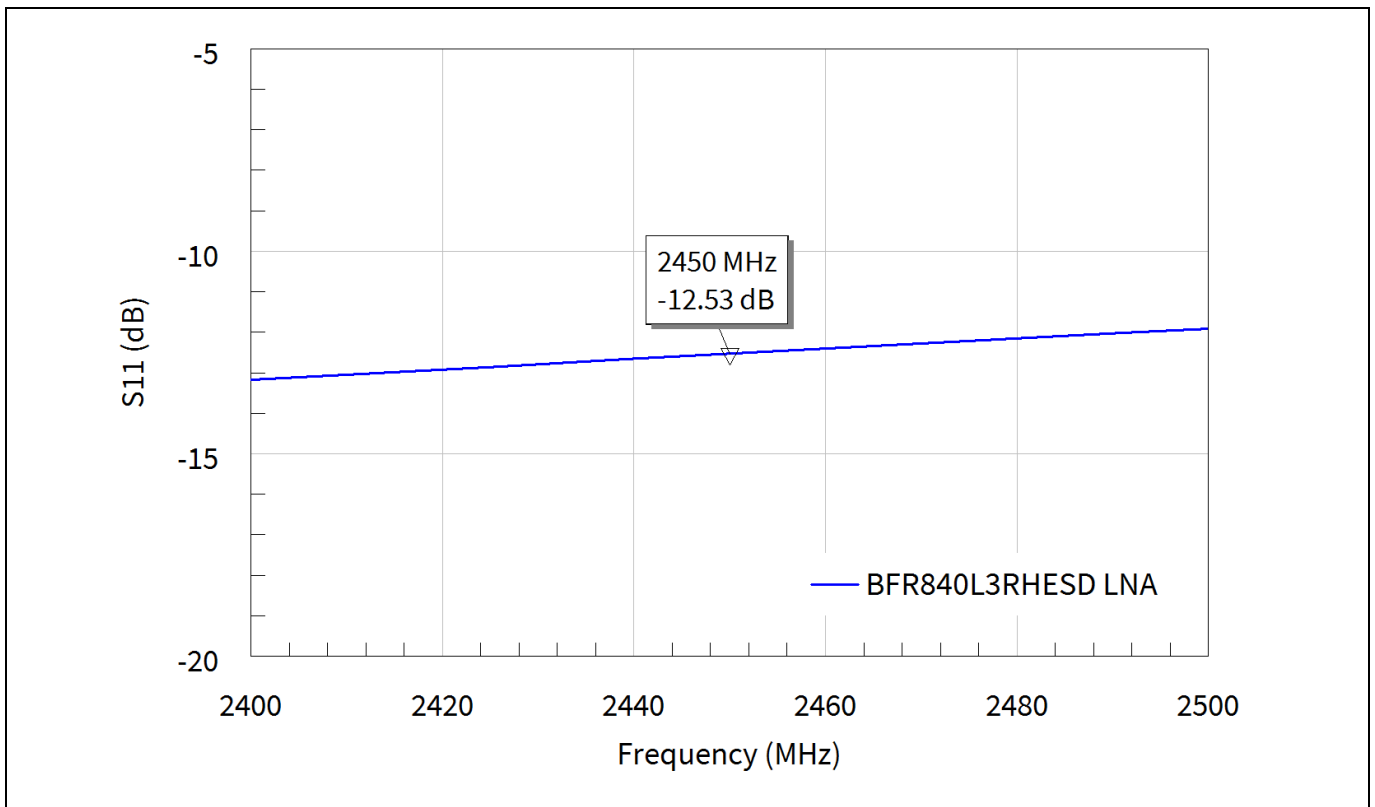


Figure 36 Input return loss measurement of the 2.4 GHz band WLAN LNA with [BFR840L3RHESD](#)

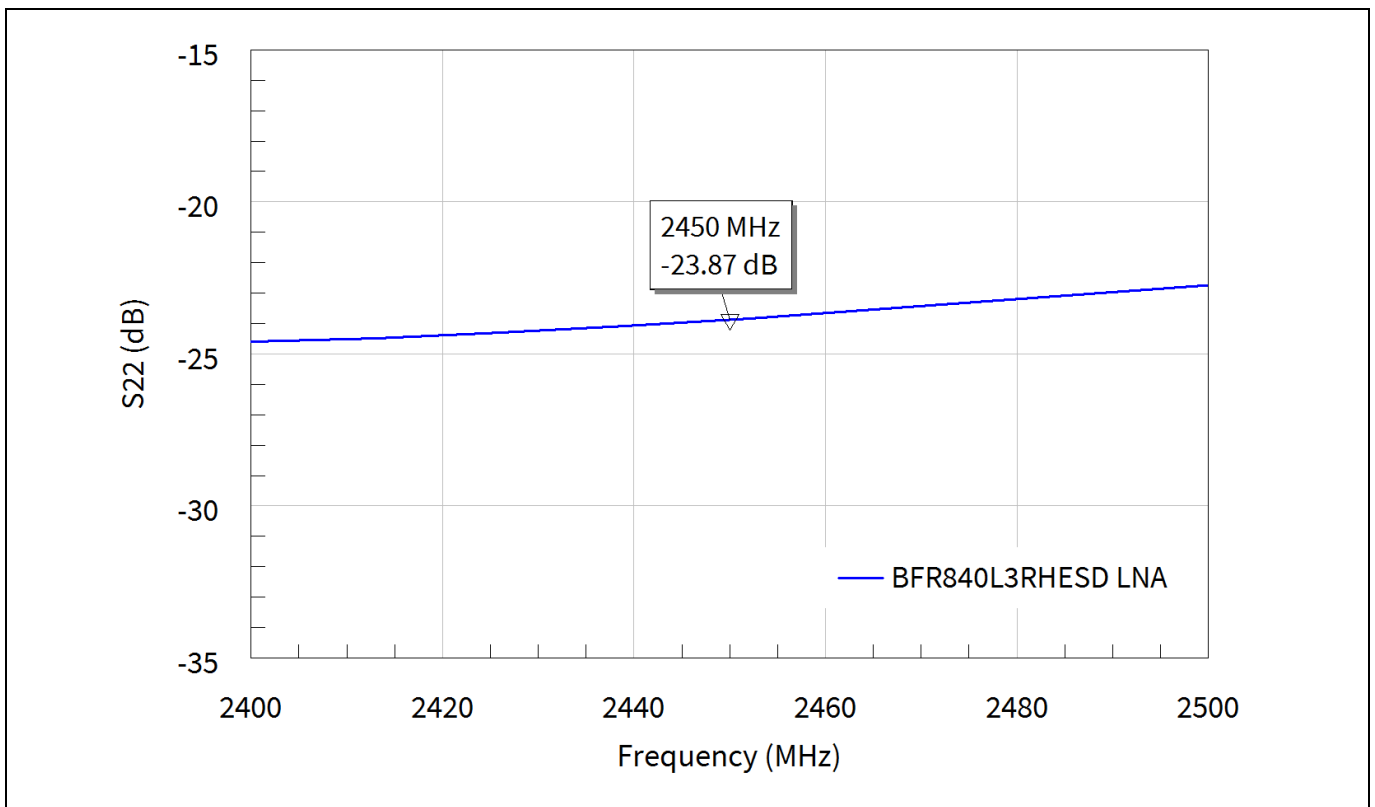


Figure 37 Output return loss measurement of the 2.4 GHz band WLAN LNA with [BFR840L3RHESD](#)

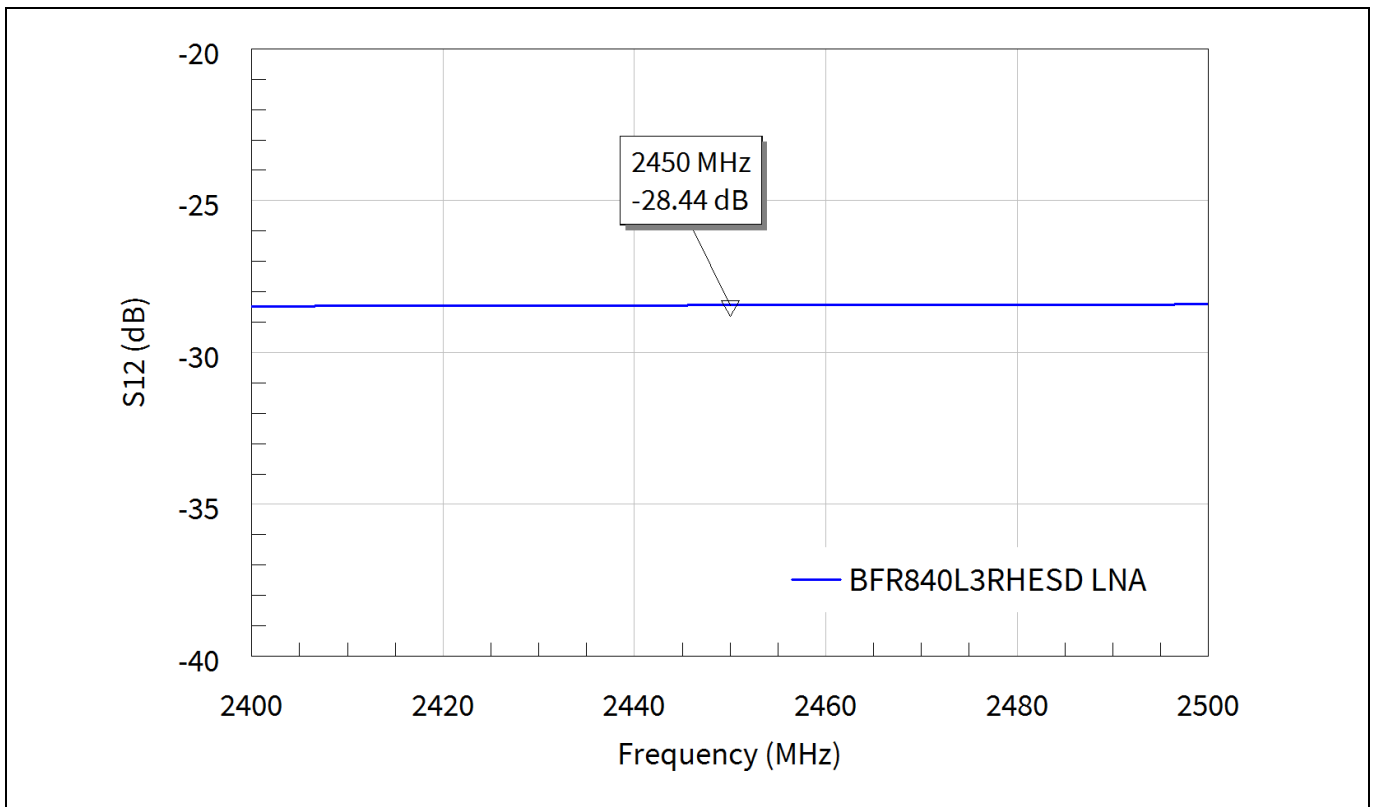


Figure 38 Reverse isolation measurement of the 2.4 GHz band WLAN LNA with [BFR840L3RHESD](#)

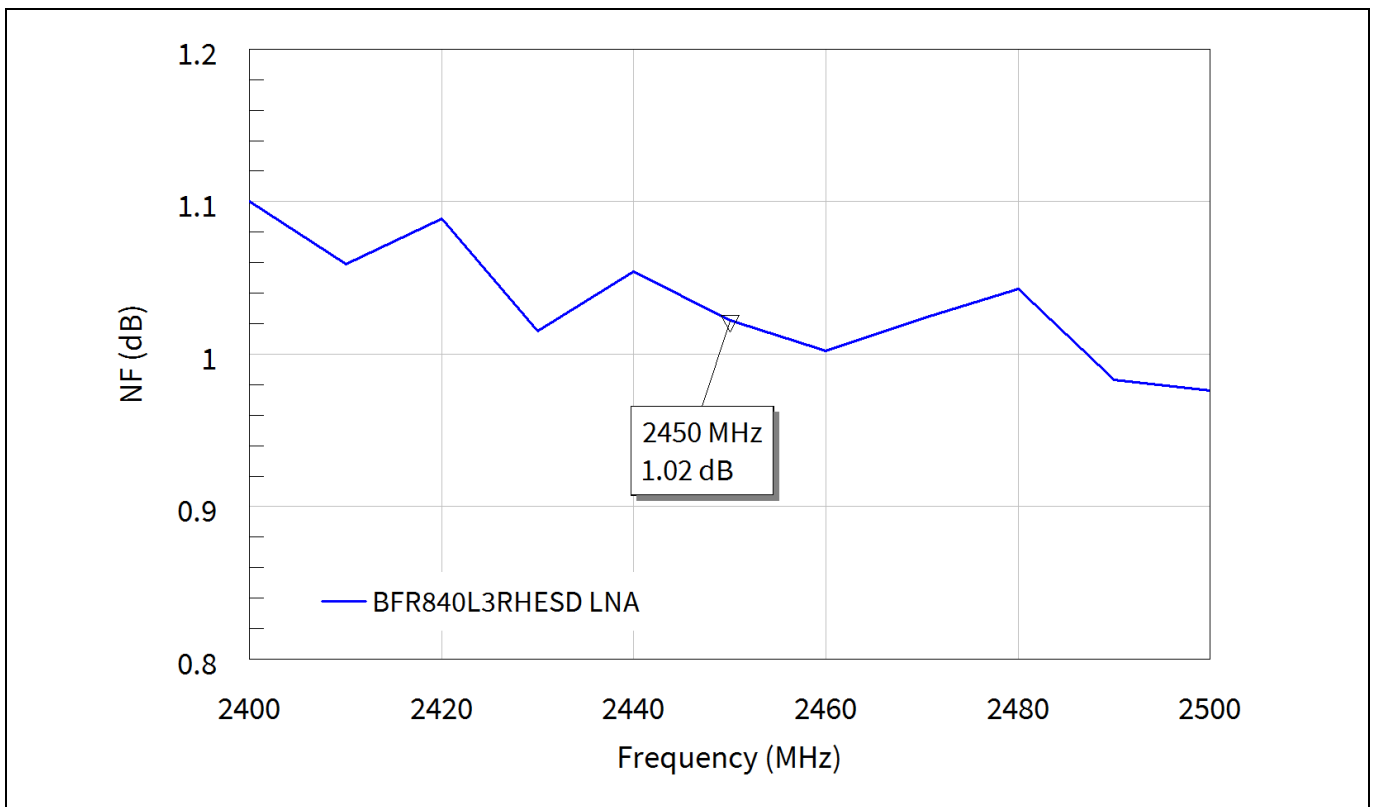


Figure 39 NF measurement of the 2.4 GHz band WLAN LNA with [BFR840L3RHESD](#)

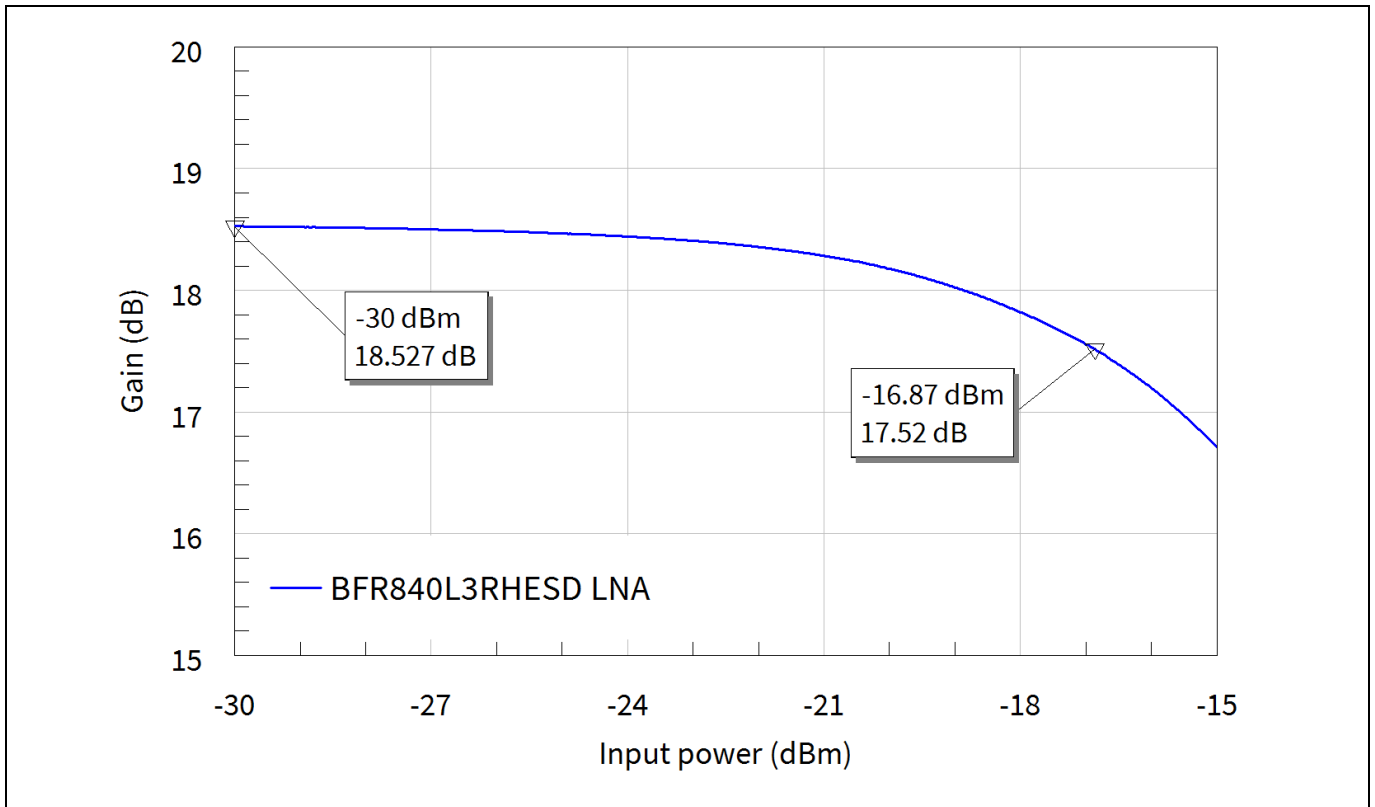


Figure 40 Input 1 dB compression point measurement of the 2.4 GHz band WLAN LNA with [BFR840L3RHESD](#)

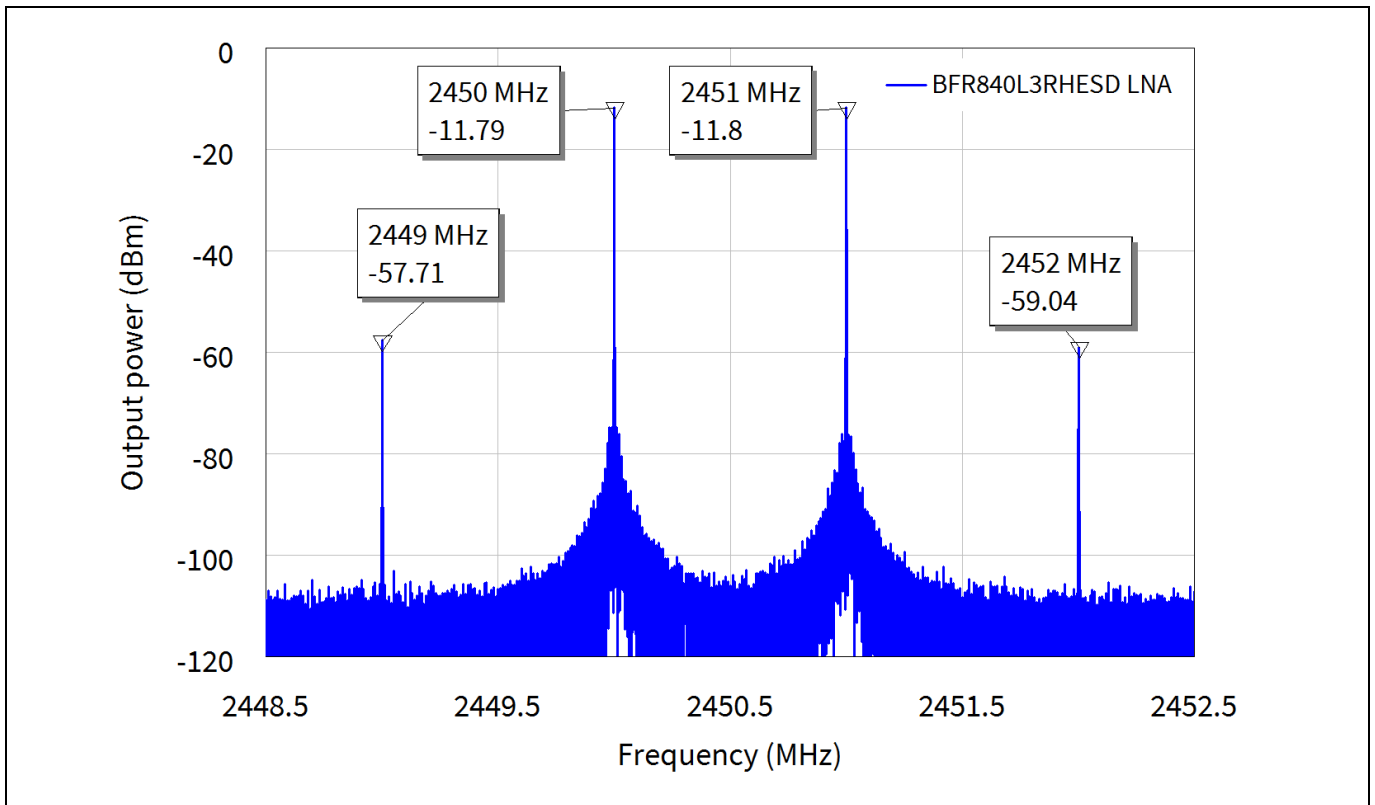


Figure 41 Output IMD_3 measurement of the 2.4 GHz band WLAN LNA with [BFR840L3RHESD](#)

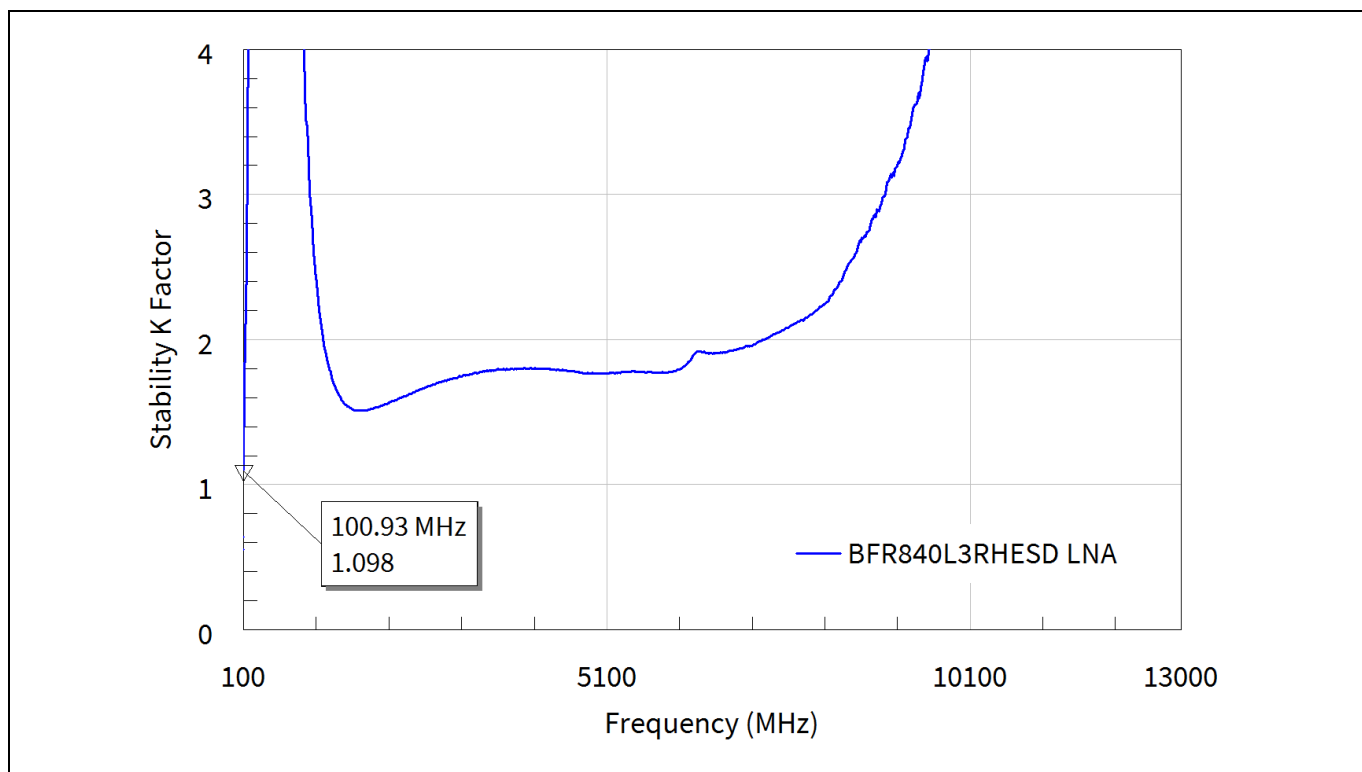


Figure 42 Stability K-factor plots of the 2.4 GHz band WLAN LNA with [BFR840L3RHESD](#)

2.4 2.4 GHz band WLAN LNA with low-noise MMIC [BGB707L7ESD](#)

2.4.1 Performance overview

The following table shows the performance of the 2.4 GHz band WLAN LNA with low-noise MMIC [BGB707L7ESD](#).

Table 7 Summary of measurement results for the 2.4 GHz band WLAN LNA with low-noise MMIC [BGB707L7ESD](#)

| Parameter | Symbol | Value | Unit | Notes |
|------------------------------------|-------------|-----------------------------|------|--|
| Device | | BGB707L7ESD | | |
| Bias voltage | V_{CC} | 3.0 | V | |
| Bias current | I_{CC} | 6.0 | mA | |
| Frequency | f | 2.45 | GHz | |
| Gain | G | 15.6 | dB | |
| NF | NF | 1.2 | dB | PCB and SMA connector losses subtracted: 0.1 dB. |
| Input return loss | RL_{in} | 15.9 | dB | |
| Output return loss | RL_{out} | 10.2 | dB | |
| Reverse isolation | ISO_{rev} | 25.1 | dB | |
| Output 1 dB compression point | OP_{1dB} | 6.3 | dBm | |
| Output third-order intercept point | OIP_3 | 10.3 | dBm | Input power: -30 dBm per tone, Tone 1: 2450 MHz, Tone 2: 2451 MHz. |
| Stability | K | >1 | | Stability measured from 100 MHz to 13 GHz. |

2.4.2 Schematic

The following figure shows the schematic of the 2.4 GHz band WLAN LNA with low-noise MMIC [BGB707L7ESD](#). In the circuit, the resistor R1 sets up the biasing current. The resistors R2 and R3 stabilize the circuit whose firmness is measured up to 13 GHz. The resistor R4 and the capacitor C5 serve as the negative feedback to improve the input and output impedance matching. The circuit input matching is achieved by the network of capacitors C1, C2 and the inductor L1. The network of L2 and C4 matches the transistor to the output port. The capacitors C2 and C3 serve as the RF bypass.

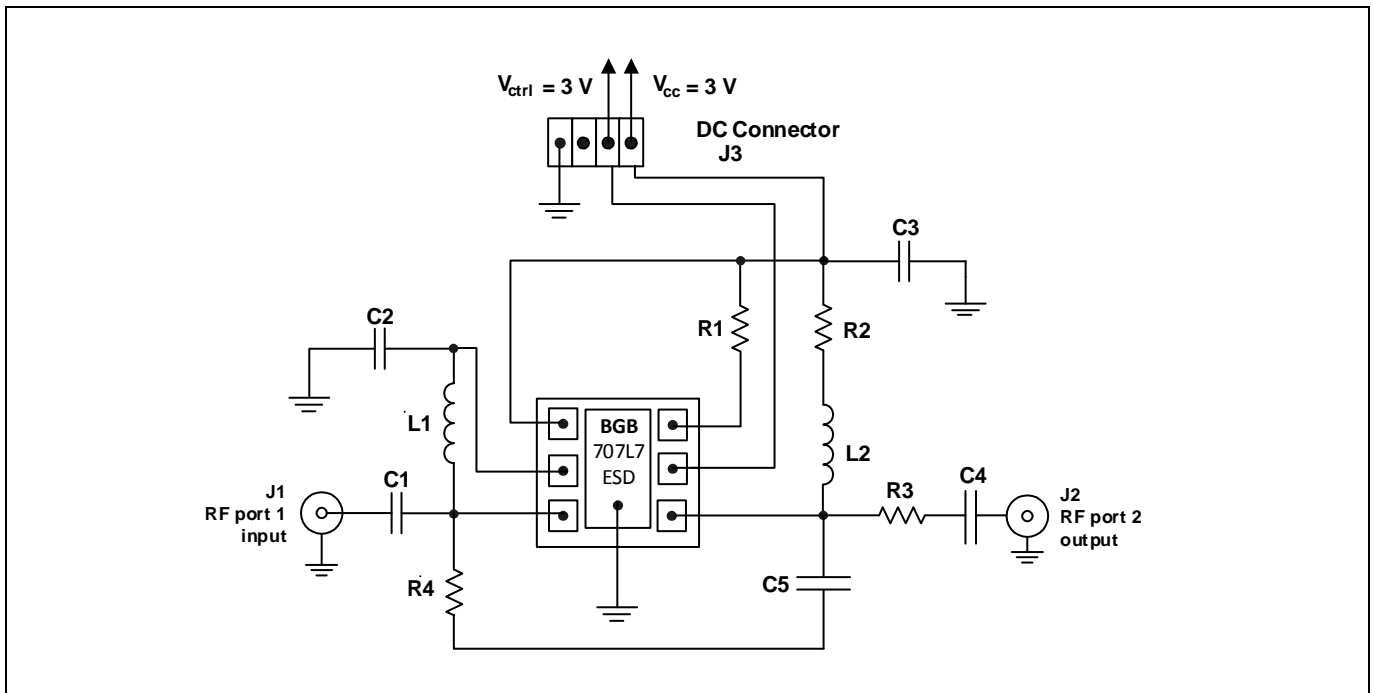


Figure 43 Schematic of the 2.4 GHz band WLAN LNA with low-noise MMIC [BGB707L7ESD](#)

2.4.3 BOM

Table 8 BOM of the 2.4 GHz band WLAN LNA with low noise MMIC [BGB707L7ESD](#)

| Symbol | Value | Unit | Size | Manufacturer | Comment |
|--------|-----------------------------|------|----------|-------------------|---------------------------------|
| Q1 | BGB707L7ESD | | TSLP-7-1 | Infineon | SiGe:C low-noise MMIC |
| C1 | 3.9 | pF | 0402 | Various | Input matching and DC blocking |
| C2 | 39 | pF | 0402 | Various | RF decoupling |
| C3 | 39 | pF | 0402 | Various | RF decoupling |
| C4 | 10 | pF | 0402 | Various | Output matching and DC blocking |
| C5 | 39 | pF | 0402 | Various | DC blocking |
| L1 | 2.9 | nH | 0402 | Murata LQG series | Input matching and RF chock |
| L2 | 40 | nH | 0402 | Murata LQG series | Output matching and RF chock |
| R1 | 2.7 | kΩ | 0402 | Various | Base bias |
| R2 | 0 | Ω | 0402 | Various | Stability improvement |
| R3 | 22 | Ω | 0402 | Various | Stability improvement |
| R4 | 1.5 | kΩ | 0402 | Various | Negative feedback |

2.4.4 Evaluation board and PCB layout information

The evaluation board for the 2.4 GHz band WLAN LNA with low-noise MMIC [BGB707L7ESD](#):

- PCB material: Rogers RO4003C
- PCB marking: M141017

The photo of the evaluation board for the 2.4 GHz band WLAN LNA with low-noise MMIC [BGB707L7ESD](#) and the detailed description of the PCB stack are shown in the following figures.

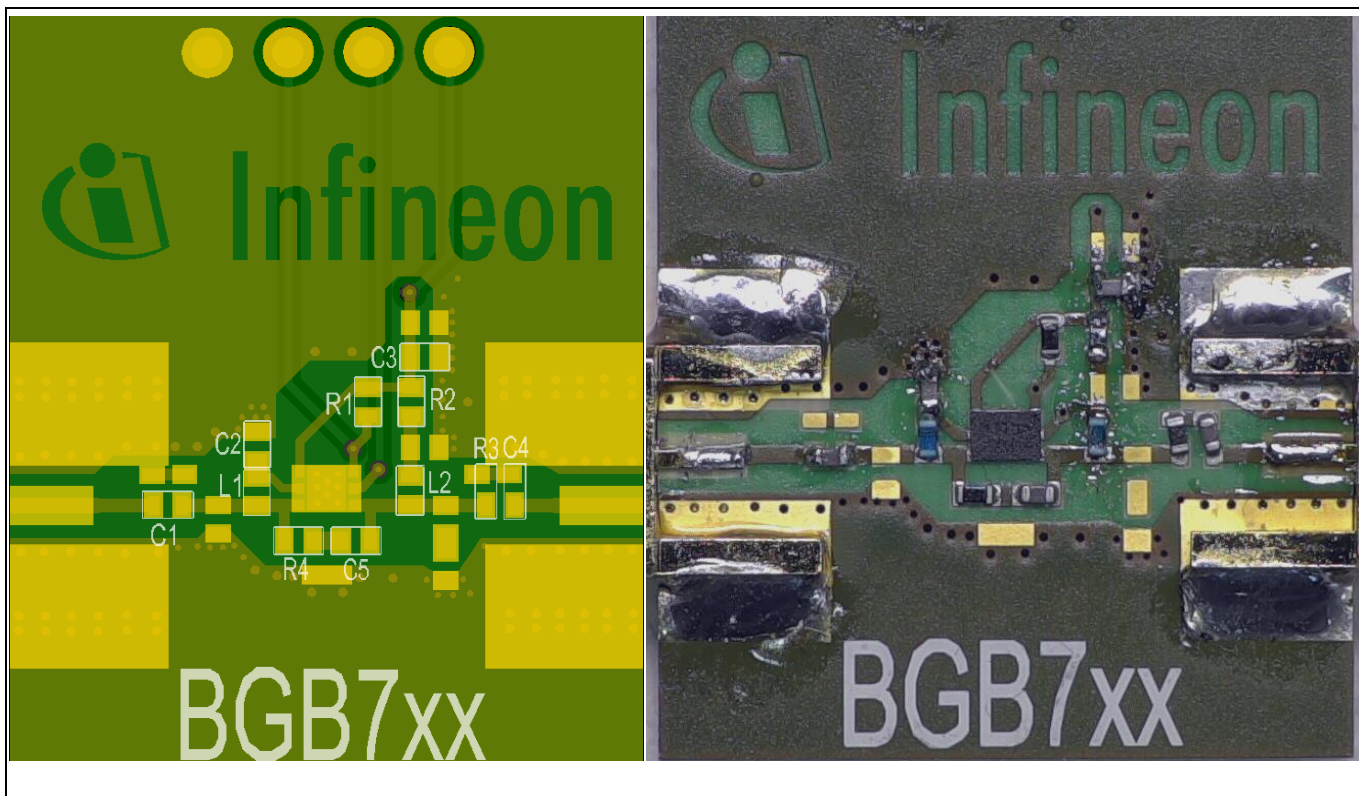


Figure 44 PCB layout with PCB marking M141017 (left) and photo (right)

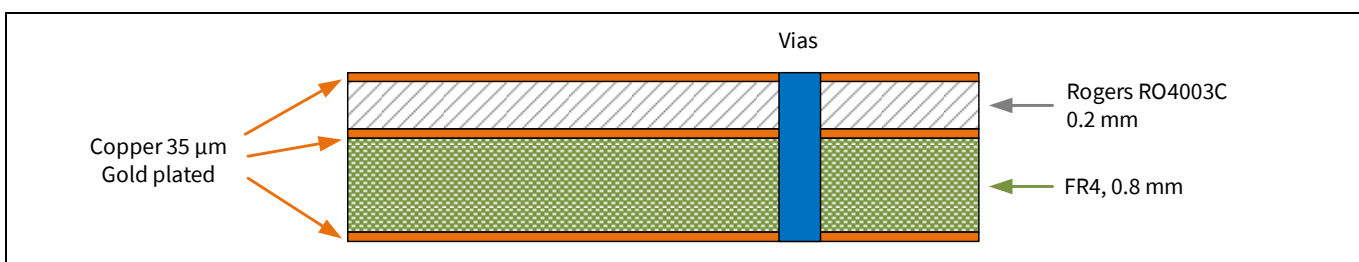


Figure 45 PCB stack information for the evaluation board M141017

2.4.5 Measurement results of the 2.4 GHz band WLAN LNA with low-noise MMIC [BGB707L7ESD](#)

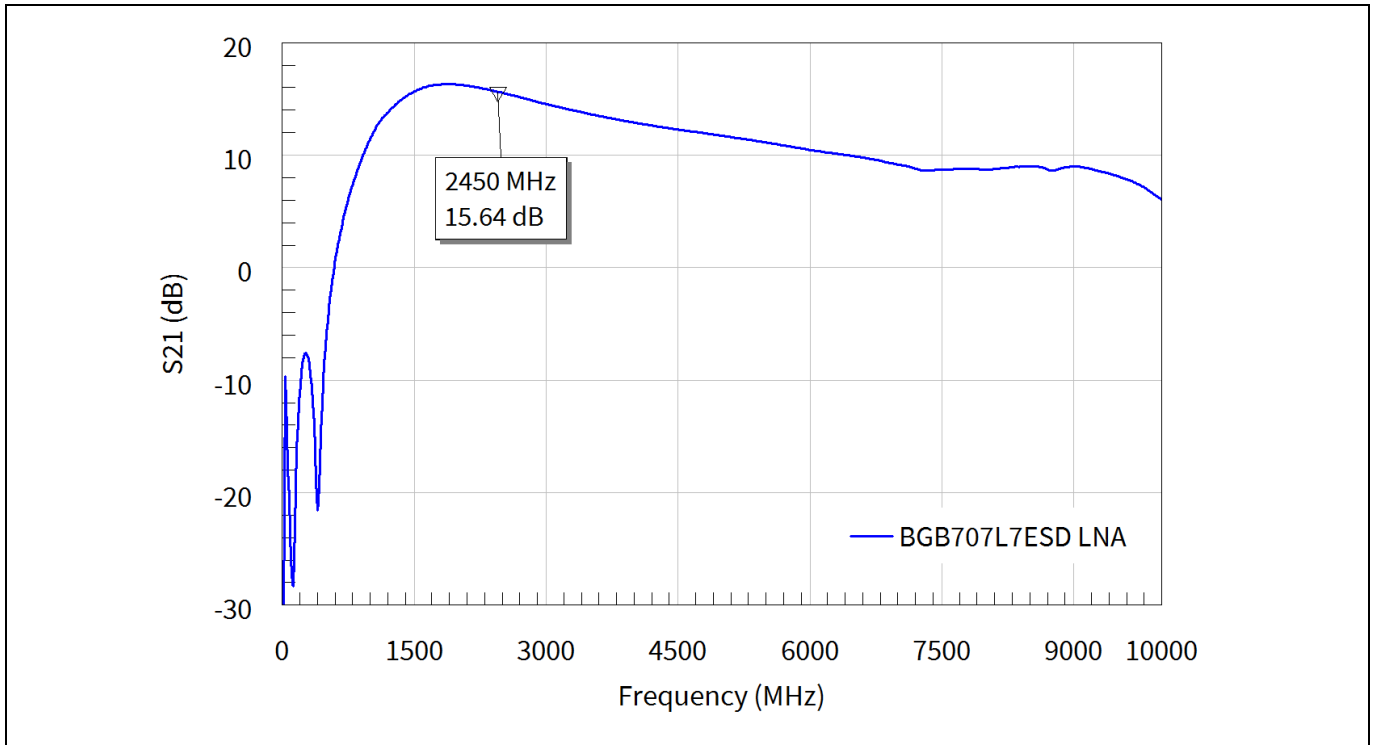


Figure 46 Small signal gain of the 2.4 GHz band WLAN LNA with [BGB707L7ESD](#)

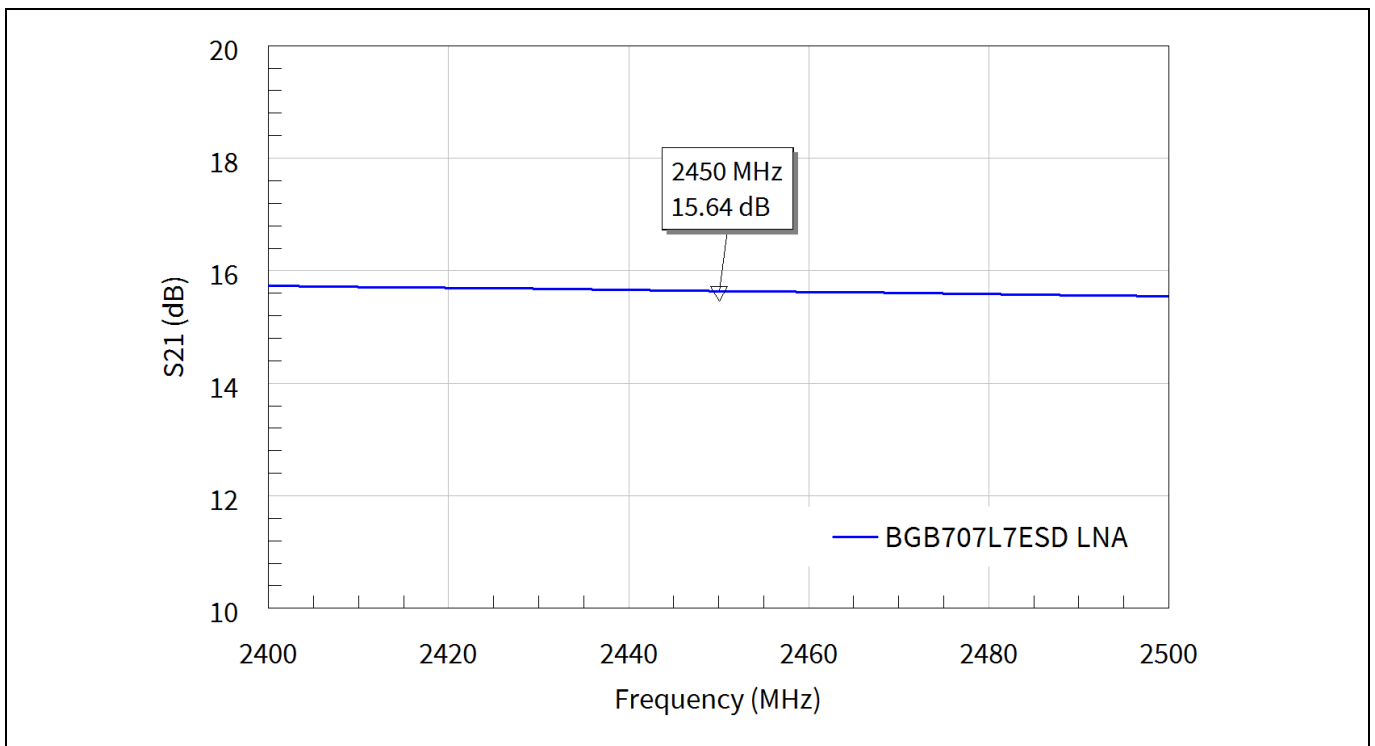


Figure 47 Small signal gain of the 2.4 GHz band WLAN LNA with [BGB707L7ESD](#) (detail view)

Note: The graphs are generated with the AWR EDA software Microwave Office®.

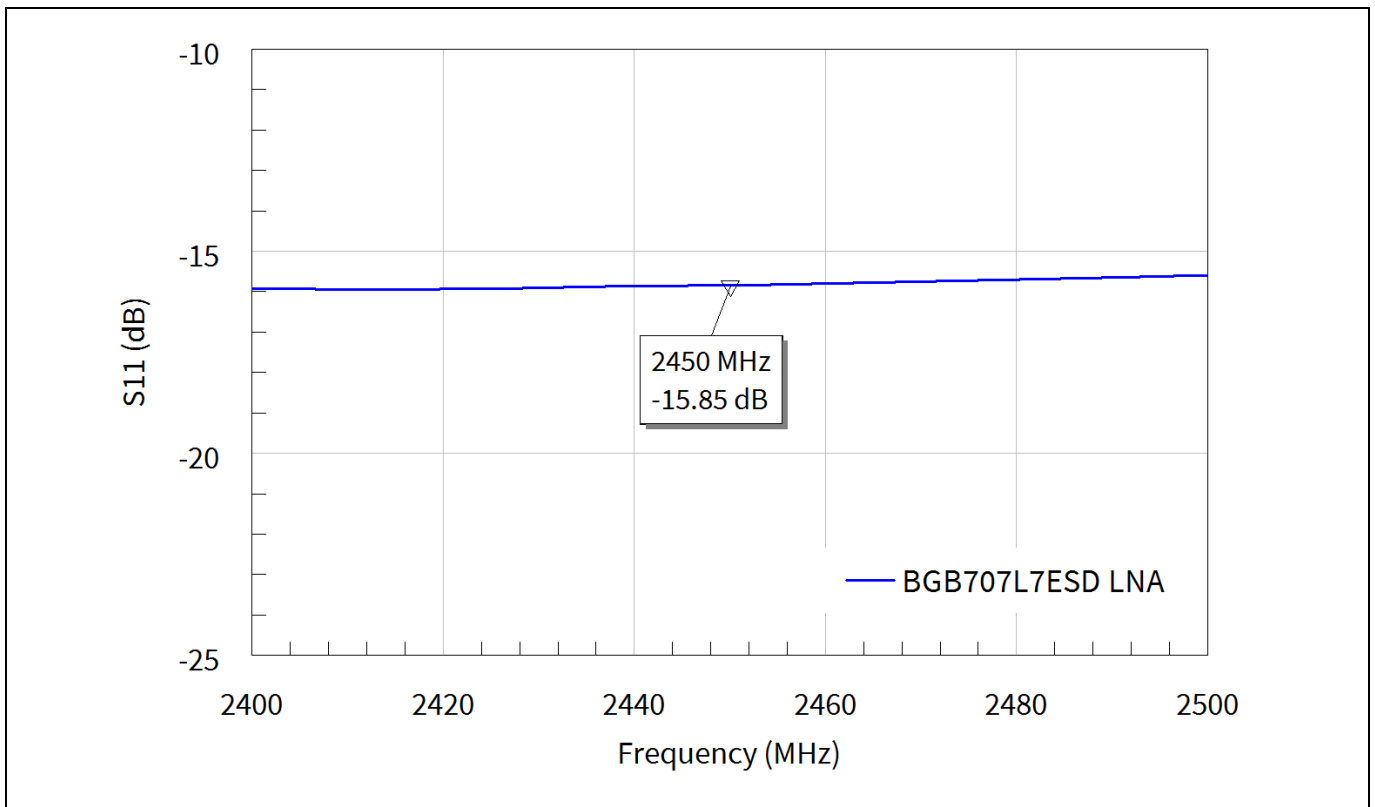


Figure 48 Input return loss measurement of the 2.4 GHz band WLAN LNA with [BGB707L7ESD](#)

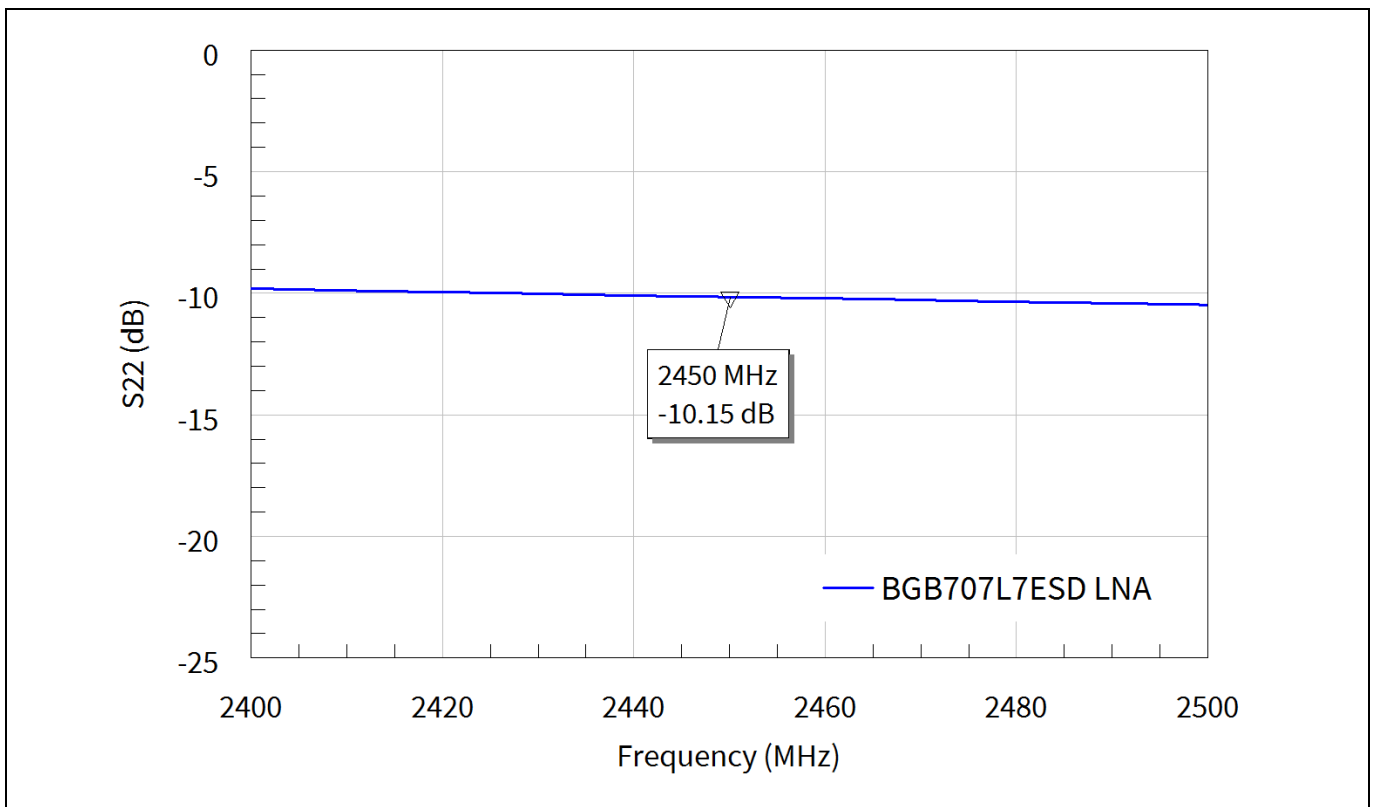


Figure 49 Output return loss measurement of the 2.4 GHz band WLAN LNA with [BGB707L7ESD](#)

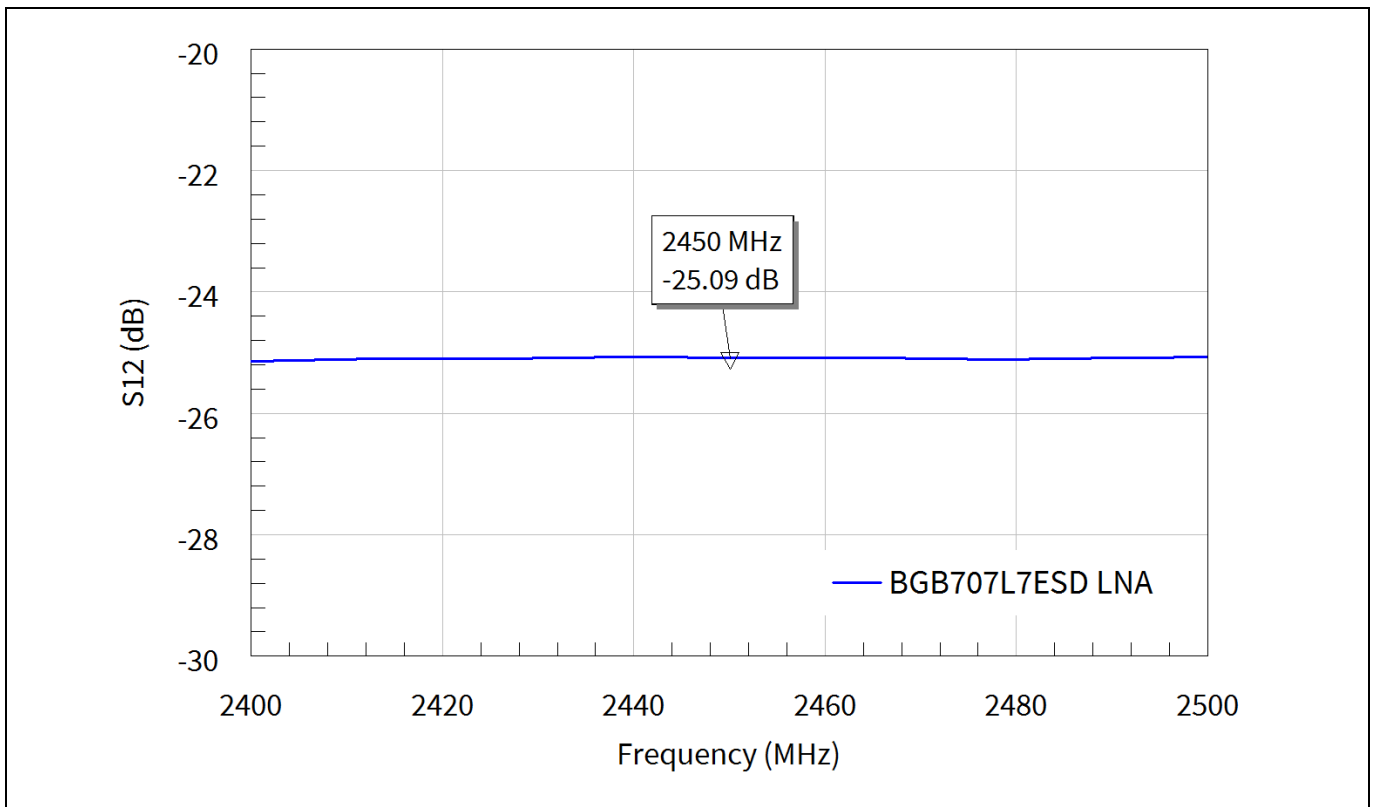


Figure 50 Reverse isolation measurement of the 2.4 GHz band WLAN LNA with [BGB707L7ESD](#)

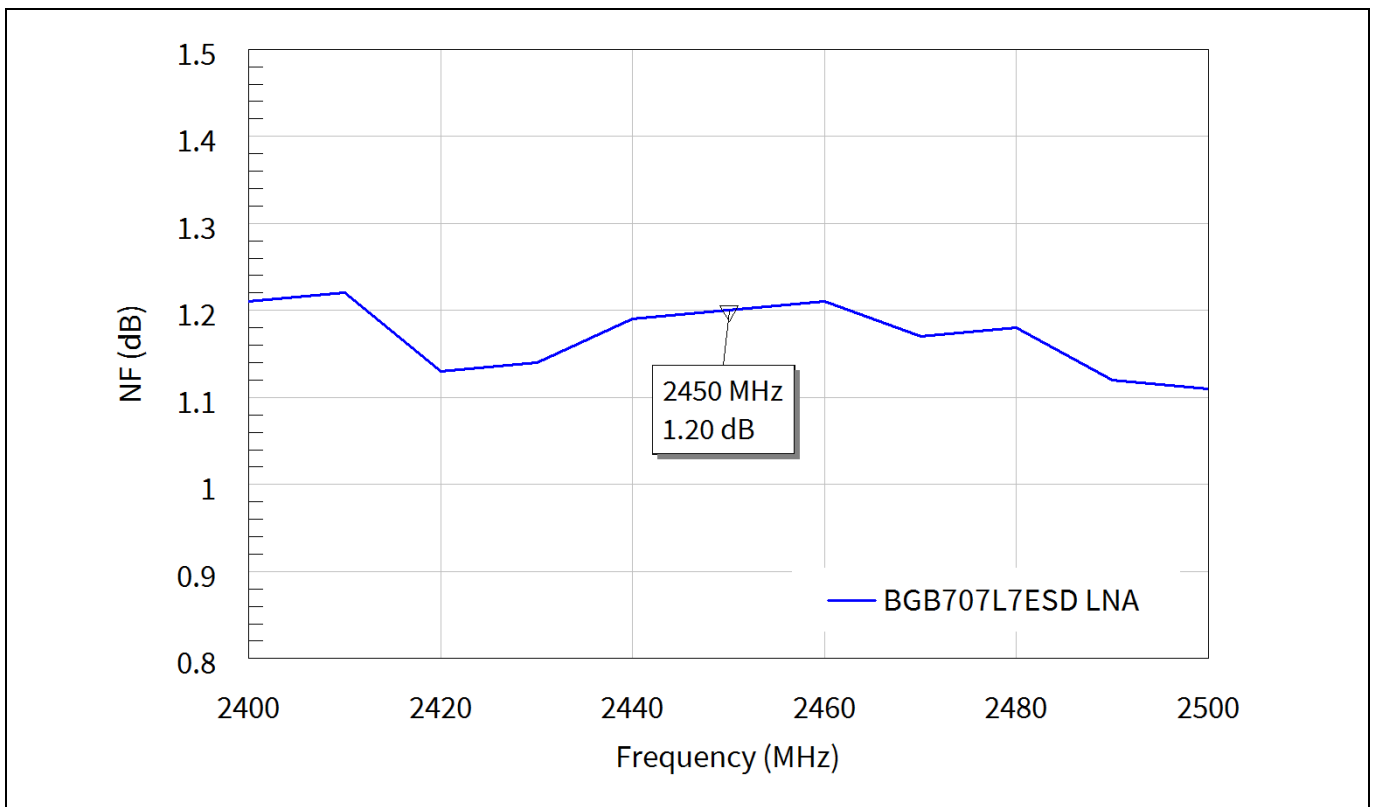


Figure 51 NF measurement of the 2.4 GHz band WLAN LNA with [BGB707L7ESD](#)

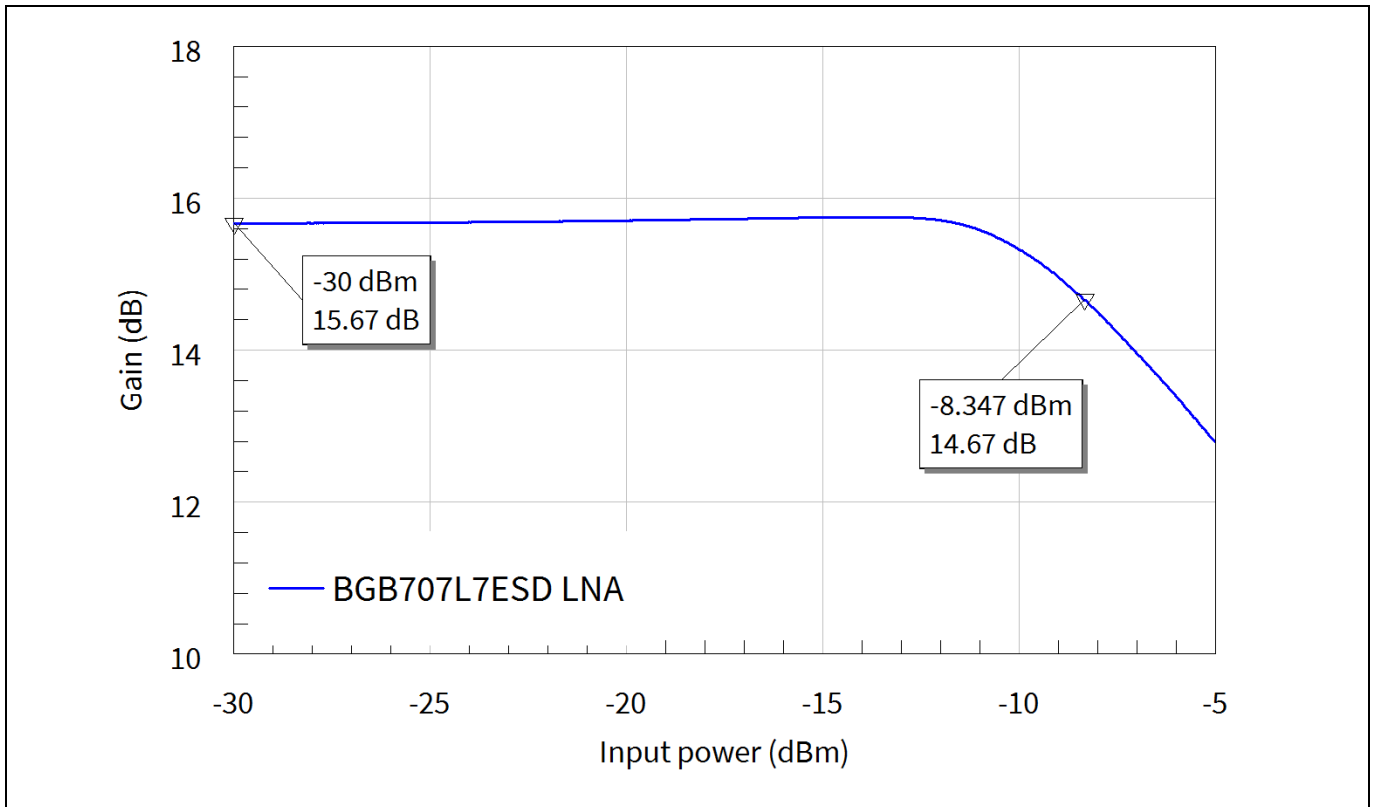


Figure 52 Input 1 dB compression point measurement of the 2.4 GHz band WLAN LNA with [BGB707L7ESD](#)

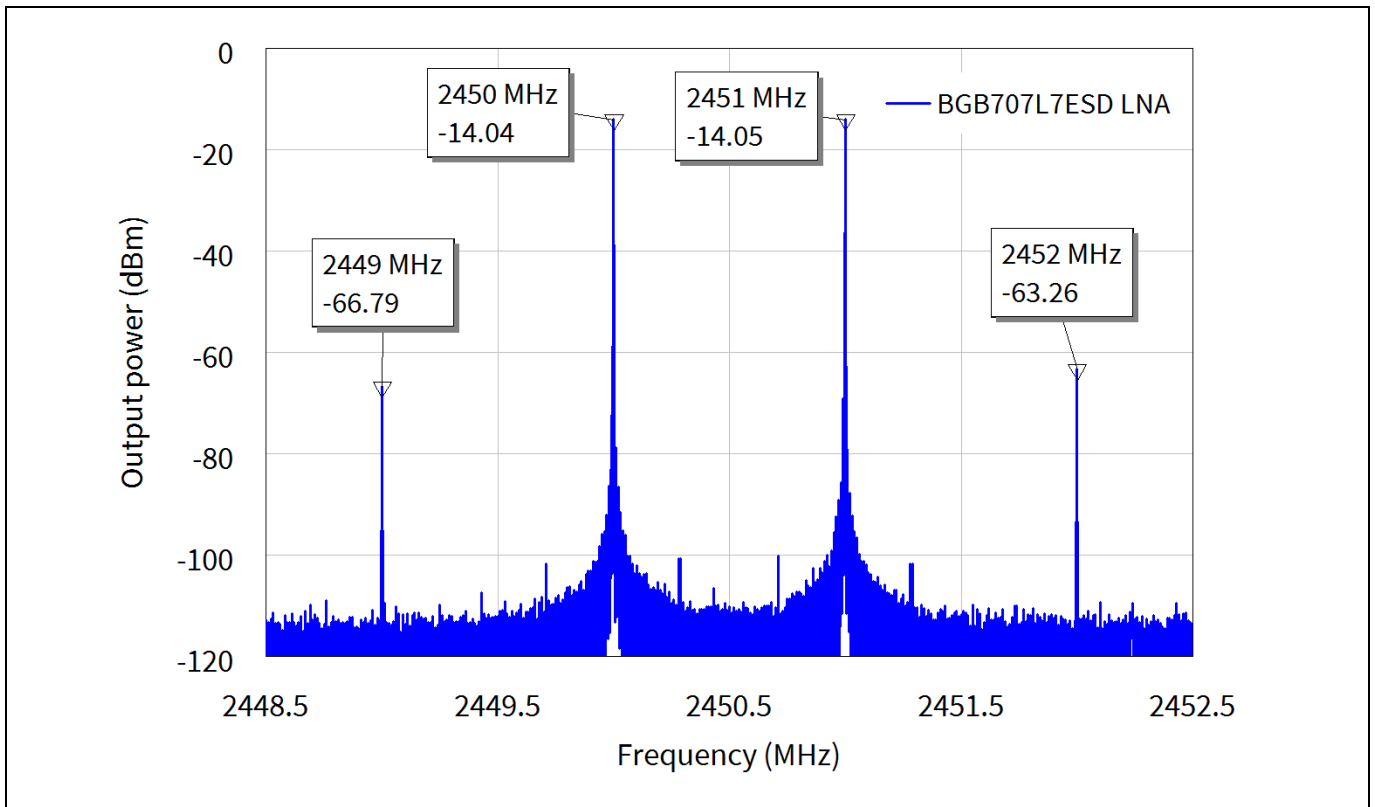


Figure 53 Output IMD_3 measurement of the 2.4 GHz band WLAN LNA with [BGB707L7ESD](#)

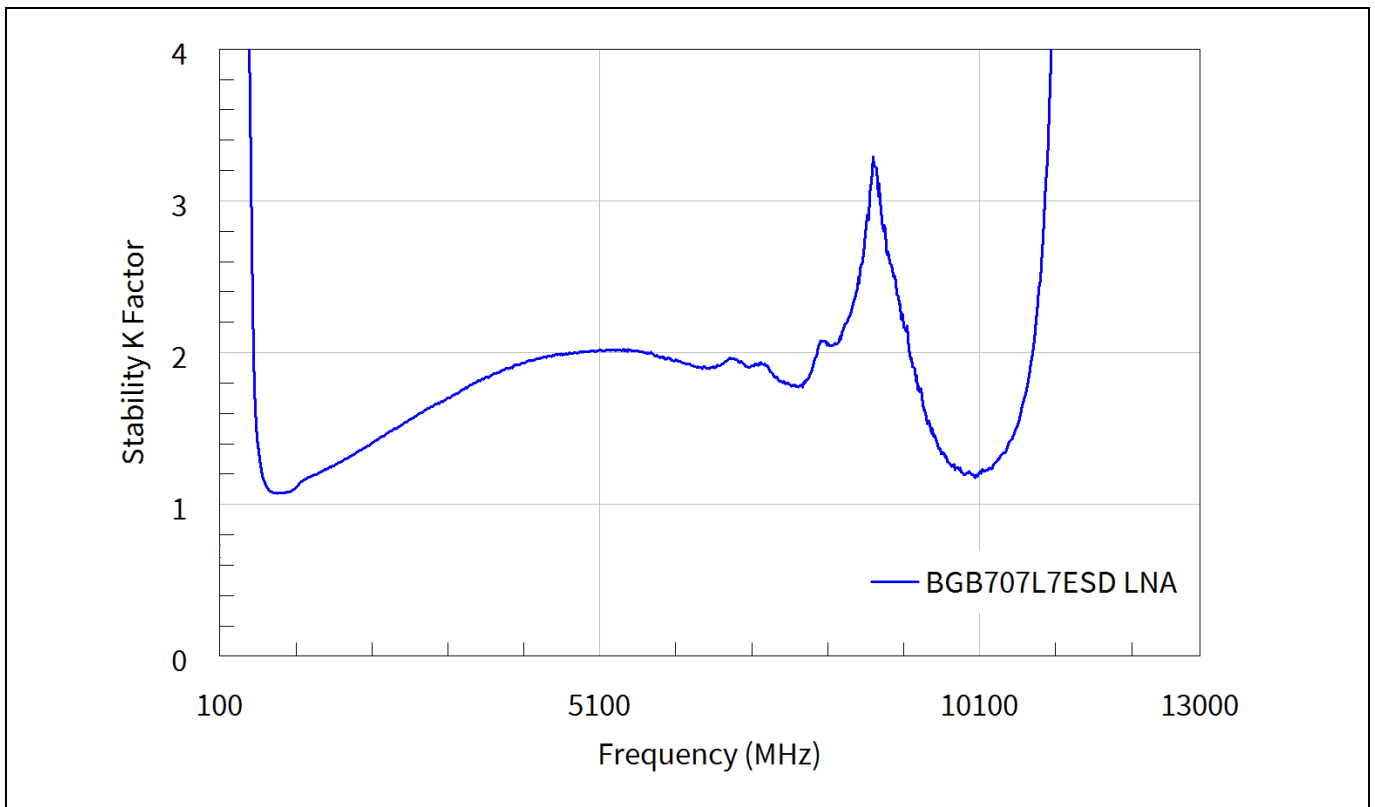


Figure 54 Stability K-factor plots of the 2.4 GHz band WLAN LNA with [BGB707L7ESD](#)

3 5 to 6 GHz band WLAN LNA application circuits

3.1 Performance overview

The following table shows the performance of the 5 to 6 GHz band WLAN LNAs.

Table 9 Summary of measurement results for the 5 to 6 GHz band WLAN LNAs

| Parameter | Symbol | Value | | | | | | Unit | Notes |
|------------------------------------|-------------|---------------------------|------|----------------------------|------|-------------------------------|------|------|--|
| Device | | BFP840ESD | | BFP840FESD | | BFR840L3RHESD | | | |
| Bias voltage | V_{CC} | 3.0 | | 3.0 | | 3.0 | | V | |
| Bias current | I_{CC} | 10.3 | | 14.3 | | 9.2 | | mA | |
| Frequency | f | 5.1 | 5.9 | 5.1 | 5.9 | 5.1 | 5.9 | GHz | |
| Gain | G | 16.3 | 15.3 | 19.2 | 18.0 | 15.0 | 14.1 | dB | |
| NF | NF | 1.07 | 1.04 | 1.01 | 1.02 | 0.99 | 0.98 | dB | PCB and SMA loss subtracted: 0.15 dB |
| Input return loss | RL_{in} | 12.2 | 18.8 | 10.2 | 10.5 | 10.3 | 12.5 | dB | |
| Output return loss | RL_{out} | 17.8 | 15.6 | 11.7 | 12.1 | 11.6 | 13.5 | dB | |
| Reverse isolation | ISO_{rev} | 26.4 | 25 | 26.3 | 25.7 | 21.6 | 20.2 | dB | |
| Output 1 dB compression point | OP_{1dB} | 4.9 | | 7.4 | | 4.9 | | dBm | Measured at 5.5 GHz |
| Output third-order intercept point | OIP_3 | 16.4 | | 18.6 | | 16.4 | | dBm | Input power: -30 dBm per tone Tone 1: 5500 MHz Tone 2: 5501 MHz |
| Stability | K | >1 | | >1 | | >1 | | | Measured from 10 MHz to 10 GHz |

3.2 Schematic

The following figure shows the schematic of the 5 to 6 GHz band WLAN LNAs with Infineon eighth-generation RF low-noise SiGe transistors [BFP840ESD](#), [BFP840FESD](#), and [BFR840L3RHESD](#). The transistors are manufactured in different packages. The parasitic inductances of different transistor packages are slightly different to each other. Hence the emitter degeneration length fabricated on the PCB for the LNA circuits has been selected differently (see section 3.4). In the LNA circuit, resistors R1 and R2 stand for transistor voltage and current bias; meanwhile, they form a negative DC feedback mechanism to stabilize the transistor bias points in various conditions. Capacitors C2 and C3 serve as the RF bypass. Transistor input matching is achieved by C1, L1 and C2. The output matching network is formed by C4, C5, C6, L2, R3 and R4. Resistors R3 and R4 also have the function of improving circuit stability.

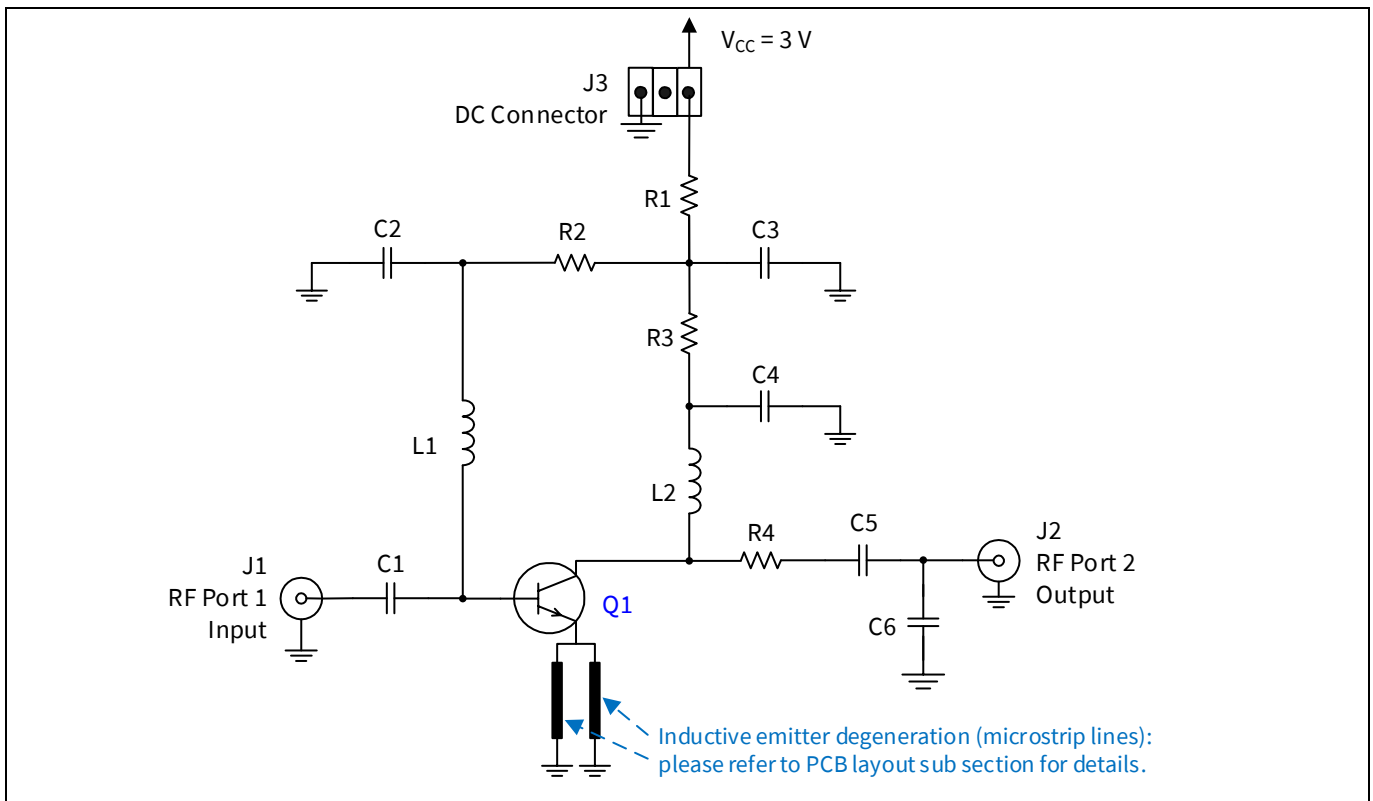


Figure 55 The 5 to 6 GHz band WLAN LNA schematic

3.3 BOM

Table 10 BOM of the 5 to 6 GHz band WLAN LNAs

| Symbol | Value (component package/size) | | | Manu- facturer | Notes |
|--------|---------------------------------------|--|---|-------------------|---|
| | | | | | |
| Q1 | BFP840ESD (SOT343) | BFP840FESD (TSFP-4-1) | BFR840L3RHESD (TSLP-3-9) | Infineon | SiGe:C bipolar low-noise transistor |
| C1 | 3.3 pF (0402) | 22 pF (0402) | 22 pF (0201) | Various | Input matching and DC blocking |
| C2 | 39 pF (0402) | n.c. ¹⁾ | n.c. | Various | RF decoupling |
| C3 | 39 pF (0402) | 33 pF (0402) | 39 pF (0201) | Various | RF decoupling |
| C4 | n.c. | 1.0 pF (0402) | 1.0 pF (0201) | Various | Output matching and stability improvement |
| C5 | 10 pF (0402) | 1.0 pF (0402) | 18 pF (0201) | Various | Output matching and DC blocking |
| C6 | 0.1 pF (0402) | n.c. | n.c. | Various | High-frequency stability improvement |
| R1 | 82 Ω (0402) | 51 Ω (0402) | 120 Ω (0201) | Various | DC bias and DC negative feedback |

| | | | | | |
|----|----------------------|-------------------------|-------------------------|---------|--|
| R2 | 30 kΩ (0402) | 27 kΩ (0402) | 33 kΩ (0201) | Various | DC biasing for transistor base |
| R3 | 82 Ω (0402) | 51 Ω (0402) | 27 Ω (0201) | Various | Low-frequency stability improvement |
| R4 | 10 Ω (0402) | n.c. | n.c. | Various | Output matching and high-frequency stability improvement |
| L1 | 5.1 nH (LQG/0402) | n.c. | n.c. | Murata | RF choke and input matching |
| L2 | 2.2 nH (LQG/0402) | 1.8 nH (LQP15M/0402) | 3.7 nH (LQP03T/0201) | Murata | RF choke and output matching |

Note: 1) Not connected (n.c.).

3.4 Evaluation boards and layout information

The evaluation boards for the 5 to 6 GHz band WLAN LNAs:

- PCB material: FR4
- PCB marking:
 - [BFP840ESD](#) M130121
 - [BFP840FESD](#) M12051302
 - [BFR840L3RHESD](#) M120131

The photos of the 5 to 6 GHz band WLAN LNAs' evaluation boards and the detailed description of the PCB stack are shown in the following figures.

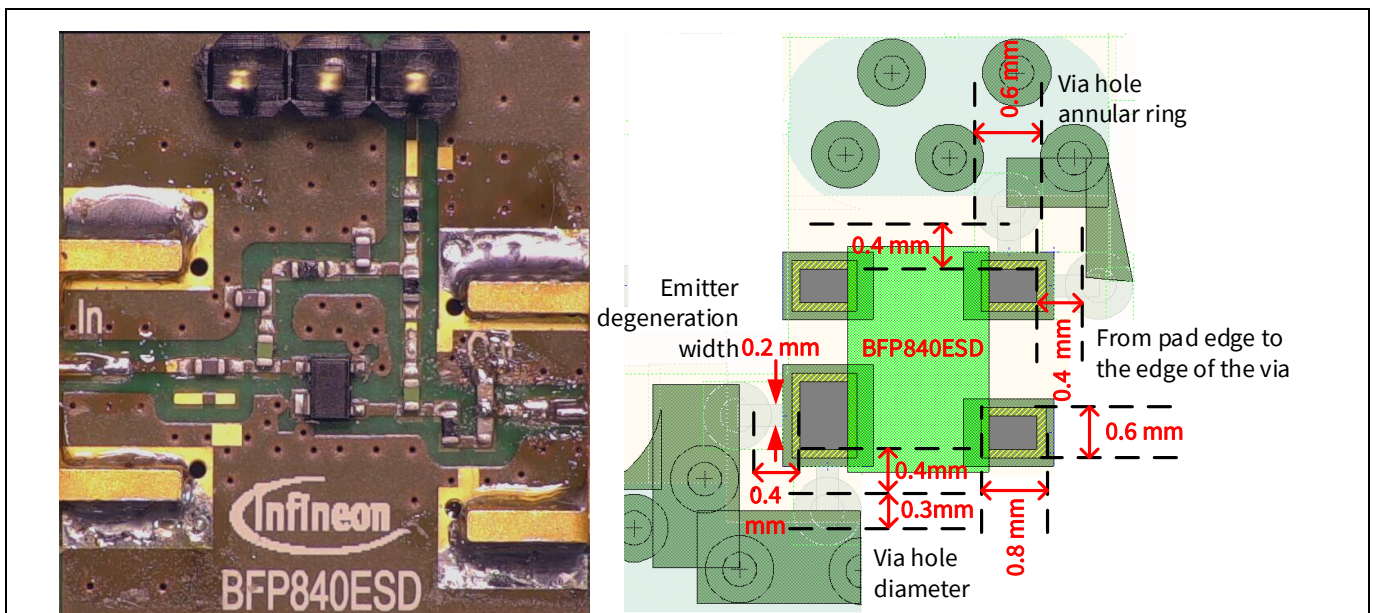


Figure 56 Photo of the evaluation board with marking M130121 (left) and emitter degeneration details (right)

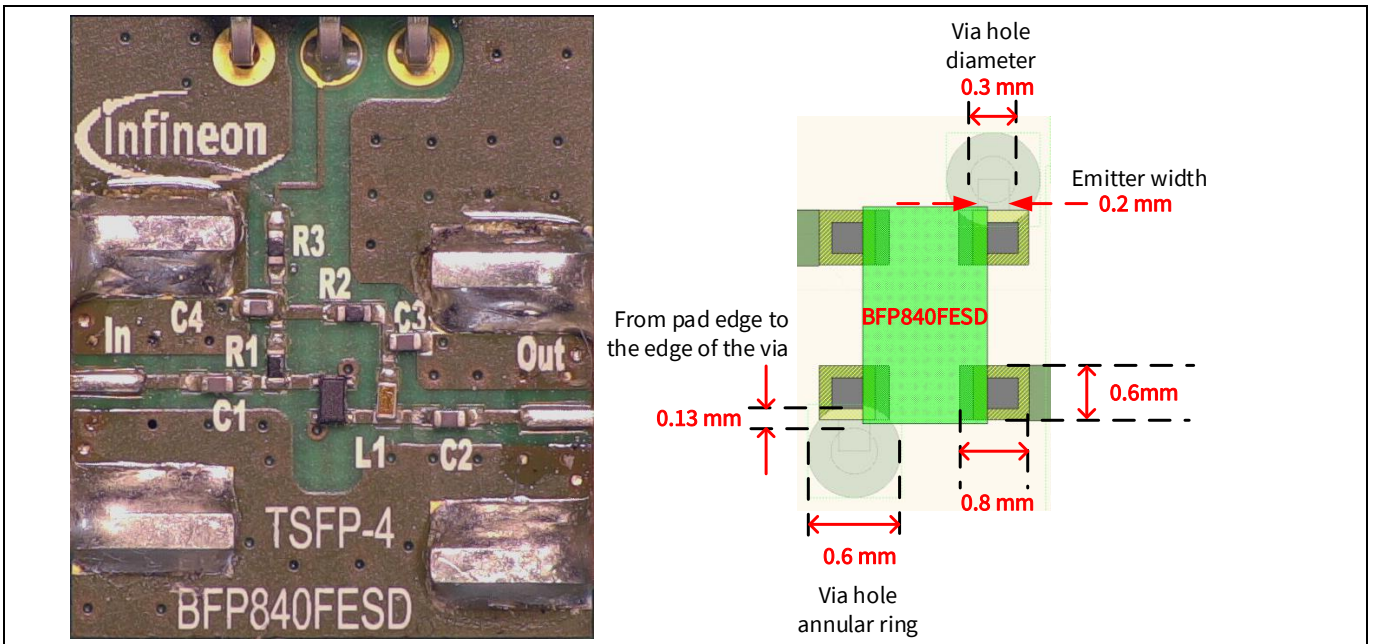


Figure 57 Photo of the evaluation board with marking M12051302 (left) and emitter degeneration details (right)

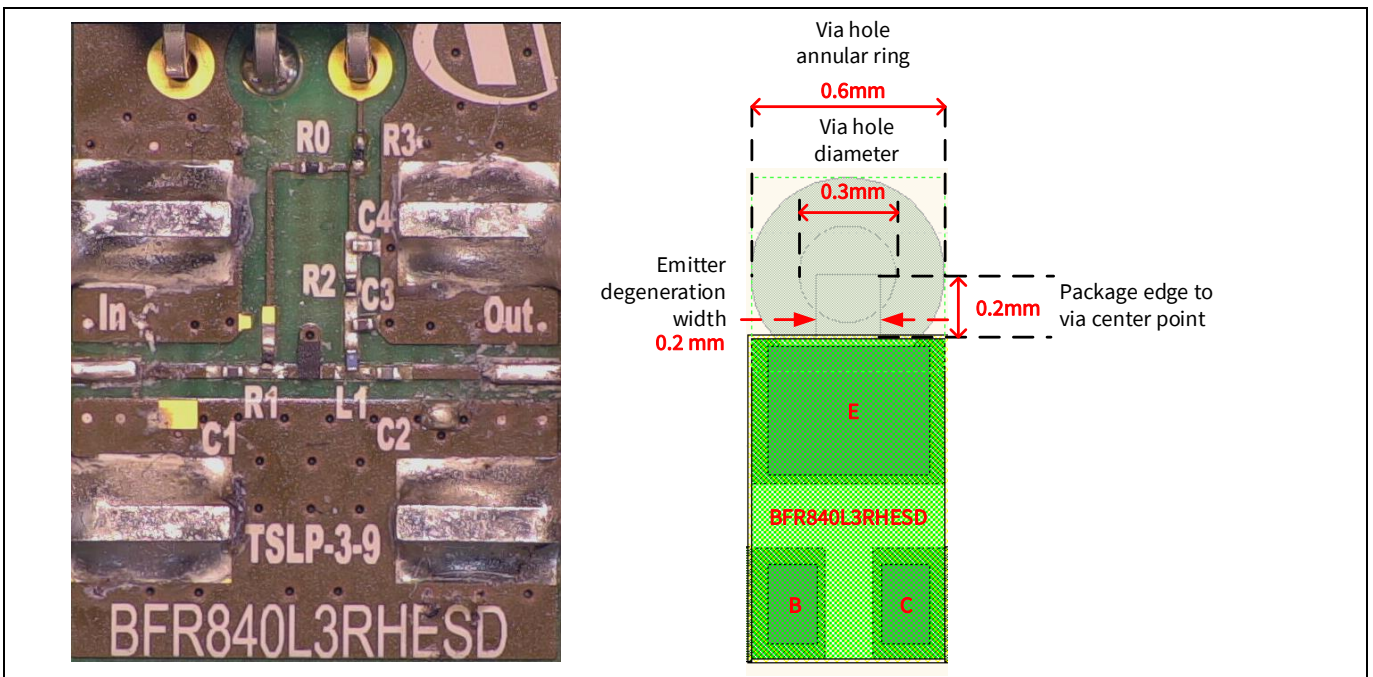


Figure 58 Photo of the evaluation board with marking M120131 (left) and emitter degeneration details (right)

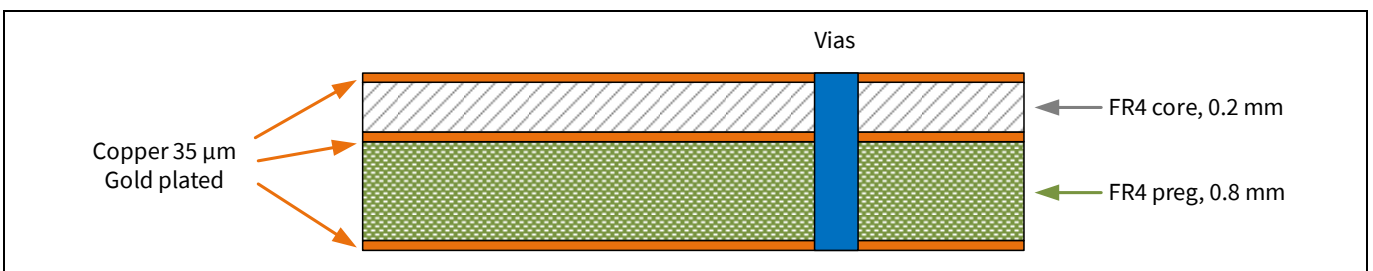


Figure 59 PCB stack information for the evaluation boards with marking M130121, M12051302, and M120131

3.5 Measurement results of the 5 to 6 GHz band WLAN LNAs

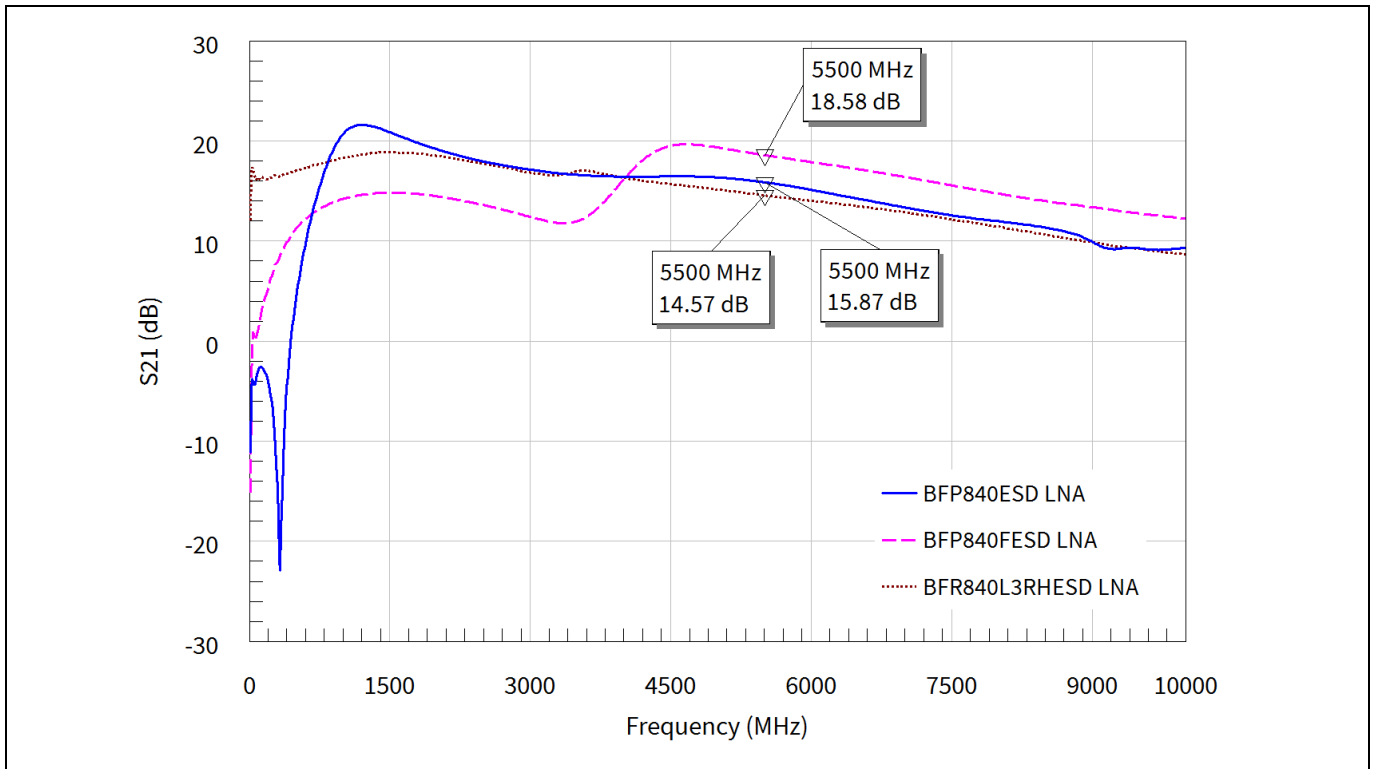


Figure 60 Small signal gain of the 5 to 6 GHz band WLAN LNAs

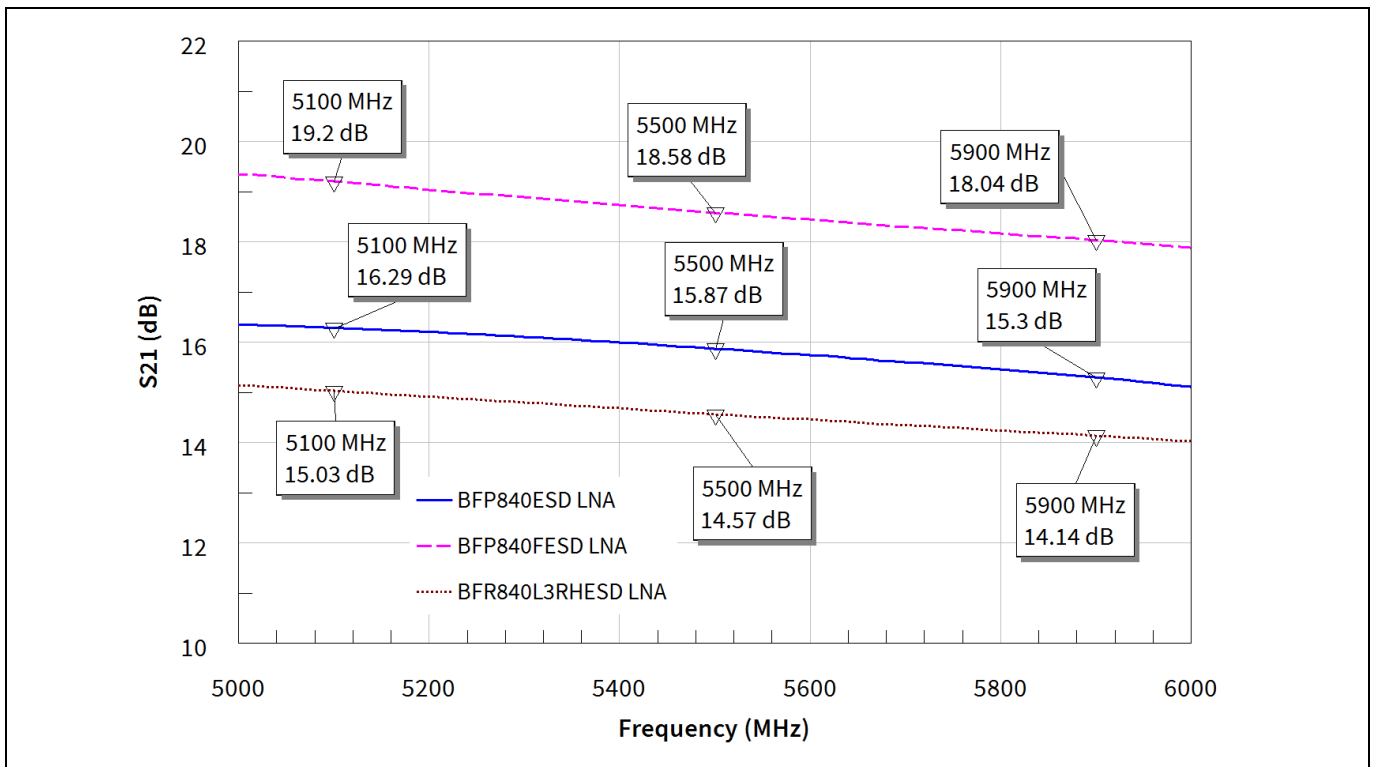


Figure 61 Small signal gain of the 5 to 6 GHz band WLAN LNAs (detail view)

Note: The graphs are generated with the AWR EDA software Microwave Office®.

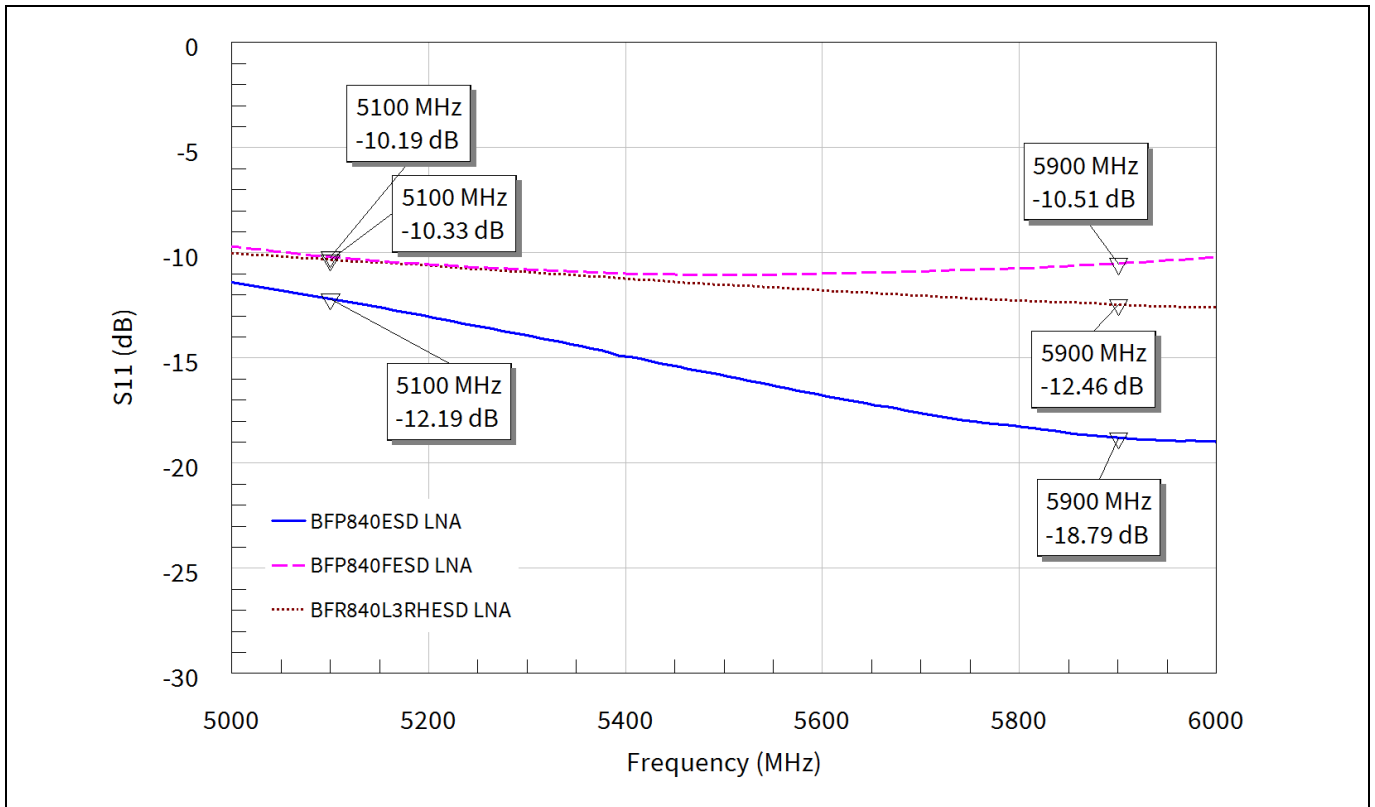


Figure 62 Input return loss measurement of the 5 to 6 GHz band WLAN LNAs

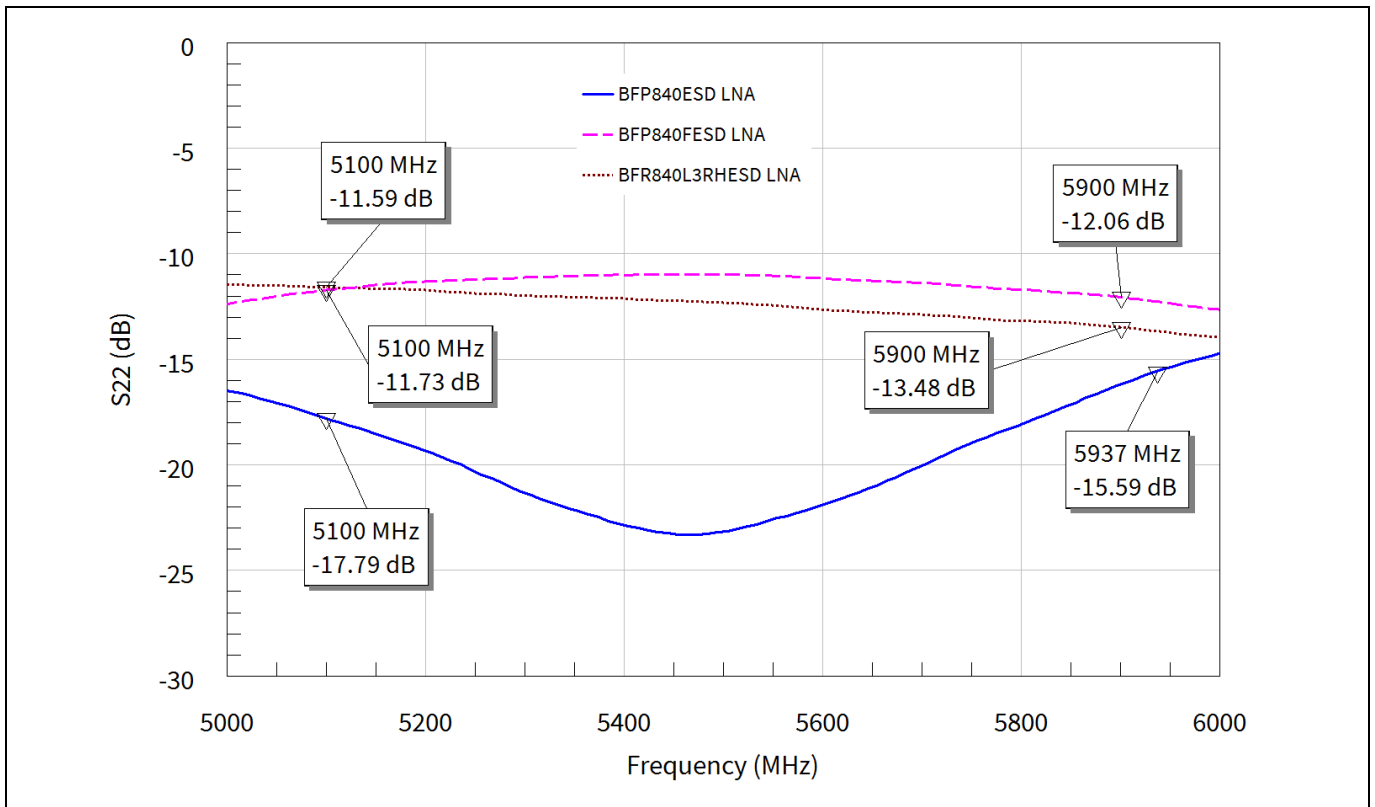


Figure 63 Output return loss measurement of the 5 to 6 GHz band WLAN LNAs

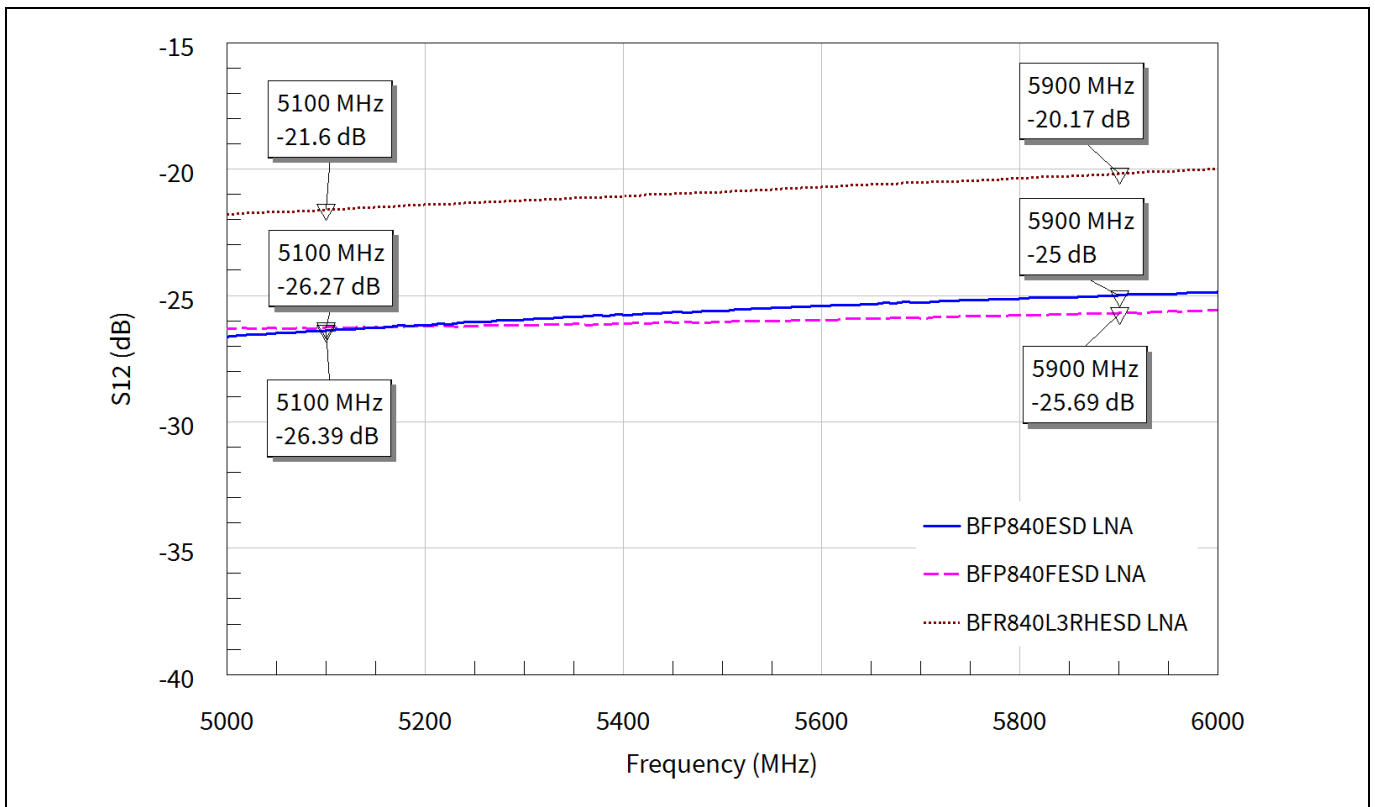


Figure 64 Reverse isolation measurement of the 5 to 6 GHz band WLAN LNAs

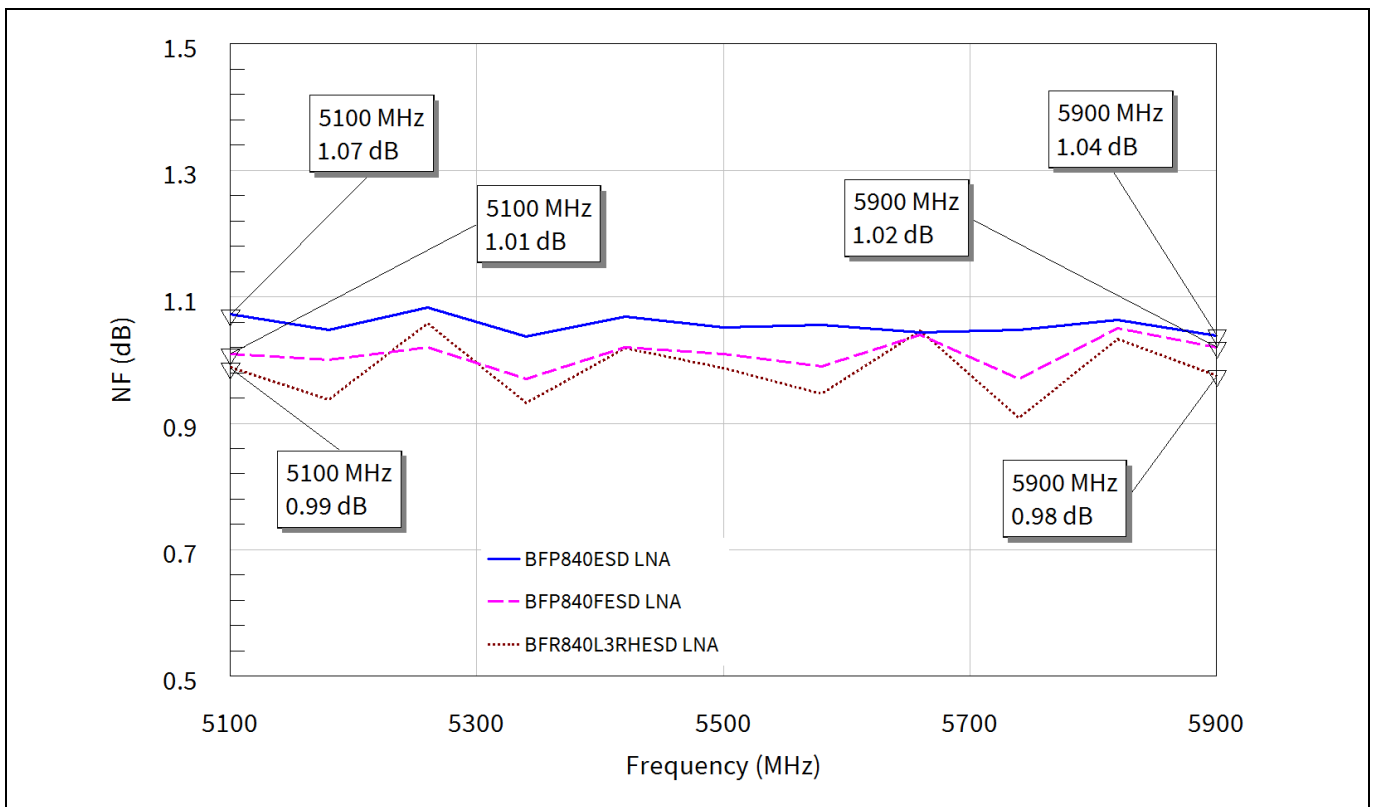


Figure 65 NF measurement of the 5 to 6 GHz band WLAN LNAs

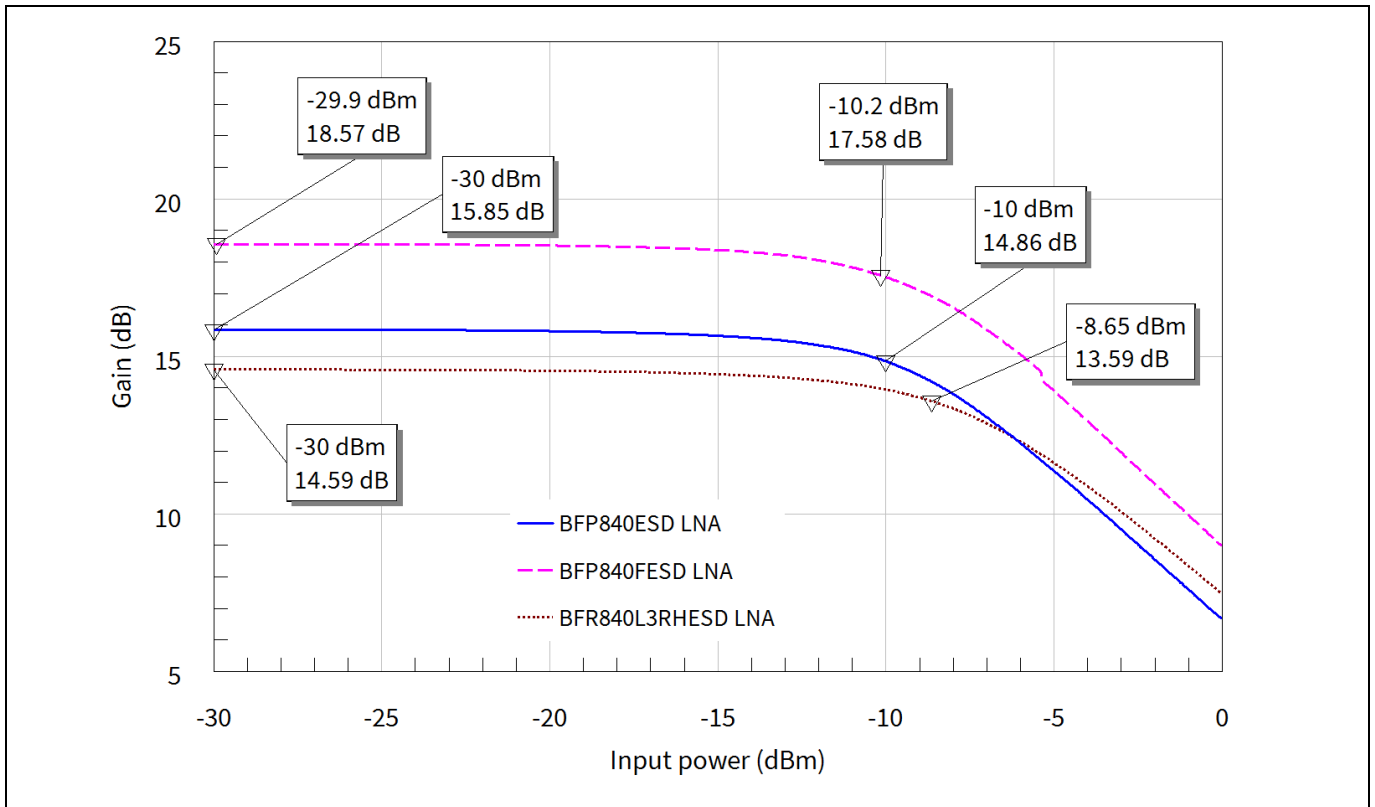


Figure 66 Input 1 dB compression point measurement of the 5 to 6 GHz band WLAN LNAs

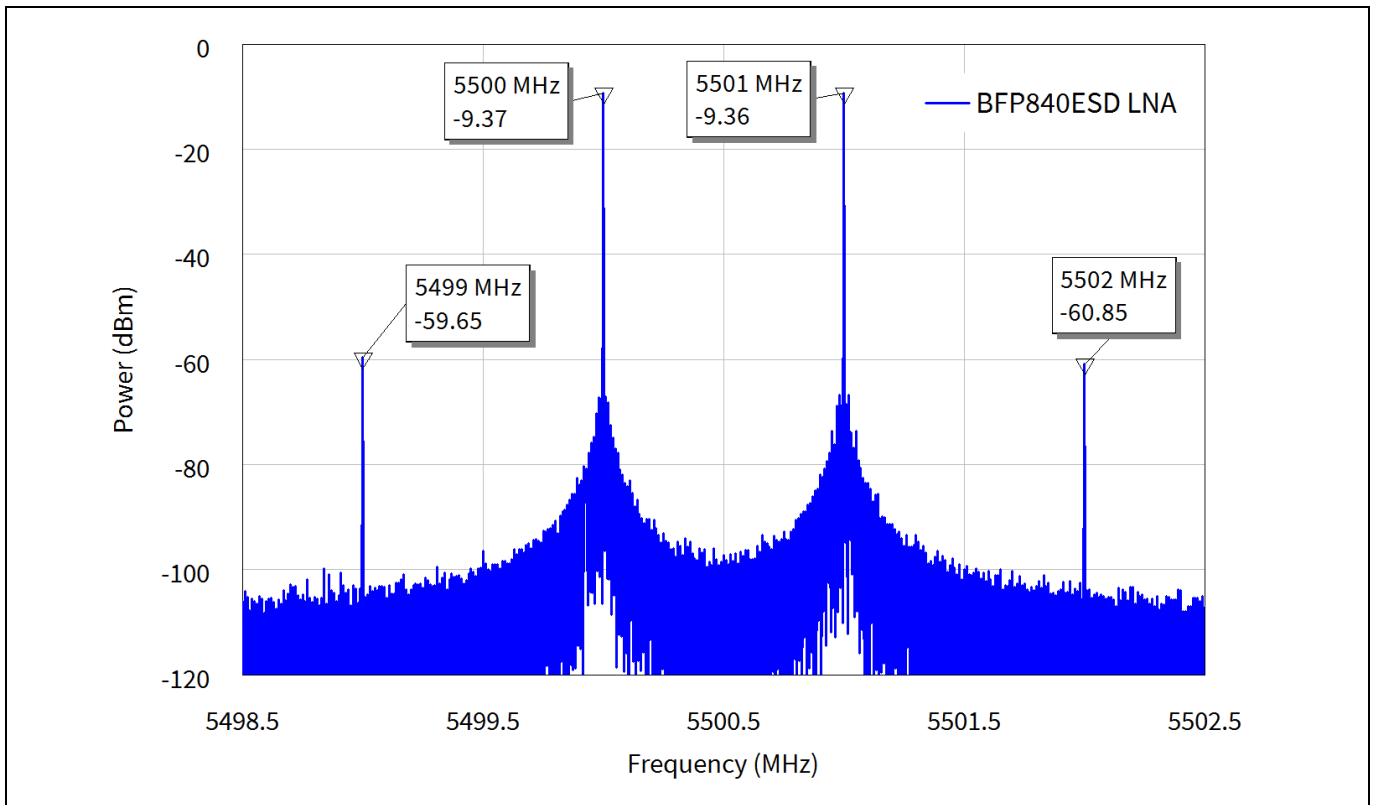


Figure 67 Output IMD_3 measurement of the 5 to 6 GHz band WLAN LNA with [BFP840ESD](#)

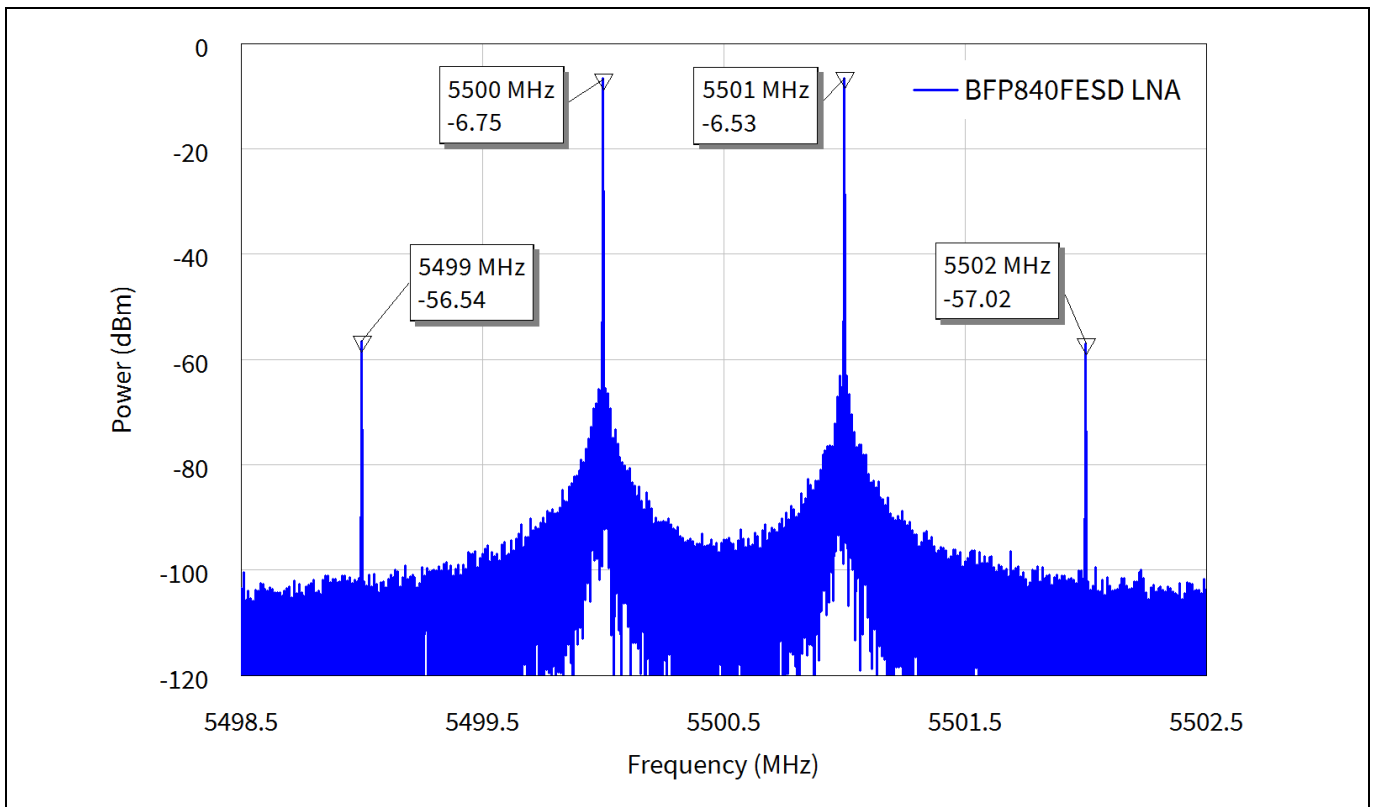


Figure 68 Output IMD₃ measurement of the 5 to 6 GHz band WLAN LNA with [BFP840FESD](#)

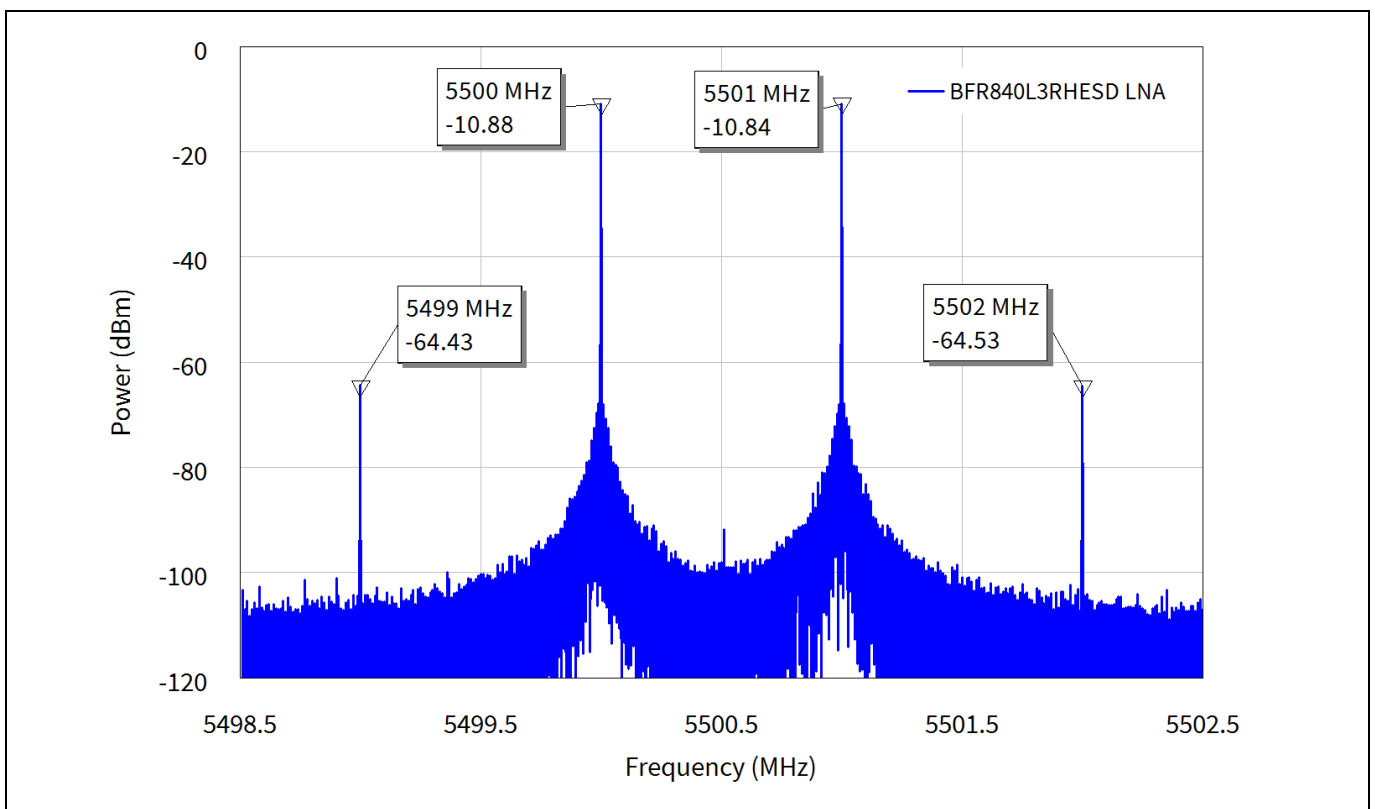


Figure 69 Output IMD₃ measurement of the 5 to 6 GHz band WLAN LNA with [BFR840L3RHESD](#)

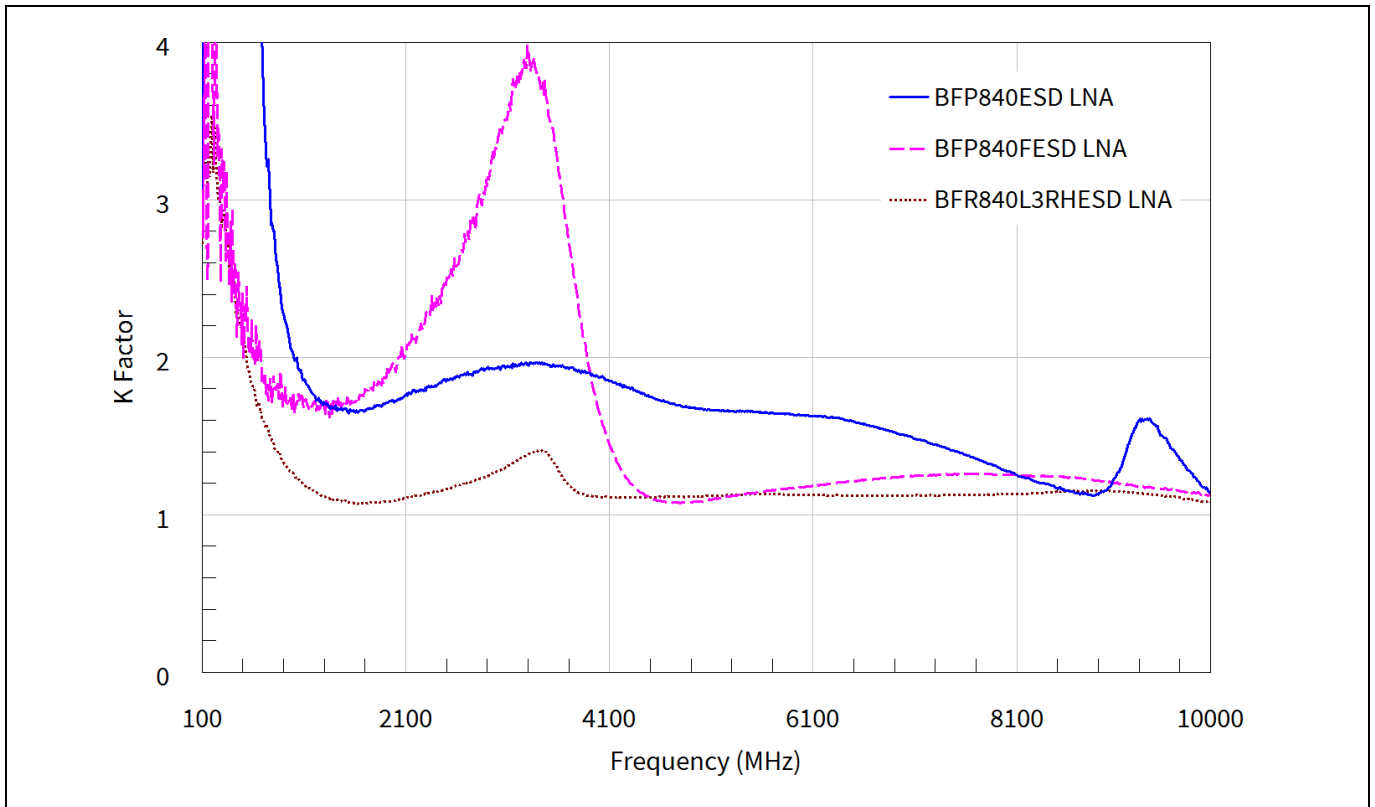


Figure 70 Stability K-factor plots of the 5 to 6 GHz band WLAN LNAs

4 2.4 GHz band WLAN [BFQ790](#) power amplifier application circuit

4.1 Performance overview

The following table shows the performance of the [BFQ790](#) medium-power amplifier at 2.412 GHz.

Table 11 Summary of measurement results for the 2.4 GHz band WLAN PA with [BFQ790](#)

| Parameter | Symbol | Value | Unit | Notes |
|--|----------------|-------|------|---|
| Bias voltage | V_{CC} | 5.0 | V | |
| Quiescent bias current | I_{CQ} | 210 | mA | |
| Gain | G | 14 | dB | |
| Input return loss | RL_{in} | > 10 | dB | |
| Output return loss | RL_{out} | > 10 | dB | |
| Reverse Isolation | ISO_{rev} | 26.9 | dB | |
| Output 1-dB compression point | OP_{1dB} | 26.7 | dBm | |
| Output third-order intercept point | OIP_3 | 39 | dBm | Output power: 15 dBm per tone Tone 1: 2411.5 MHz Tone 2: 2412.5 MHz |
| Second harmonic | H_2 | < -66 | dBm | |
| Third harmonic | H_3 | < -66 | dBm | |
| Output power at error vector magnitude (EVM): -30 dB | $P_{out,avg}$ | 18 | dBm | Signal: 802.11 n, VHT20, MCS7, 64QAM |
| Band edge power at 2390 MHz | | < -45 | dBm | |
| Stability factor | μ_1, μ_2 | > 1 | | From 10 MHz up to 6 GHz |

4.2 Schematic

The following figure shows the schematic of the 2.4 GHz band WLAN PA with RF medium-power transistor [BFQ790](#). In the circuit, resistors R1, R2, and R3 stand for transistor base bias for a collector current of around 210 mA; meanwhile, R3 stabilizes the circuit at low frequency. Capacitors C3 and C4 together with inductor L2 form a low-pass structured output-matching circuit to maximize the output power and linearity and suppress the harmonic products. L1 is the RF choke, and the value is also chosen in consideration of the current allowance. Capacitors C1 and C2 build up the input-matching network to boost the gain of the [BFQ790](#) power amplifier. Capacitors C6, C7 and C8 are for the RF bypass.

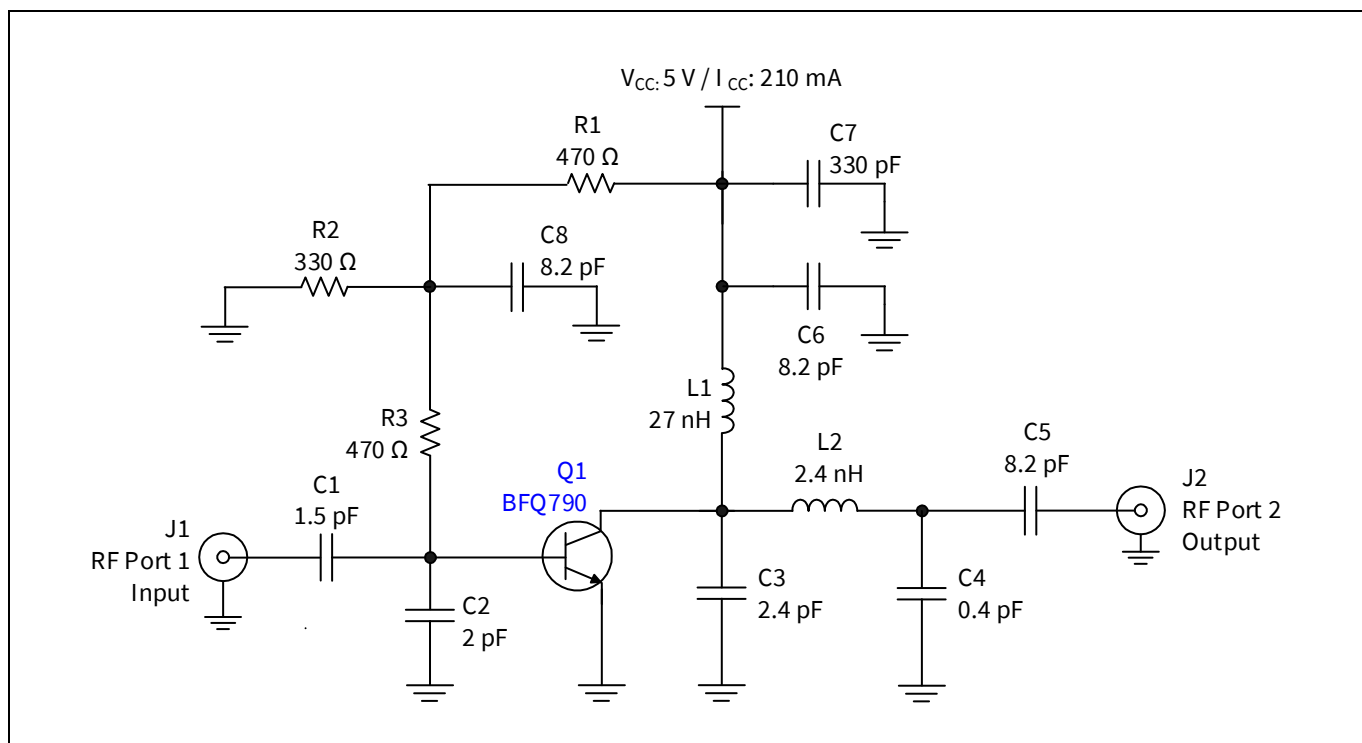


Figure 71 The [BFQ790](#) 2.4 GHz band WLAN power amplifier schematic

4.3 BOM

Table 12 BOM of the [BFQ790](#) 2.4 GHz band WLAN power amplifier

| Symbol | Value | Unit | Package | Manufacturer | Notes |
|--------|------------------------|------|---------|--------------|-----------------------------------|
| Q1 | BFQ790 | | SOT89 | Infineon | SiGe medium-power transistor |
| C1 | 1.5 | pF | 0402 | Various | Input matching and DC blocking |
| C2 | 2 | pF | 0402 | Various | Input matching |
| C3 | 2.4 | pF | 0402 | Various | Output matching |
| C4 | 0.4 | pF | 0402 | Various | Output matching |
| C5 | 8.2 | pF | 0402 | Various | DC blocking |
| C6 | 8.2 | pF | 0402 | Various | RF bypass |
| C7 | 330 | pF | 0402 | Various | RF bypass |
| C8 | 8.2 | pF | 0402 | Various | RF bypass |
| R1 | 470 | Ω | 0402 | Various | DC bias |
| R2 | 330 | Ω | 0402 | Various | DC bias |
| R3 | 470 | Ω | 0402 | Various | DC bias and stability improvement |
| L1 | 10 | nH | 0402 | Murata LQW | RF choke and output matching |
| L2 | 8.2 | nH | 0402 | Murata LQW | Output matching |

4.4 Evaluation board and layout information

The evaluation board for the [BFQ790](#) 2.4 GHz WLAN power amplifier:

- PCB marking: M141008 v1.2_2
- PCB material: FR4

The photo of the [BFQ790](#) 2.4 GHz WLAN power amplifier evaluation board and the detailed description of the PCB stack are shown in the following figures.

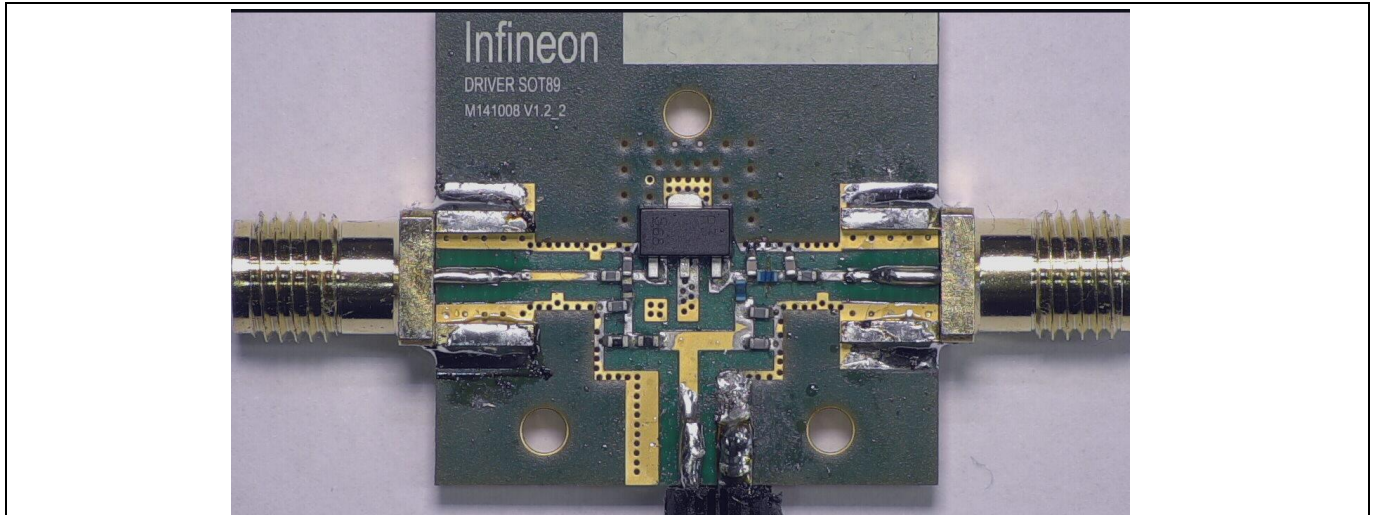


Figure 72 Photo of the [BFQ790](#) 2.4 GHz power amplifier evaluation board for WLAN application

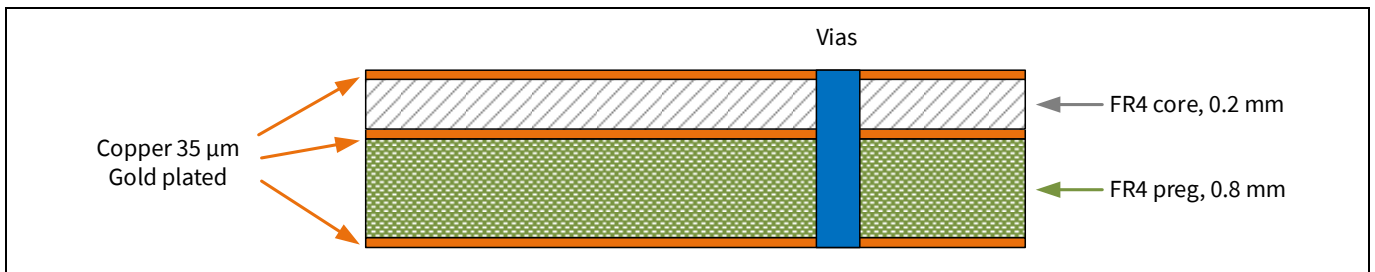


Figure 73 PCB stack information for the evaluation board M141008 v1.2_2

4.5 Measurement results of the [BFQ790](#) 2.4 GHz band WLAN power amplifier

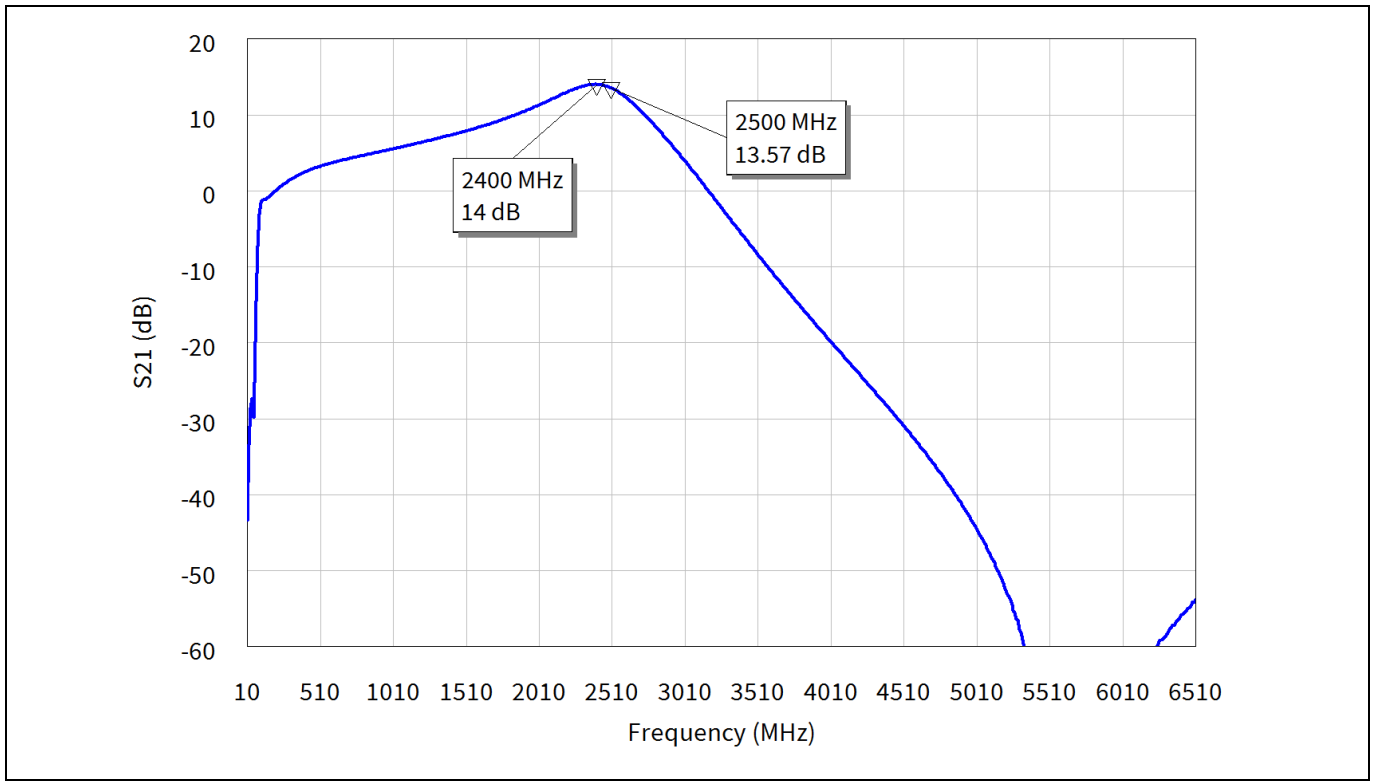


Figure 74 Small signal gain of the [BFQ790](#) 2.4 GHz WLAN power amplifier

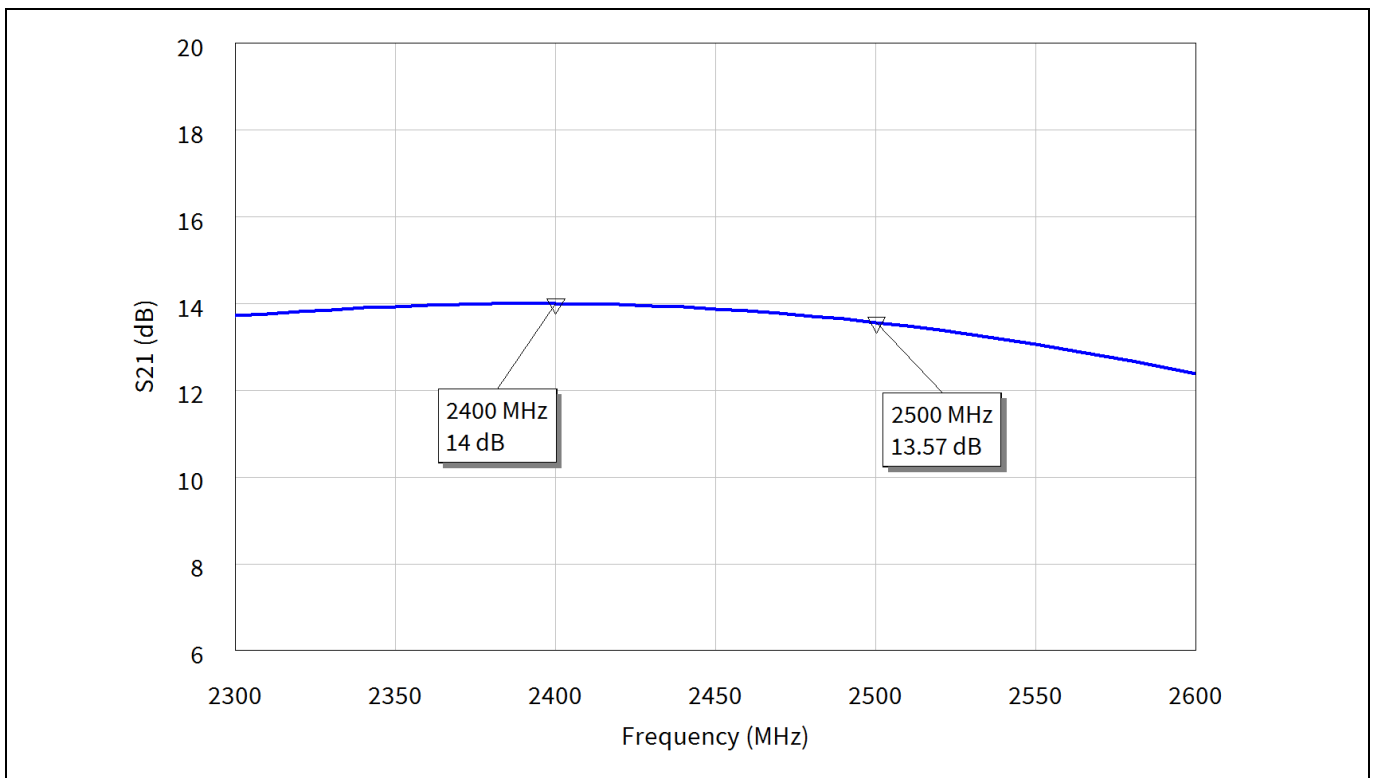


Figure 75 Small signal gain of the [BFQ790](#) 2.4 GHz WLAN power amplifier (detail view)

Note: The graphs are generated with the AWR EDA software Microwave Office®.

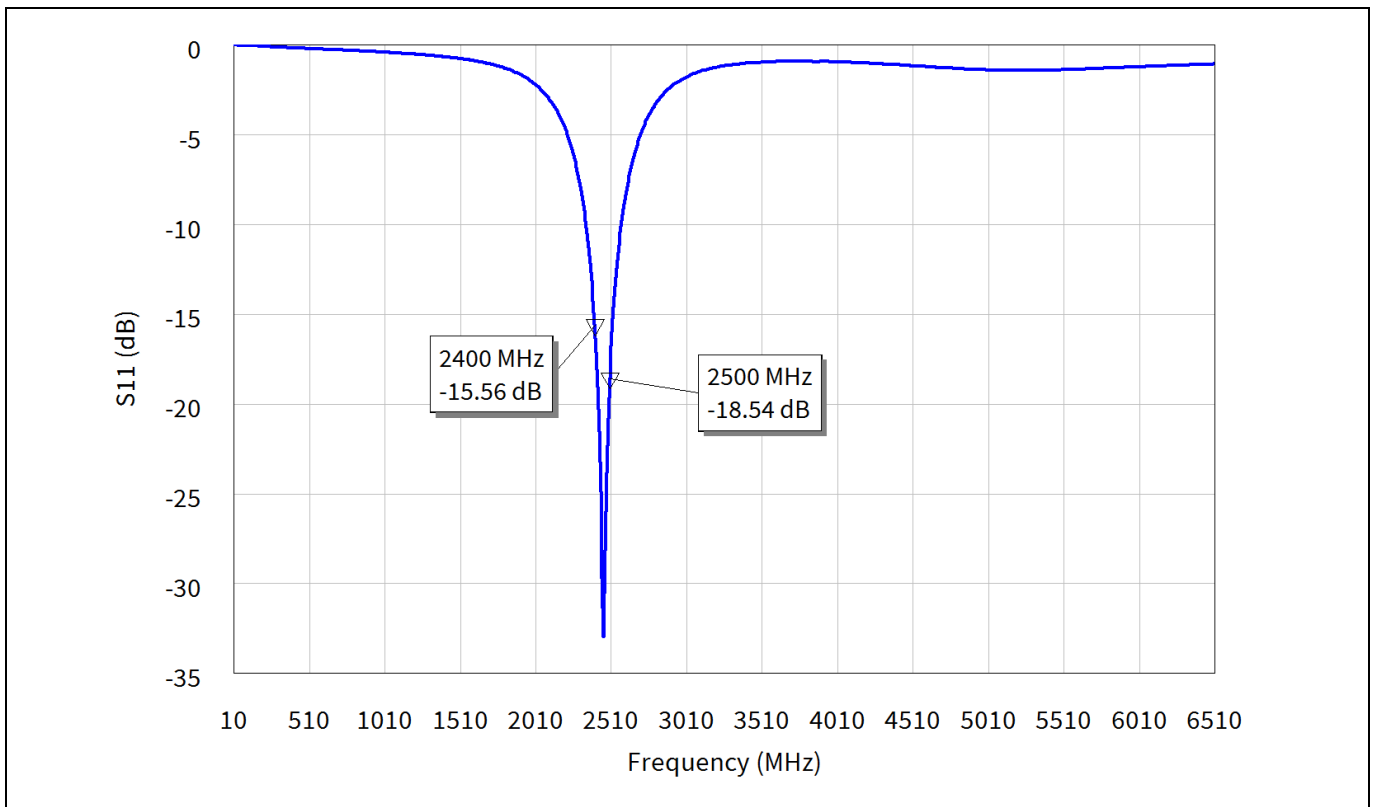


Figure 76 Input return loss measurement of the [BFQ790](#) 2.4 GHz WLAN power amplifier

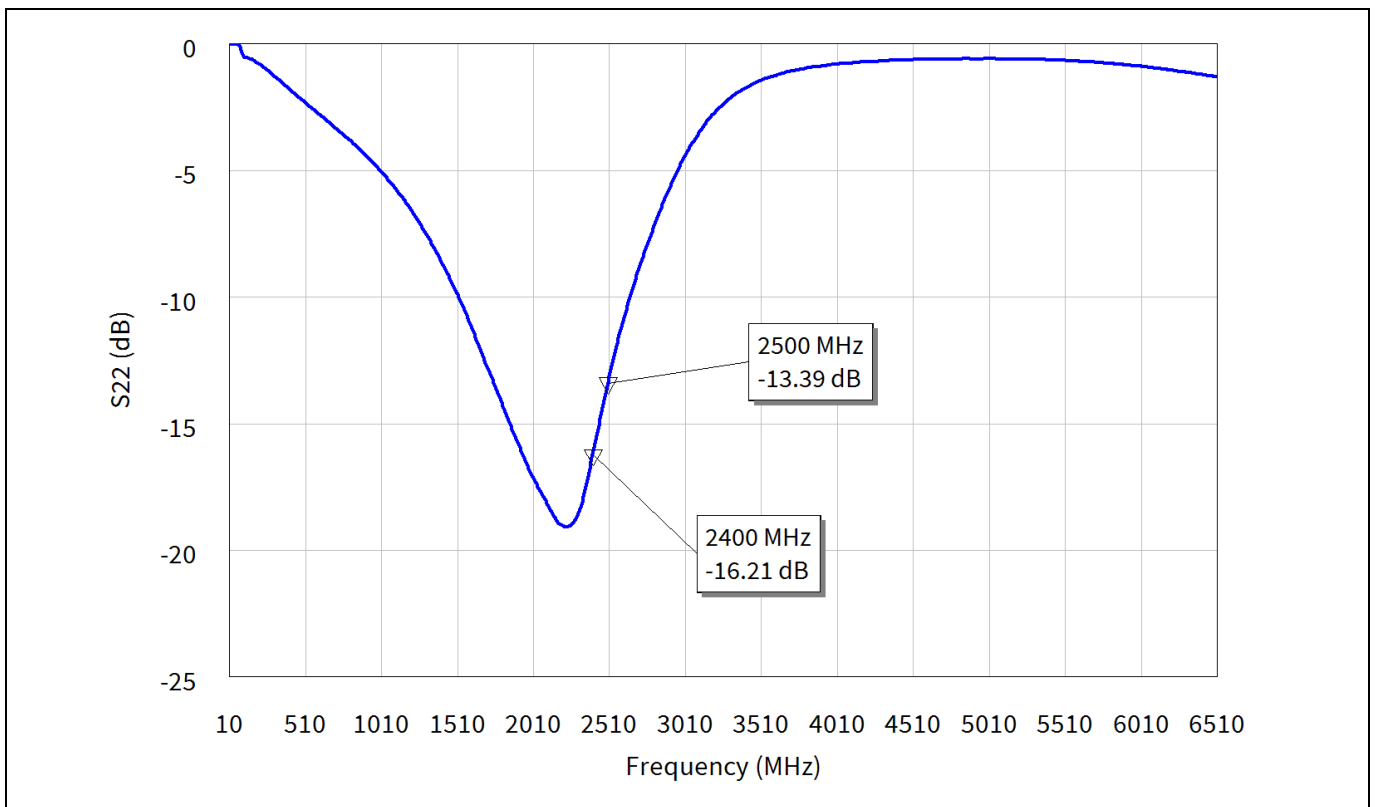


Figure 77 Output return loss measurement of the [BFQ790](#) 2.4 GHz WLAN power amplifier

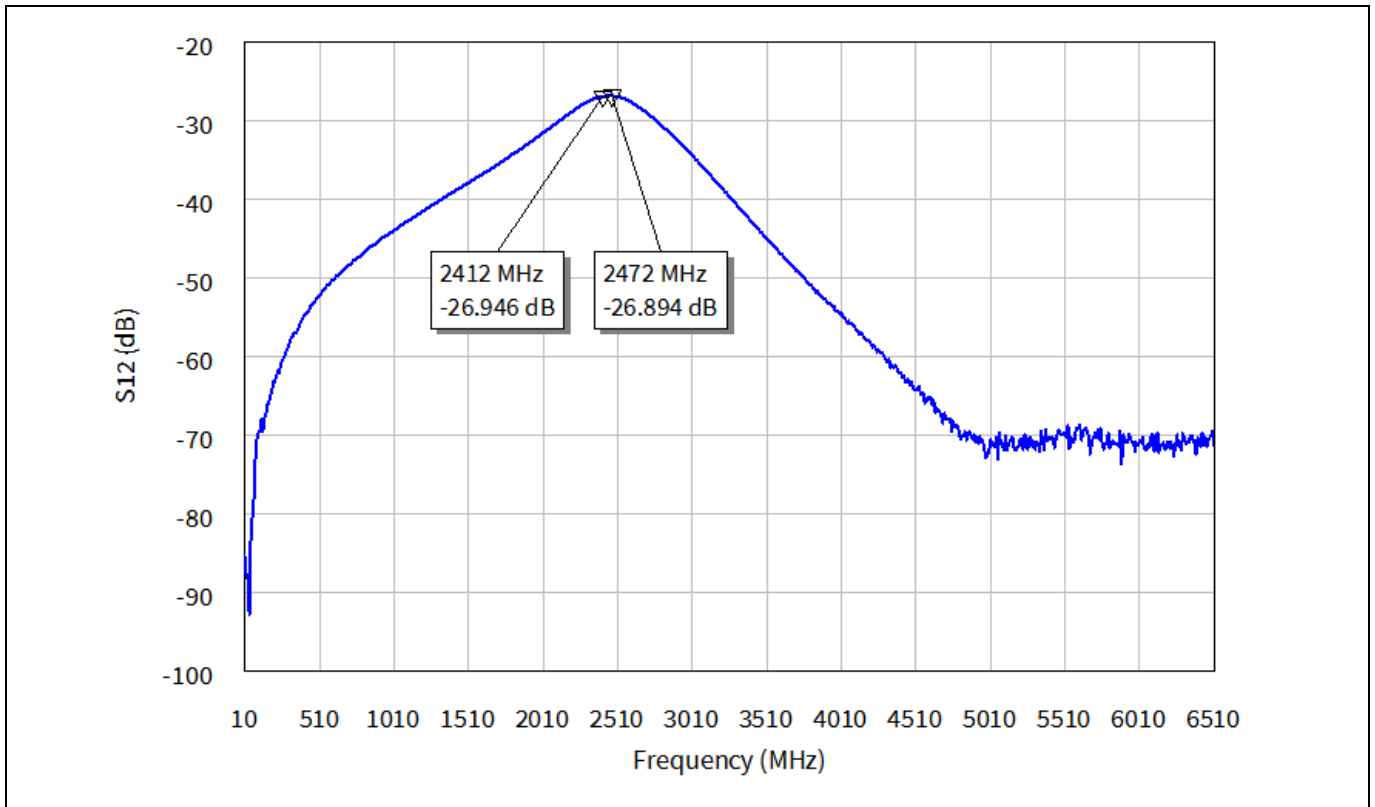


Figure 78 Reverse isolation measurement of the [BFQ790](#) 2.4 GHz WLAN power amplifier

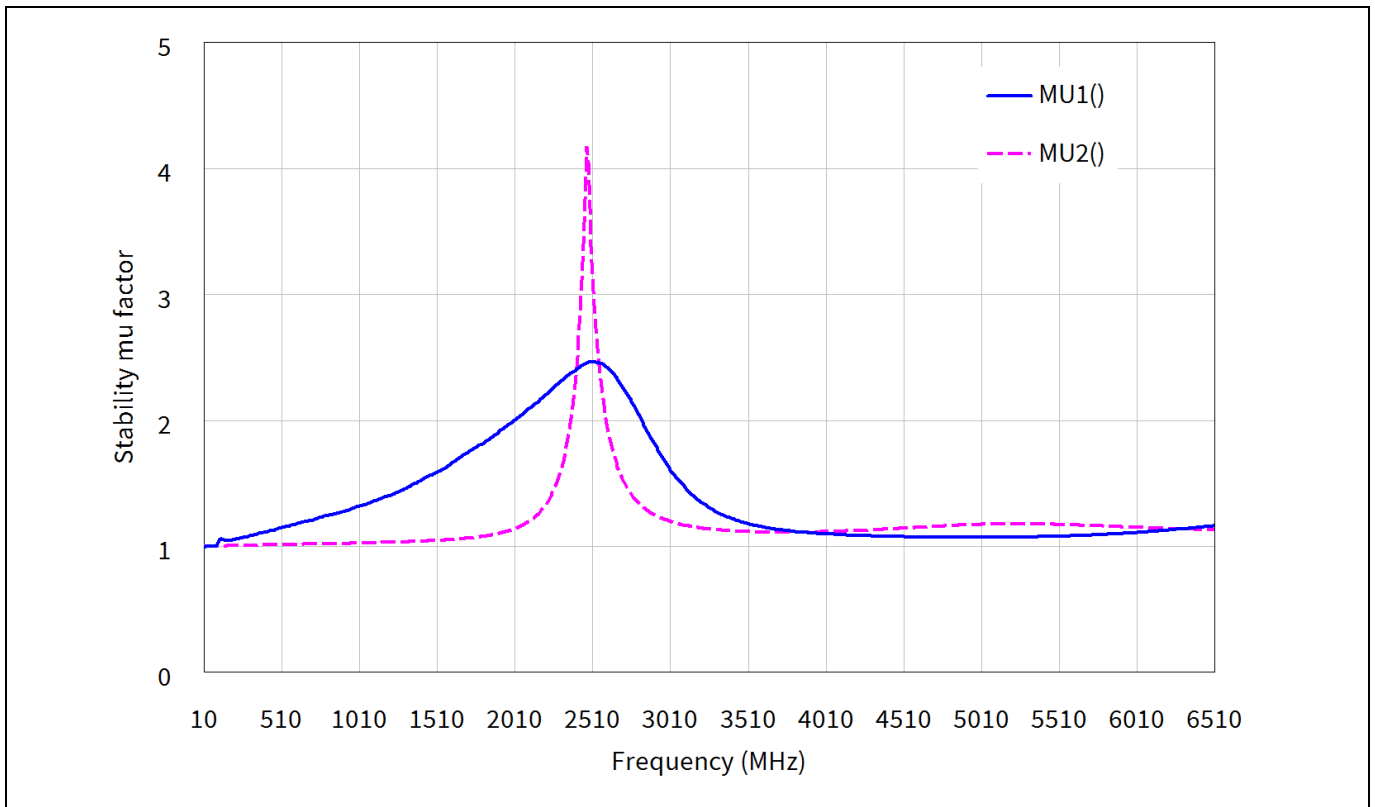


Figure 79 Stability μ -factor plots of the [BFQ790](#) 2.4 GHz WLAN power amplifier

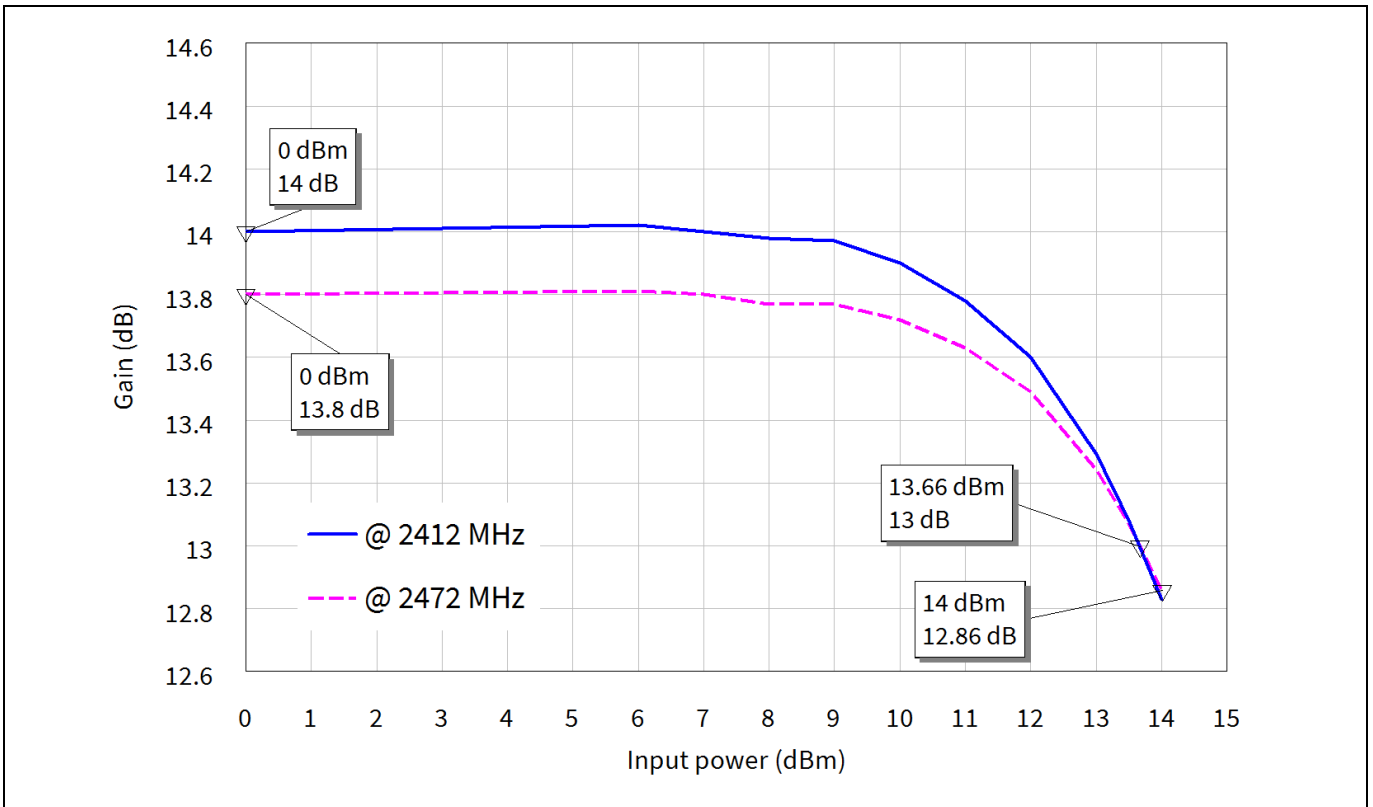


Figure 80 Input 1 dB compression point measurement of the [BFQ790](#) 2.4 GHz WLAN power amplifier

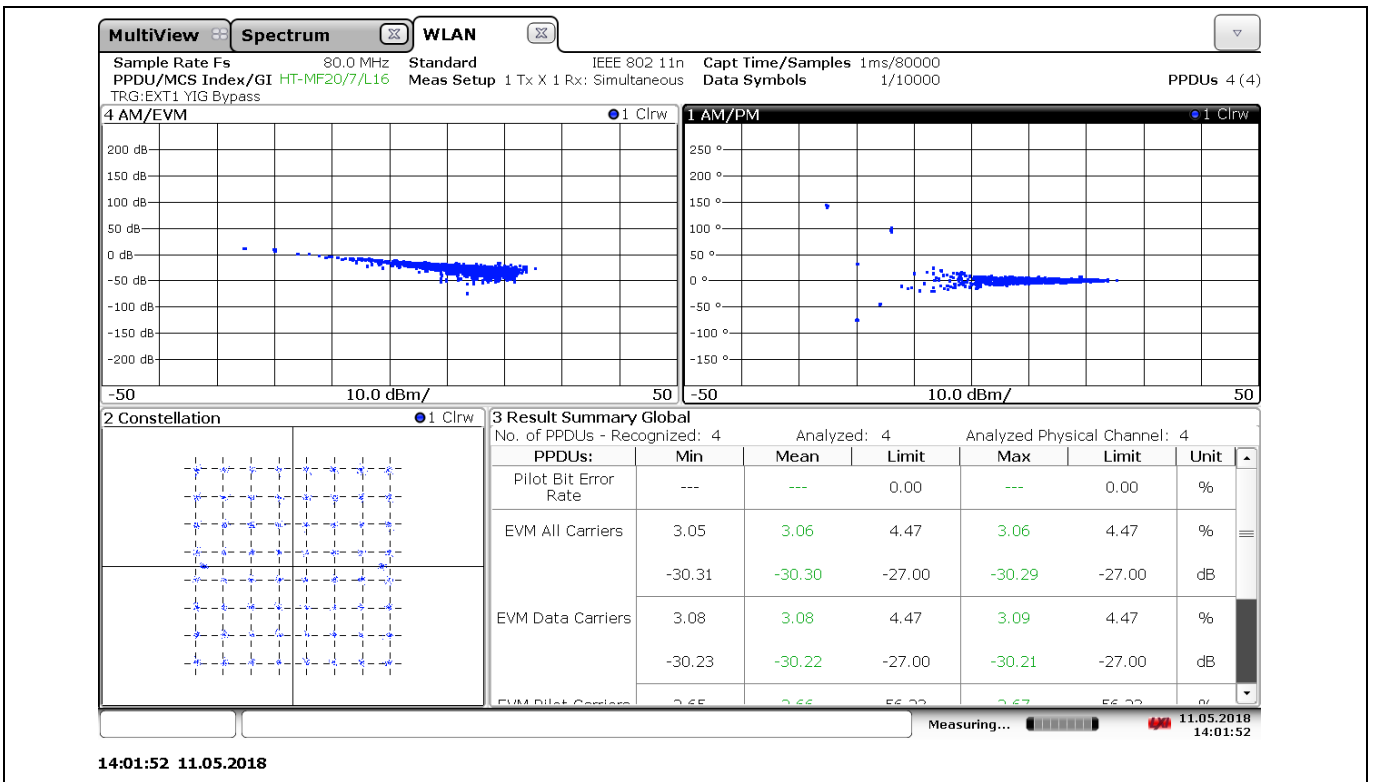


Figure 81 Measured [BFQ790](#) 2.4 GHz WLAN power amplifier output signal EVM of -30 dB at 17.8 dBm average output power level with 802.11n MCS7 64QAM signal at center frequency 2.412 GHz

2.4 GHz band WLAN BFQ790 power amplifier application circuit

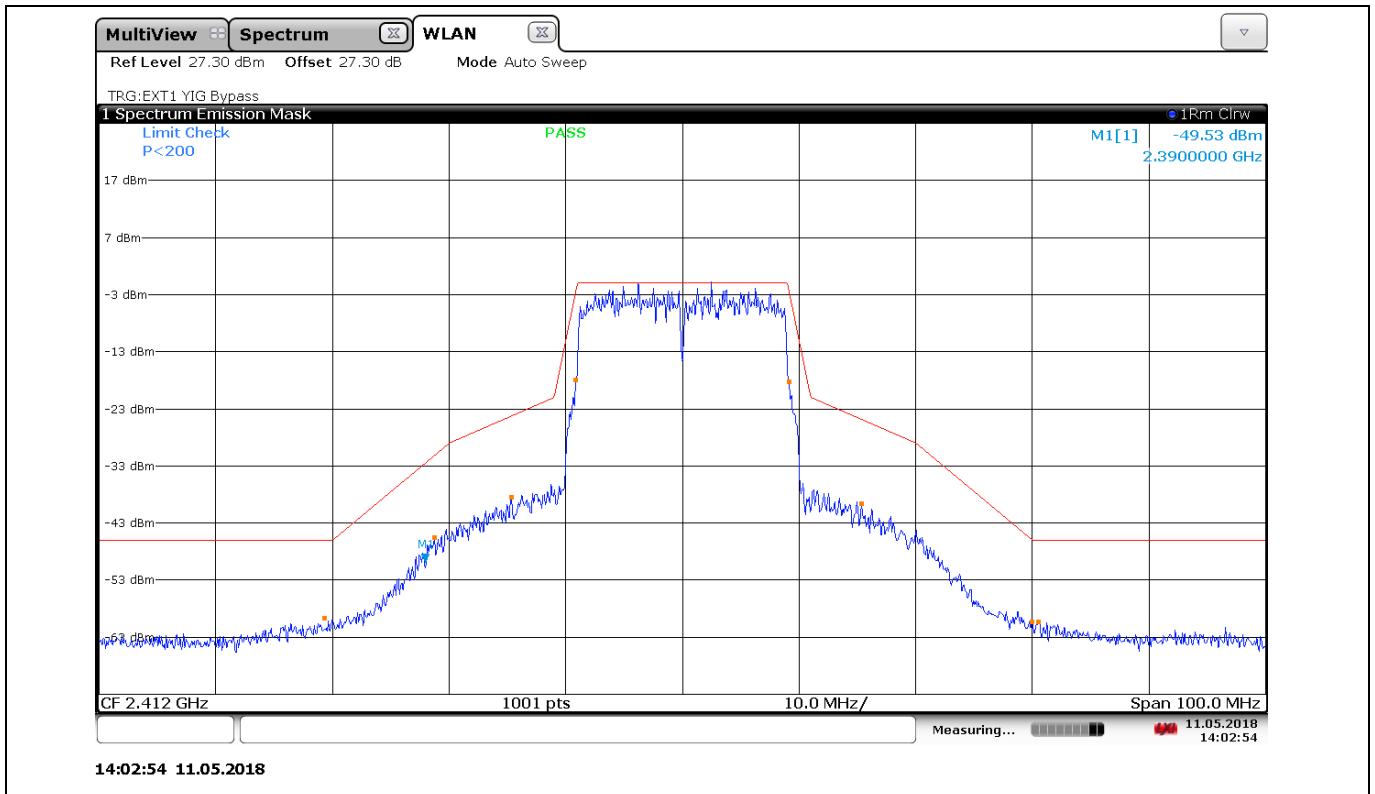


Figure 82 Output signal spectrum mask measurement of the **BFQ790** 2.4 GHz WLAN power amplifier with 802.11n MCS7 64QAM signal at center frequency 2.412 GHz

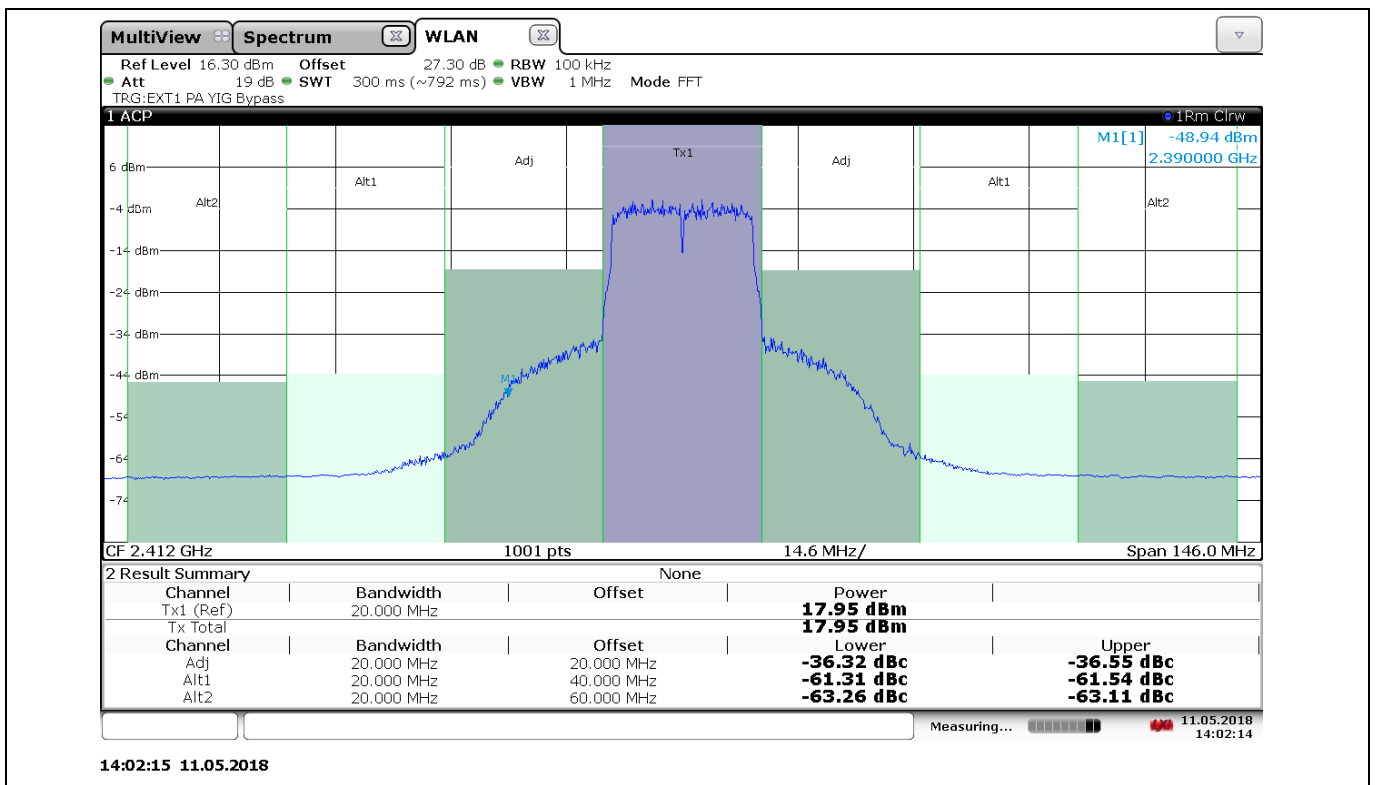


Figure 83 Output signal adjacent channel power measurement of the **BFQ790** 2.4 GHz WLAN power amplifier with 802.11n MCS7 64QAM signal at center frequency 2.412 GHz

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Revision history

Revision history

| Document version | Date of release | Description of changes |
|------------------|-----------------|------------------------|
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